

## Transport in Semiconductors

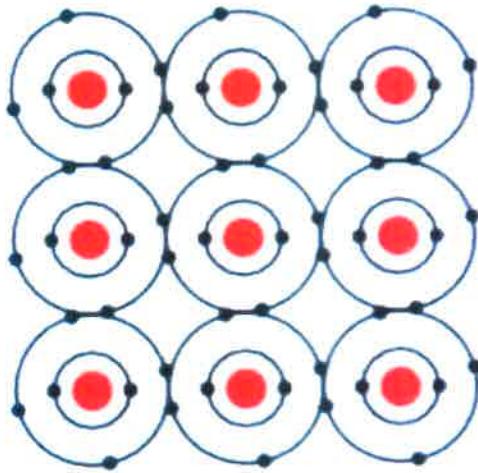
(1)

Individual atoms of semiconductors have half-full valence shells. Typical example of a semiconductor is  $^{14}\text{Si}$ . It has two electrons in the first shell, 8 electrons in the second shell and 4 electrons in the 3rd - valence shell.

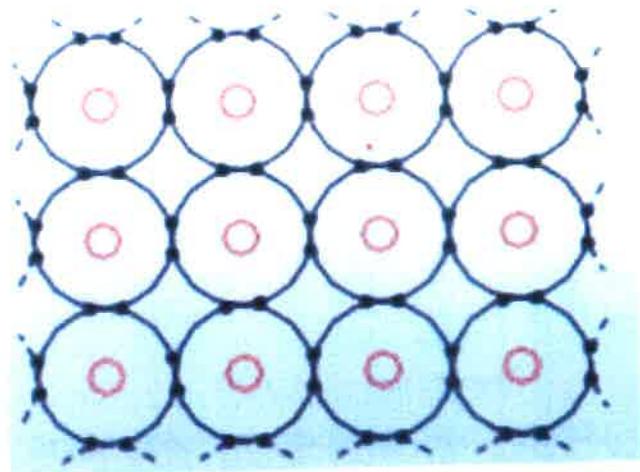
Simplified picture - just the nucleus and valence shell shown



When atoms come together, they share the valence electrons. Therefore, the valence shell is full



2D projection



Simplified 2D projection

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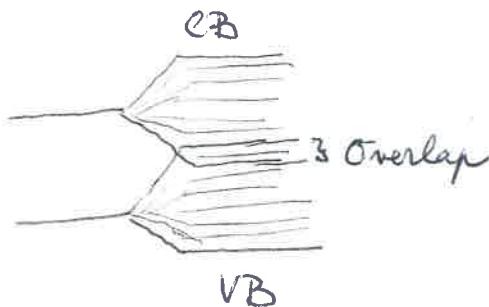
In energy scheme in individual atoms electrons are localized on discrete energy levels. When atoms come together these levels split. If we have  $N$  atoms in the solid, from each energy level in individual atom a band consisting of  $N$  levels is formed. From the energy state related to the valence shell the valence band (VB) is created. The nearest energy band is called the conduction band.

In semiconductors and insulators these two energy bands are separated by an energy interval, where in an ideal periodic structure no electrons can be localized. This band is called the bandgap. The difference between semiconductors and insulators is in the value of the bandgap. Semiconductors are often defined as materials with energy bandgap ( $E_g < 5\text{ eV}$ ). Insulators have  $E_g > 5\text{ eV}$ . This value is connected with the energy necessary to free electron from the valence shell (transition from VB to CB). It is much smaller in semiconductors than in insulators.

The number of electrons that are free at 300K in insulators is small, the electric conductivity is very low.

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In metals the valence band and conduction band overlap. There is no bandgap



Examples - Al, Ag, Cu

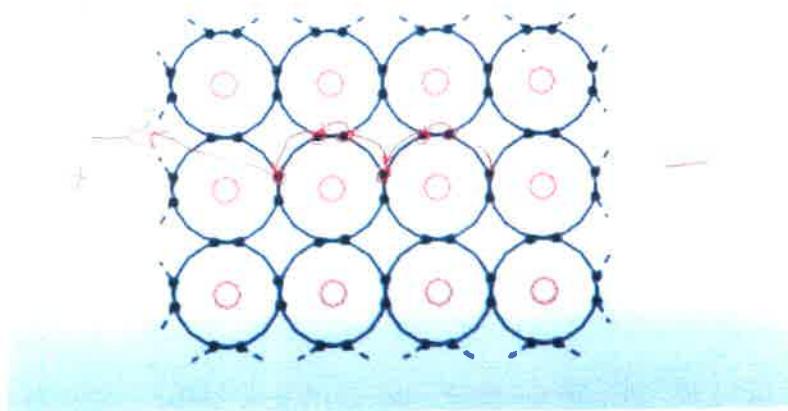
Electrons from the top of the valence band can move freely in the conduction band

Therefore these materials are good conductors.

### Intrinsic semiconductors

At  $T=0K$  all electrons are in the valence shells (energetically in the valence band). After some increase of temperature there is enough energy (thermal) to free electron from the VB.

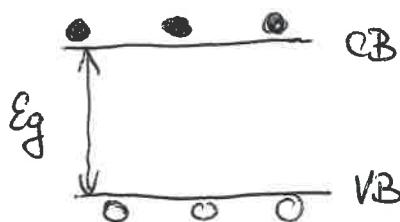
### Conduction in Intrinsic Semiconductor



An empty state is formed on the original position of the electron. If external bias is applied, the free electron drifts to the anode.

(4)

Neighbour electron in the valence shell can transfer to the empty space (hole), creates a new hole, to which another electron can transfer. This way electrons in the valence shells also drift to the anode. This flow can be seen as a flow the holes in the valence band to the anode (hole = missing electron and is therefore positively charged).



In intrinsic semiconductors the electric current is caused by drift of equal numbers of electrons and holes

$$n = p$$

### Doped semiconductors

By doping of semiconductors we understand introduction of impurities (other atoms than the atoms of the matrix). The goal of doping is a change of the concentration of free electrons or holes when compared to an intrinsic semiconductor.

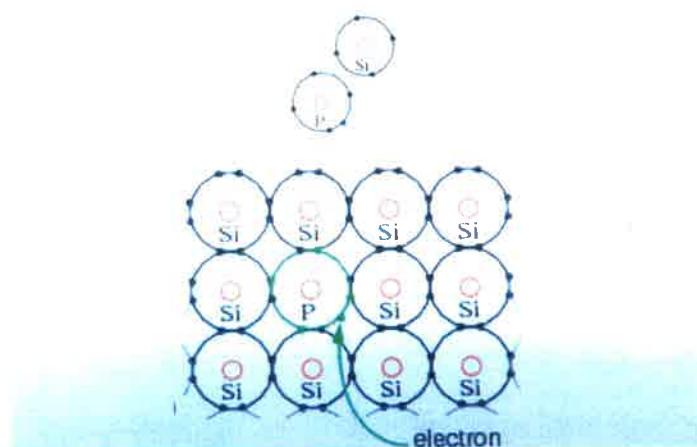
If we want to increase the concentration of free electrons we introduce an impurity with a higher number of valence electrons

When compared to the matrix. This impurity is (5) called a donor. Example - P in Si.

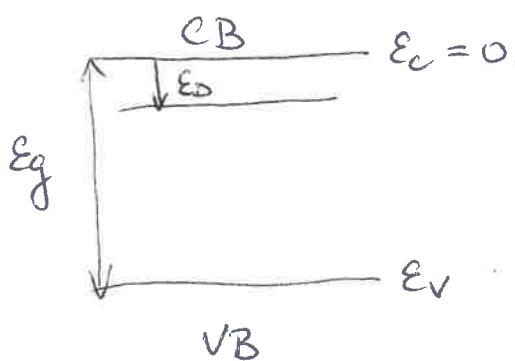
P has 5 valence electrons, Si has 4



P



P has a valence electron that is not shared with neighbor atoms. It is weakly bound to nucleus and can be released with a much lower energy than the standard valence electron.



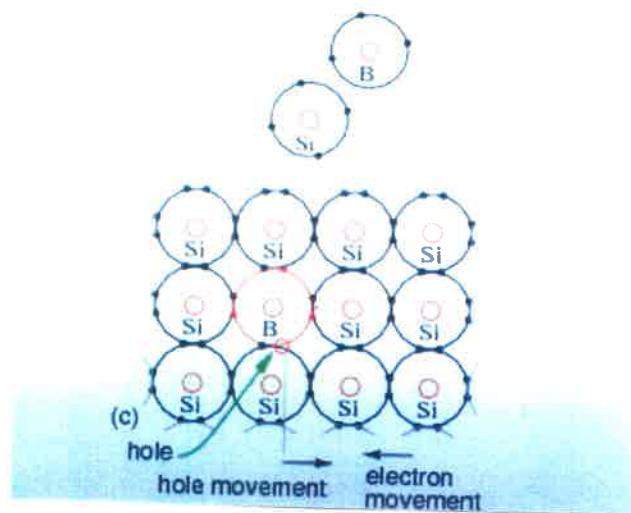
Such an impurity is called "donor".  
The semiconductor is called N-type

Electrons are so called "majority" carriers,  
holes are minority carriers.

The electric current is primarily caused by electrons in N-type materials.

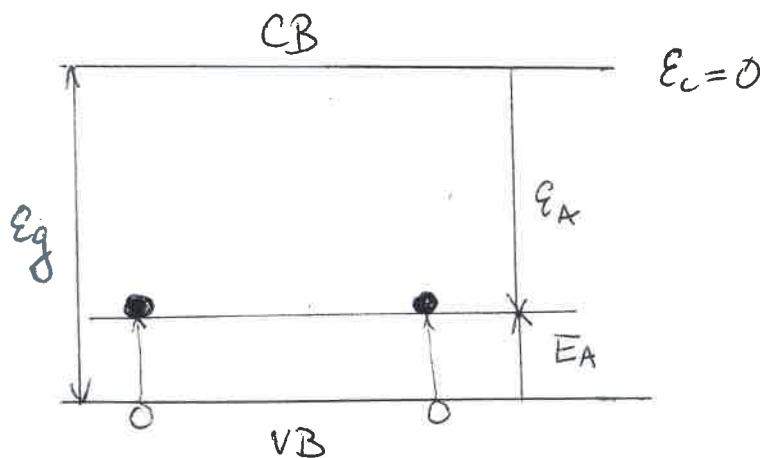
If we want to increase the concentration of free holes, we introduce impurity with a smaller number of valence electrons than have the atoms of the matrix. (6)

Example B in Si



Holes formed due to acceptor doping drift after application of bias to the anode.

- an electron on acceptor is often symbolized as  $\square$  .. fixed negative charge on acceptor

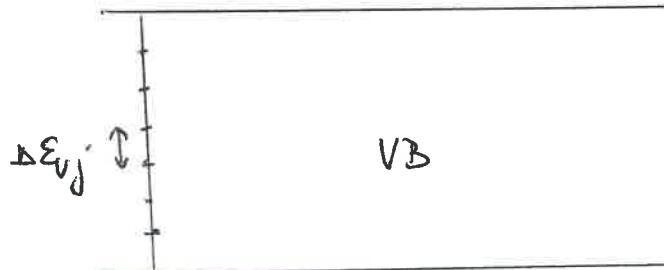
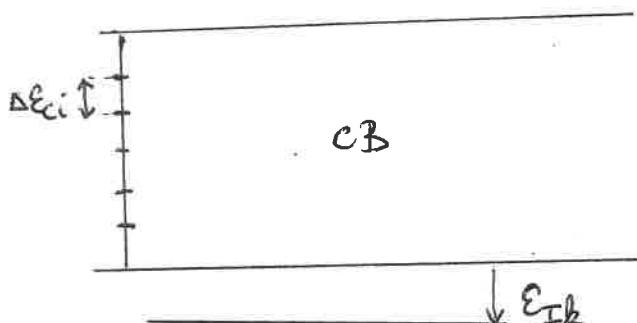


(7)

## Statistics of electrons and holes

Electrons behave like indistinguishable charged particles. Their distribution is described by Fermi distribution function.

To determine the distribution of electrons in the crystals we will be looking for a number of permutations to divide a certain number of electrons to the allowed energy states. These states can be in the bands (described by quantum numbers  $\ell_x, \ell_y, \ell_z$ ) or in the bandgap (caused by impurities or native defects like vacancies, interstitials, antisites etc.) characterized by their own quantum numbers.



Let at given thermodynamic conditions be  
 $N_e$  electrons in the crystal (8)

$$N_e = N_{ee} + N_{ve} + N_{ie}$$

Here  $N_{ee}$  is the number (or concentration) of electrons in the conduction band,  $N_{ve}$  is the concentration of electrons in the valence band and  $N_{ie}$  is the concentration of electrons on impurities.

For the purpose of the derivation we divide the conduction band (CB) to energy intervals  $\Delta E_c$  and the valence band (VB) to  $\Delta E_v$ . Each interval contains a large number of energy states, but  $\Delta E_{cv} \ll \Delta E_H$ , where  $\Delta E_H$  characterizes the precision of measurements. Let the  $i$ -th interval in the CB contain  $N_{ei}$  electrons and  $N_{ci}$  states.

The number of permutations how to divide  $N_{ei}$  electrons into  $N_{ci}$  states is

$$W_{ei} = \binom{N_{ci}}{N_{ee}} = \frac{N_{ci}!}{N_{ei}!(N_{ci}-N_{ei})!}$$

The number of permutations how to divide all electrons in the CB is

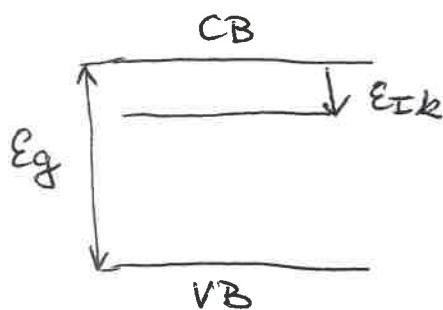
$$W_c = \prod_i W_{ei}$$

The same applies for the valence band (9)

$$W_{Vj} = \frac{N_{Vj}!}{N_{Vj}! (N_{Vj} - M_{Vj})!} \quad W_V = \prod_j W_{Vj}$$

When introducing impurities to statistics we will assume a simple case, when each impurity has just one energy state in the bandgap. It means that if we have a concrete atom with  $M_a + 1$  electrons, it is necessary to provide energy  $E_{Ik}$  ( $k$  is an index of impurity type) to excite one electron ( $E_{Ik} < E_g$ )

Example - a donor (like P in Si)



P has 5 electrons in the valence shell in the ground state (i.e.  $M_a + 1 = 5$ )  
After excitation of one electron by energy  $E_{Ik}$  the donor (here P) is ionized, there are 4 electrons in the valence shell.  
If the atom is in the state with  $M_a$  electrons, energy higher than  $E_g$  is necessary to ionize it further. Therefore, the next energy state of the impurity is in the conduction band.

(10)

The number of permutations, how to divide  $N_{IK}$  electrons into  $N_{IK}$  states (each atom has one energy state in the energy gap) of the  $l$ -th impurity is

$$\binom{N_{IK}}{M_{IK}} = \frac{N_{IK}!}{M_{IK}! (N_{IK}-M_{IK})!}$$

$N_{IK}$  - the total number of atoms of the impurity

$M_{IK}$  - the number of atoms with  $M_l+1$  electrons

$N_{IK}-M_{IK}$  - the number of atoms with  $M_l$  electrons

In case of impurities we have to take into account that electrons can be on each atom in several energetically equal states. For example, if we have three electrons in an orbital that contains 6 states ( $p$ -orbital) we have additional

$$g = \binom{6}{3} = \frac{6!}{3! 3!} = 20$$

The number  $g$  is called degeneracy factor

Let  $g_1$  be the degeneracy of the state with  $M_l+1$  electrons and  $g_0$  of the state with  $M_l$  electrons.

Then the total number of permutations on all atoms with  $M_{i+1}$  electrons is (11)

$$\underbrace{(g_1 \cdot g_1 \cdots g_1)}_{M_{ik}} = g_1^{M_{ik}}$$

The total number of additional permutations on all atoms with  $M_i$  electrons is

$$\underbrace{(g_0 \cdot g_0 \cdots g_0)}_{N_{ik} - M_{ik}} = g_0^{N_{ik} - M_{ik}}$$

The total number of permutations of electrons on  $k$ -th impurity is

$$W_{ik} = \frac{(g_1)^{M_{ik}} \cdot g_0^{(N_{ik} - M_{ik})} \cdot N_{ik}!}{M_{ik}! (N_{ik} - M_{ik})!}$$

If we have more impurity types in the crystal, then

$$W_I = \prod_k W_{ik}$$

(12)

The number of permutations how to divide electrons in the crystal is then

$$W = W_c \cdot W_v \cdot W_I$$

Now we apply an axiom of probability theory saying that if each permutation which results in the same total energy, has an equal probability, then the most probable distribution is that one, that maximizes  $W$ .

Therefore, we look for the maximum of  $W$  in the calculation. We will take advantage of the Stirling formula  $\ln N! = N \ln N - N$ .

We will use the fact that both  $W$  and  $\ln W$  are monotonic functions (if  $W$  has an maximum,  $\ln W$  has it too).

During the search for a maximum we have to take into account that the total number of electrons in the system  $N_e$  and the total energy of all electrons  $E_t$  must be kept.

$$F_1(m) = \sum_i m_{ci} + \sum_j m_{vj} + \sum_k m_{Ik} = N_e$$

$$F_2(m, E) = \sum_i m_{ci} E_{ci} + \sum_j m_{vj} E_{vj} + \sum_k m_{Ik} E_{Ik} = E_t$$

We will be looking for maximum of  $\ln W$  in respect to conduction band electrons, valence band electrons and electrons on impurities respecting the two above written formulas.

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Note: The method of bound extrema  
(Lagrange multipliers)

The method of Lagrange multipliers is a strategy for finding the local maxima and minima of a function subject to equality constraints (i.e. subject to the condition that one or more equations have to be satisfied exactly by the chosen values of the variables).

Let  $f, g_1, g_2, \dots, g_p$  have continuous partial derivations (1st order) on a set

$$M = \{x_1, x_2, \dots, x_{n+p}\} \quad g_i(x) = 0 \quad i=1 \dots p$$

If the function  $f$  has in  $x_0 \in M$  a local extremum respective to  $M$ , then exist numbers  $\lambda_1^0, \dots, \lambda_p^0$  for which holds

$$\frac{\partial f(x_0)}{\partial x_k} - \sum_{j=1}^p \lambda_j^0 \cdot \frac{\partial g_i}{\partial x_k}(x_0) = 0$$

(14)

Therefore we will use the method of Lagrange multipliers (bound extrema) which results in

$$\frac{\partial}{\partial M_{\alpha}} \left\{ \ln W + \alpha \underbrace{(N_e - F_1(M))}_{b_1} + \beta \underbrace{(C_f - F_2(M, E))}_{b_2} \right\}$$

where  $M_{\alpha} = M_{ei}$  or  $M_{vj}$  or  $M_{IB}$

so we perform three derivations to look for 3 local maxima (in the CB, VB and on impurities).  $\alpha$  and  $\beta$  are the Lagrange multipliers.

Performing the derivations after application of the Stirling formula we obtain

$$M_{ei} = \frac{N_{ei}}{1 + e^{(\alpha + \beta E_{ei})}}$$

$$M_{vj} = \frac{N_{vj}}{1 + e^{(\alpha + \beta E_{vj})}}$$

$$M_{IB} = \frac{N_{IB}}{1 + \frac{g_0}{g_1} e^{(\alpha + \beta E_{IB})}}$$

Based on thermodynamics and statistics it can be determined that

$$\alpha = -\frac{EF}{k_B T} \quad \beta = \frac{1}{k_B T}$$

Derivation of concentration of electrons  $n_i$  in the  $i$ -th interval of the conduction band

$$\frac{\partial}{\partial n_i} \left\{ \ln W - \alpha E_i(n) - \beta g_e(n, \epsilon) \right\} = 0$$

$$\ln W = \ln (W_c W_V W_{Ie}) ; \quad W_c = \prod_i W_{ci} ; \quad W_V = \prod_j W_{Vj} ; \quad W_{Ie} = \prod_k W_{Ik}$$

$$\ln W = \sum_i \ln W_{ci} + \sum_j \ln W_{Vj} + \sum_k \ln W_{Ik}$$

$$\begin{aligned} \ln W &= \sum_i \ln \frac{N_{ci}!}{m_{ci}!(N_{ci}-m_{ci})!} + \sum_j \ln \frac{N_{Vj}!}{m_{Vj}!(N_{Vj}-m_{Vj})!} + \\ &+ \sum_k \ln \frac{g_1^{N_{Ik}} \cdot g_0^{N_{Ik}-N_{Ik}} \cdot N_{Ik}!}{m_{Ik}! (N_{Ik}-m_{Ik})!} = \end{aligned}$$

$$= \sum_i \ln N_{ci}! - \sum_i \ln m_{ci}! - \sum_i \ln (N_{ci} - m_{ci})! + \sum_j \ln N_{Vj}! + \sum_k \ln N_{Ik}!$$

We apply Stirling formula

$$\ln A! \approx A \ln A - A$$

$$\frac{\partial \ln W}{\partial m_{ci}} = \frac{\partial}{\partial m_{ci}} \left( \sum_i N_{ci} \ln N_{ci} - \sum_i N_{ci} - \sum_i m_{ci} \ln m_{ci} + \sum_i m_{ci} - \right)$$

$$- \sum_i (N_{ci} - m_{ci}) \ln (N_{ci} - m_{ci}) + \sum_i (m_{ci} - N_{ci}) \right) =$$

$$-1 - \ln m_{ci} + 1 - \frac{N_{ci}}{N_{ci} - m_{ci}} + \frac{m_{ci}}{N_{ci} - m_{ci}} + \ln (N_{ci} - m_{ci}) - 1 =$$

$$= -\ln m_{ci} + \ln (N_{ci} - m_{ci})$$

$$\frac{\partial}{\partial M_{ci}} \left\{ \ln W - \alpha G_1(n) - \beta G_2(n, \epsilon) \right\} = 0$$

$$= -\ln M_{ci} + \ln (N_c - M_{ci}) - \alpha - \beta \epsilon_{ci} = 0$$

(Because  $G_1(n) = \sum_i M_{ci} + \sum_j M_{ij} + \sum_k M_{Ik} - M_c$

$$\frac{\partial G_1}{\partial M_{ci}} = 1 \quad ; \text{ etc.}$$

$$\ln \frac{M_{ci}}{N_{ci} - M_{ci}} = -\alpha - \beta \epsilon_{ci}$$

$$\frac{M_{ci}}{N_{ci} - M_{ci}} = e^{-(\alpha + \beta \epsilon_{ci})}$$

$$M_{ci} = N_{ci} e^{-(\alpha + \beta \epsilon_{ci})} - M_{ci} e^{-(\alpha + \beta \epsilon_{ci})}$$

$$M_{ci} (1 + e^{-(\alpha + \beta \epsilon_{ci})}) = N_{ci} e^{-(\alpha + \beta \epsilon_{ci})}$$

$$M_{ci} = \frac{N_{ci}}{1 + e^{-(\alpha + \beta \epsilon_{ci})}}$$

Based on comparison of thermodynamics and statistical physics it can be shown that

$$\alpha = -\frac{\epsilon_F}{\Delta T} \quad \beta = \frac{1}{\Delta T}$$

$$\Rightarrow M_{ci} = \frac{N_{ci}}{1 + e^{\frac{\epsilon_{ci} - \epsilon_F}{\Delta T}}}$$

# Statistics of a monovalent donor

(15)

## I. Neutral (not ionized) donor

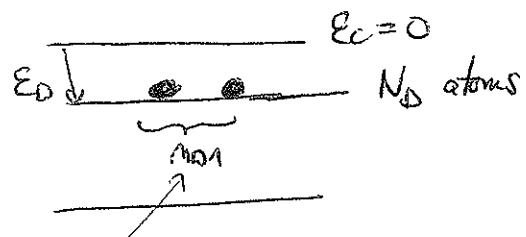
$$M_{D1} = \frac{N_D}{1 + \frac{g_0}{g_1} e^{\frac{E_D - E_F}{k_B T}}}$$

1 electron  
in donor

$$g_0 = \binom{2}{0} = \frac{2!}{0! 2!} = 1$$

$$g_1 = \binom{2}{1} = \frac{2!}{1! 1!} = 2$$

$$M_{D1} = \frac{N_D}{1 + \frac{g_0}{g_1} e^{\frac{E_D - E_F}{k_B T}}}$$



atoms with a  
valence electron

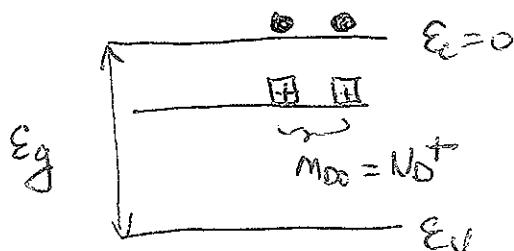
## II Ionized donor

$$M_{D0} = N_D^+ = N_D - M_{D1} =$$

no electron on donor

$$= N_D - \frac{N_D}{1 + \frac{g_0}{g_1} e^{\frac{E_D - E_F}{k_B T}}} = \frac{N_D}{1 + \frac{g_1}{g_0} e^{-\frac{(E_D - E_F)}{k_B T}}}$$

$$N_D^+ = \frac{N_D}{1 + 2 e^{-\frac{(E_D - E_F)}{k_B T}}}$$



## (16)

### Calculation of concentration of electrons in the conduction band

From the previous statistical calculation follows that the concentration of electrons in the  $i$ -th energy interval of the CB is

$$n_{ci} = \frac{N_{ci}}{1 + e^{\frac{E_i - E_F}{k_B T}}} \quad (\text{we set simply})$$

$$E_i = E_i^-$$

The total number of electrons can be calculated as

$$N = \sum_i n_{ci} = \sum_i \frac{N_{ci}}{1 + e^{\frac{E_i - E_F}{k_B T}}}$$

Instead of summing all the energy intervals we can use integration. The number of states in the  $i$ -th interval  $N_{ci}$  is replaced by  $g(\epsilon) \cdot \Delta E_i$  (or  $\rho(\epsilon) d\epsilon$  when  $\Delta E_i \rightarrow d\epsilon$ )

From the theory of semiconductors we know

that

$$g(\epsilon) = \frac{4\pi (2m_e^*)^{3/2} \sqrt{\epsilon}}{h^3}$$

(in 3D space)

The function  $g(\epsilon)$  is called the density of states in the energy space.

(17)

Then

$$m = \int_{E_{\text{MIN}}}^{E_{\text{MAX}}} \frac{g(\epsilon) d\epsilon}{1 + e^{\frac{\epsilon - E_F}{kT}}} = \int_{E_{\text{MIN}}}^{E_{\text{MAX}}} f_0(\epsilon) g(\epsilon) d\epsilon$$

As we decided to set  $E_{\text{MIN}} = 0$  and due to the fact that the Fermi-Dirac distribution function  $\rightarrow 0$  for high  $\epsilon$ , we can set  $E_{\text{MAX}} = \infty$  in the integral to simplify the calculation. Then

$$m = \int_0^{\infty} \frac{g(\epsilon) d\epsilon}{1 + e^{\frac{\epsilon - E_F}{kT}}} ; \quad x = \frac{\epsilon}{kT} ; \quad \epsilon = kTx \\ d\epsilon = kT dx \\ \eta = \frac{E_F}{kT}$$

$$m = \frac{4\pi (2m_e^* k_B T)^{3/2}}{h^3} \int_0^{\infty} \frac{\sqrt{\epsilon} d\epsilon}{1 + e^{\frac{\epsilon - E_F}{kT}}} =$$

$$= \frac{4\pi (2m_e^* k_B T)^{3/2}}{h^3} \int_0^{\infty} \frac{x^{1/2} dx}{1 + e^{x - \eta}} =$$

$$= \frac{4 (2\pi m_e^* k_B T)^{3/2}}{h^3} \int_0^{\infty} \frac{x^{1/2} dx}{1 + e^{x - \eta}}$$

We introduce effective density of states in the CB

$$N_e = \frac{2 (2\pi m_e^* k_B T)^{3/2}}{h^3}$$

(18)

Then we obtain

$$M = \frac{2}{\sqrt{\pi}} N_c \int_0^{\infty} \frac{x^{1/2} dx}{1 + e^{x-\eta}}$$

This result can be rewritten with the help of the Fermi integral

$$F_F(\eta) = \int_0^{\infty} \frac{x^n}{e^{x-\eta} + 1}$$

$$M = \frac{2}{\sqrt{\pi}} N_c F_{1/2}(\eta)$$

For  $\eta < -4$  (i.e. for energies further than 4 eV from the bottom of the CB) simplify

as

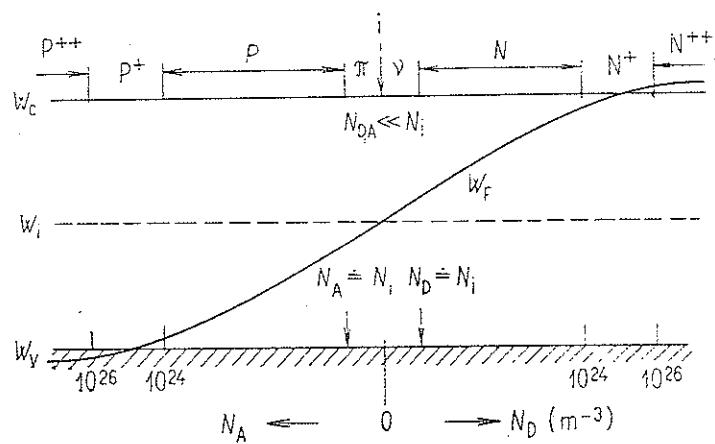
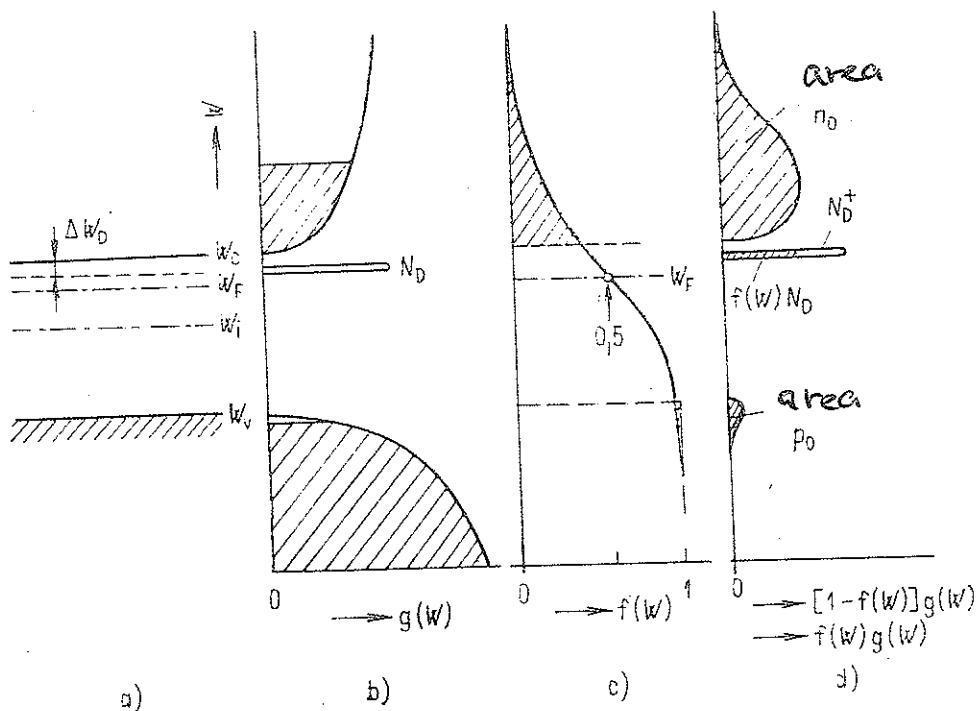
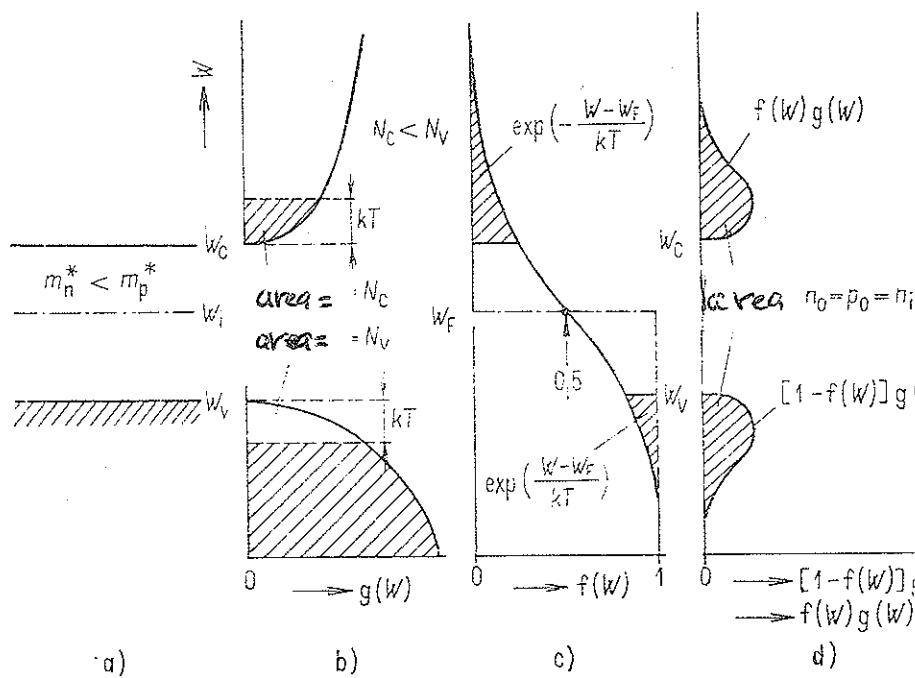
$$F_{1/2}(\eta) \approx \frac{\sqrt{\pi}}{2} e^{\eta}$$

For this so called non-degenerate state we can then write

$$M = \frac{2}{\sqrt{\pi}} \cdot \frac{\sqrt{\pi}}{2} N_c e^{\eta} = N_c e^{\eta}$$

Energies marked as  $W$  (instead of  $E$ )  
in these diagrams

(19)



## Statistics of holes

(20)

The distribution function of holes is

$$f_{0,h} = 1 - f_{0,e} = 1 - \frac{1}{1 + e^{\frac{x-\eta}{kT}}} = \frac{1}{1 + e^{-\frac{(x-\eta)}{kT}}}$$

For a description of statistics for holes we introduce new variables in such a way that equations for holes look like eqs. for electrons.

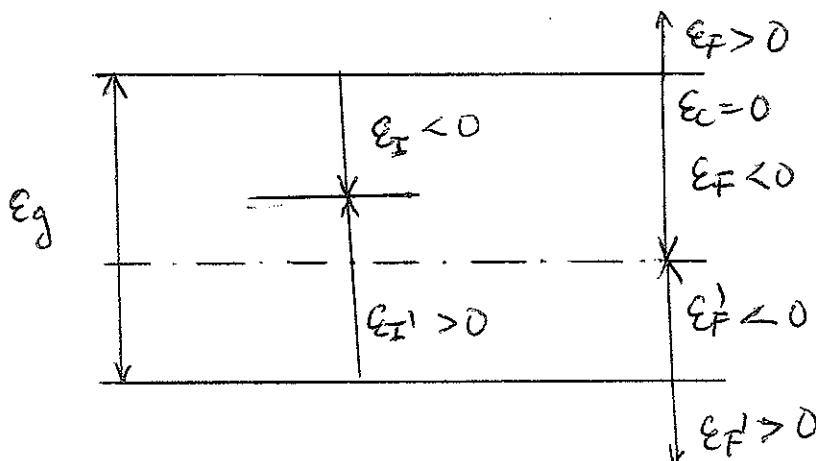
$$\varepsilon' = -\varepsilon - Eg \quad E_F' = -E_F - Eg; \quad x' = -x - Ag$$

$$\eta' = -\eta - Bg$$

$$\left( \eta = \frac{E_F}{kT_B}, \eta' = \frac{E_F'}{kT_B}; \quad Bg = \frac{E_g}{kT_B}, \quad x' = \frac{\varepsilon'}{kT}, \quad x = \frac{\varepsilon}{kT} \right)$$

$$f_{0,h} = \frac{1}{1 + e^{-\frac{(x-\eta)}{kT}}} = \frac{1}{1 + e^{-\frac{-x+\eta'}{kT}}} =$$

$$= \frac{1}{1 + e^{\frac{x'+Bg-\eta'-Bg}{kT}}} = \frac{1}{1 + e^{\frac{x'-\eta'}{kT}}}$$



(21)

By the same approach that we used to calculate  $n$ , we obtain for  $P$

$$P = \int_0^{\infty} f_0(\varepsilon') g(\varepsilon') d\varepsilon' = \frac{2}{\pi} N_v F_0(\gamma')$$

Here  $N_v$  is the effective density of states in the valence band

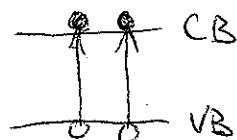
$$N_v = \frac{2(2\pi m_e^* k_B T)^{3/2}}{h^3}$$

$$P = N_v e^{\gamma'} \quad (\text{non-degenerate stat})$$

Determination of the Fermi energy

a) Intrinsic Semiconductor

$$n = P$$



Electrons in CB come from VB

$$N_e e^n = N_v e^{\gamma'}$$

$$\frac{2(2\pi m_e^* k_B T)^{3/2}}{h^3} e^{\gamma'} = \frac{2(2\pi m_h^* k_B T)^{3/2}}{h^3} e^{\gamma'})$$

$$m_e^{3/2} e^{\gamma} = m_h^{3/2} e^{\gamma'} = m_h^{3/2} e^{-\gamma - \beta g} \quad (20)$$

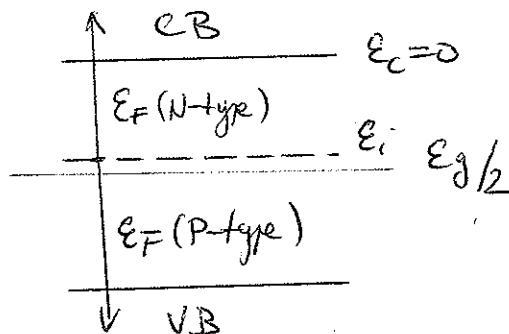
$$e^{2\gamma} = \left(\frac{m_h^*}{m_e^*}\right)^{3/2} e^{-\beta g}$$

$$\gamma = \gamma_i = -\frac{\beta g}{2} + \frac{3}{4} \ln \frac{m_h^*}{m_e^*} = -\frac{\epsilon_g}{2k_B T} + \frac{3}{4} \ln \frac{m_h^*}{m_e^*}$$

The Fermi energy in an intrinsic semiconductor is located slightly above the middle of the bandgap (because  $m_h^* > m_e^*$ )

Definition of N-type and P-type semiconductor  
N-type -  $E_F$  closer to CB than  $\epsilon_i$  ( $E_F$  closer than  $\epsilon_i$ )

P-type  $E_F$  closer to VB than  $\epsilon_i$



Intrinsic concentration

$$M_i = N = P$$

$$N_c e^{M_i} = N_c e^{-\frac{\beta g}{2}} \cdot \left(\frac{m_h^*}{m_e^*}\right)^{3/4}$$

Let us calculate the product

$$N_c N_V = \frac{2(2\pi m_e^* k_B T)^{3/2}}{h^3} \cdot \frac{2(2\pi m_h^* k_B T)^{3/2}}{h^3} \left(\frac{m_e^* m_h^*}{m_e^* + m_h^*}\right)^{3/2}$$

$$(N_e N_V)^{1/2} = \frac{2(2\pi k T)^{3/2}}{\hbar^3} \cdot (m_e^* m_h^*)^{3/4} =$$

$$= \frac{2(2\pi m_e^* k T)^{3/2}}{\hbar^3} \cdot \left(\frac{m_h^*}{m_e^*}\right)^{3/4} = N_e \left(\frac{m_h^*}{m_e^*}\right)^{3/4}$$

$$\Rightarrow N_e e^{-\beta \epsilon_i} = (N_e N_V)^{1/2} e^{-\frac{\beta \epsilon_i}{2}} =$$

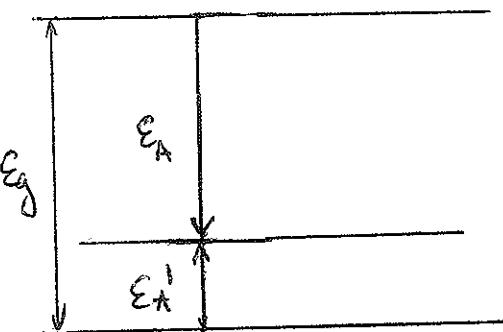
$$= (N_e N_V)^{1/2} e^{-\frac{\epsilon_i}{2kT}} = n = P$$

# 24

## Statistics of a monovalent acceptor

### 1) Ionized acceptor

$$N_{A1} = \frac{N_A}{1 + \frac{g_0}{g_1} e^{\frac{\epsilon_A - \epsilon_F}{k_B T}}}$$



$$\epsilon_A' = -\epsilon_A - \epsilon_g \quad \epsilon_F' = -\epsilon_F - \epsilon_g$$

$$N_{A1} = \frac{N_A}{1 + \frac{g_0}{g_1} e^{\frac{-\epsilon_A + \epsilon_F'}{k_B T}}}$$

$$g_0 = \binom{4}{3} = 4$$

$$g_1 = \binom{4}{4} = 1$$

$$N_{A1} = \frac{N_A}{1 + 4 e^{\frac{-\epsilon_A' + \epsilon_F'}{k_B T}}} = N_A^+$$

### 2) Not ionized acceptor

~~A~~

$$N_{AO} = N_A - N_{A1} = \frac{N_A}{1 + \frac{1}{4} e^{\frac{\epsilon_A' - \epsilon_F'}{k_B T}}}$$

# Electric neutrality equation

(25)

$$\sum (+) = \sum (-)$$

$$P + N_D^+ = M + N_A^-$$

$$N_D^+ = n_{D0}$$

$$N_A^- = n_{A1}$$

$$n_{D0} = \frac{N_D}{1 + 2e^{-\epsilon_d^* + \eta}}$$

$$\epsilon_d^* = \frac{\epsilon_d}{k_B T}$$

$$\eta = \frac{\epsilon_F}{k_B T}$$

$$n_{A1} = \frac{N_A}{1 + 4e^{-\epsilon_A^{*1} + \eta^1}}$$

$$\epsilon_A^{*1} = \frac{\epsilon_A}{k_B T}$$

$$\eta^1 = \frac{\epsilon_F'}{k_B T}$$

$$M = N_c e^\eta \quad (\text{non-degenerate state})$$

$$M = \frac{2}{\pi} N_c \epsilon_{1/2}^*(\eta) \quad \text{General form}$$

$$N_c e^\eta + \frac{N_D}{1 + 2e^{-\epsilon_d^* + \eta}} = N_r e^{\eta^1} + \frac{N_A}{1 + 4e^{-\epsilon_A^{*1} + \eta^1}}$$

The solution of ENE for one type of impurities

Let us focus on the case  $N_D \neq 0, N_A = 0$ .

We will assume that the temperature  $T$  is so low that transitions of electrons from the VB to CB is negligible (i.e.  $p=0$ )

Then the ENE has a simple form

$$M = N_D^+ \quad (N_D^+ \equiv N_{D0})$$

$$N_c e^\gamma = \frac{N_D}{1 + 2 e^{-E_d^* + \gamma}}$$

$$N_c e^\gamma + 2 N_c e^\gamma e^{-E_d^* + \gamma} - N_D = 0 \quad ; \quad e^\gamma = x$$

$$2 N_c e^{-E_d^*} x^2 + N_c x - N_D = 0$$

$$D = N_c^2 + 8 N_c N_D e^{-E_d^*}$$

$$x = \frac{1}{4} \left( \sqrt{1 + 8 \frac{N_D}{N_c} e^{-E_d^*}} - 1 \right) e^{E_d^*}$$

$$E_d^* < 0 \Rightarrow -E_d^* > 0$$

$$\text{when } T \rightarrow 0 \quad 8 \frac{N_D}{N_c} e^{-E_d^*} \gg 1 \Rightarrow$$

$$\sqrt{\frac{N_D}{2 N_c}} e^{-\frac{E_d^*}{2}} e^{\frac{E_d^*}{2}} = e^\gamma$$

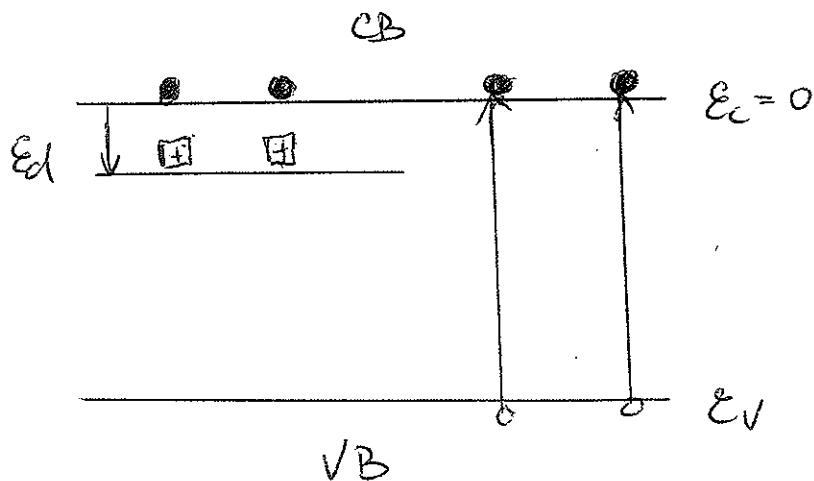
$$\Rightarrow \gamma = \frac{E_d^*}{2} + \frac{1}{2} \ln \frac{N_D}{2 N_c} \quad ; \quad E_F = \frac{E_d}{2} + \frac{1}{2} k_B T \ln \frac{N_D}{2 N_c}$$

(27)

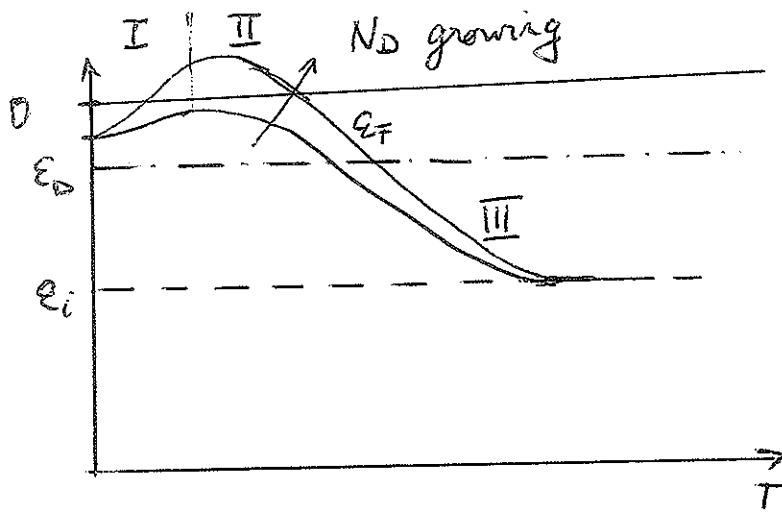
It follows from the result that at  $T=0$  the Fermi energy is in the middle of the energy level of the donor and the bottom of the CB

The course of  $E_F(T)$  is described by equation (7) to the temperature, when transitions of electrons from the VB to the CB start to contribute and the ENF has a more complex form

$$M = N_D^+ + P \quad (++)$$



(28)



With an increasing temperature in region I the  $E_F$  is shifting from its position at  $T=0$  ( $E_D/2$ ) towards the CB. When transitions of electrons from the VB to CB start to be significant, holes are generated, too. This leads to the fact, that the  $E_F(T)$  reaches a maximum and starts to shift down towards the middle of the bandgap. Finally it reaches the intrinsic Fermi energy  $E_i$ . In this situation, the concentration of electrons in the CB coming from donors is negligible when compared to concentration of electrons coming from the CB (i.e.  $N_D \gg N_A$ ). The situation for acceptors is treated analogically.

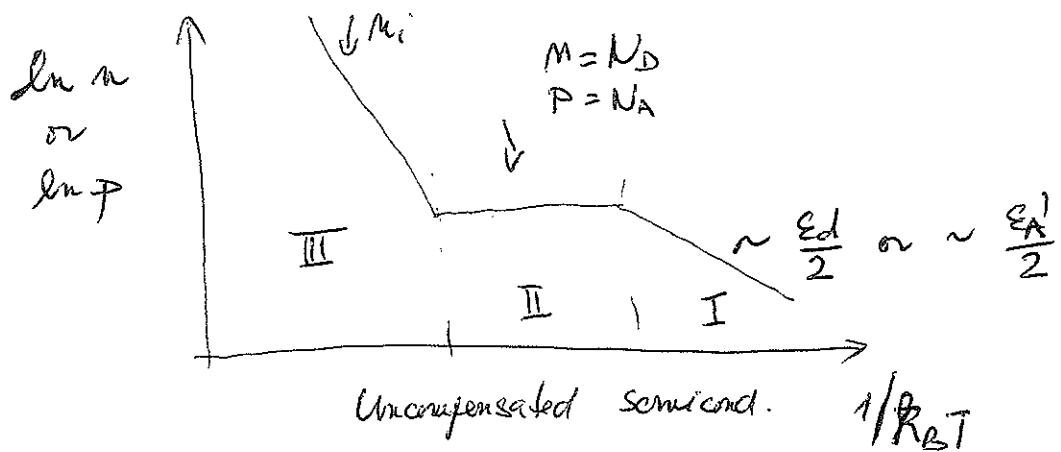
$$E_F' = \frac{E_A'}{2} + \frac{k_B T}{2} \ln \frac{N_A}{2N_V}$$

Where  $E_F', E_A'$  is calculated from the top of VB,  $N_V$  is effective density of states in VB.

The solution of ENE in a general form  
is possible only numerically (29)

The solution yields Fermi energy and concentration  
of free carriers

Uncompensated semiconductor:  
Dependence of  $N(T)$  - or  $P(T)$



Region I -- low temperatures

$$\epsilon_F = \frac{\epsilon_0}{2} + \frac{k_B T}{2} \ln \frac{N_D}{2N_c} \quad (\gamma = \frac{\epsilon_d}{2} + \frac{1}{2} \ln \frac{N_D}{2N_c})$$

$$\text{or} \quad \epsilon_F^1 = \frac{\epsilon_A'}{2} + \frac{k_B T}{2} \ln \frac{N_A}{2N_V} \quad (\gamma^1 = \frac{\epsilon_A'}{2} + \frac{1}{2} \ln \frac{N_A}{2N_V})$$

$$\Rightarrow N = \left( \frac{N_D}{2N_c} \right)^{1/2} e^{\epsilon_d/2k_B T}$$

$$P = \left( \frac{N_A}{2N_V} \right)^{1/2} e^{\epsilon_A'/2k_B T}$$

Region II - plateau : all electrons from donors are free (in the CB), all donors are ionized. The temperature is too low to enable thermal transitions from VB to CB.  
 In this interval of  $T$  the  $n$  remains constant (analogically for P-type Semiconductor)

$$M = N_D - N_A \quad (\text{for } N_D > N_A)$$

$$\text{or} \quad P = N_A - N_D \quad (\text{for } N_A > N_D)$$

Region III - transitions of electrons from the VB to the CB start to dominate

$$M = (N_D^+) + P$$

$\downarrow$   
negligible

$$P \gg N_D^+$$

$$P = (N_A^-) + M$$

$N_A^-$   
negligible  
 $M \gg N_A^-$

The semiconductor approaches an "intrinsic" state ( $M = P$ )

According to our previous calculation

$$M = P = N_C e^{m_i} \sim N_C e^{\frac{E_F i}{k_B T}} = n_i$$

$$m_i = -\frac{E_g}{2k_B T} + \frac{3}{4} \ln \frac{m_h^+}{m_e^+}$$

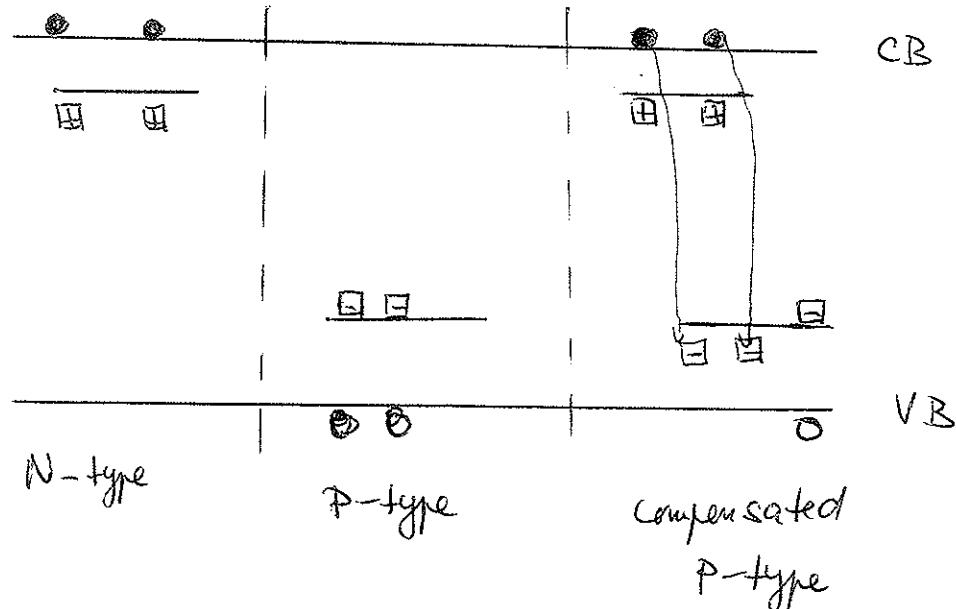
$$\Rightarrow M = P = n_i \sim e^{-\frac{E_g}{2k_B T}}$$

$$\ln n \sim -\frac{E_g}{2k_B T}$$

## Compensated semiconductor

(31)

The semiconductor is compensated when both donors and acceptors are present in the material



Electrons liberated from donors occupy empty states on acceptors, because these states are energetically more favorable.

If  $N_D < N_A$ , some atoms of acceptors remain negatively charged and there is a corresponding concentration of free holes in the VB. The semiconductor is P-type, but the concentration of holes is much smaller when compared to uncompensated P-type.

If  $N_D > N_A$  the situation is opposite.

Electrons from donors occupy all free sites on acceptors. The remaining electrons in CB cause N-type conductivity of the material.

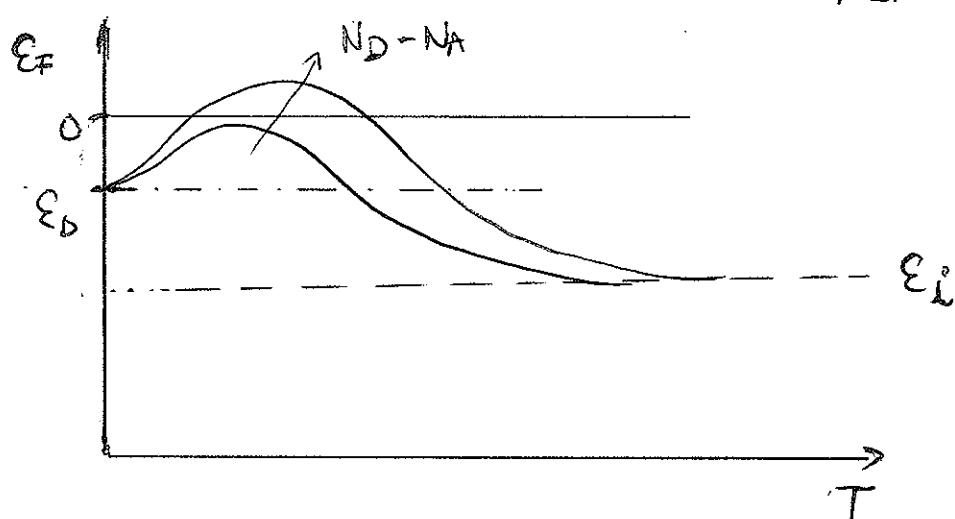
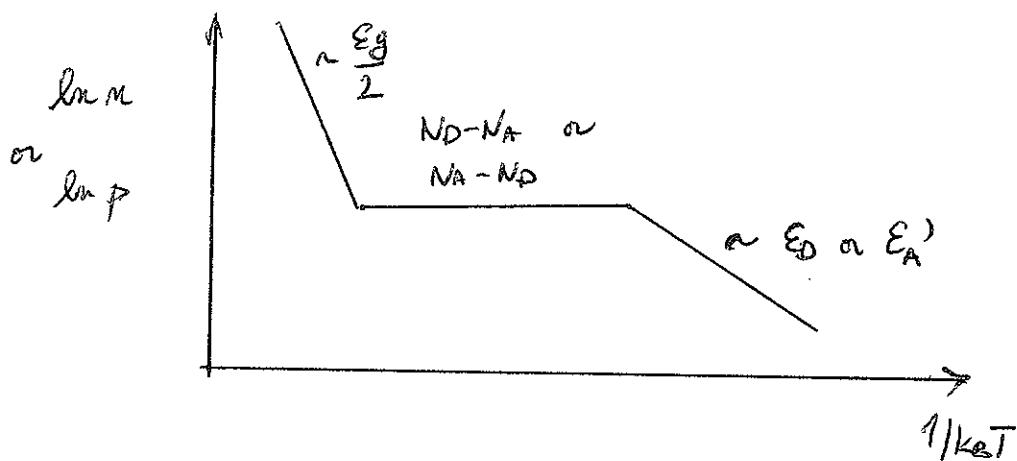
Solution of ENE for compensated semiconductors  
results in

$$\epsilon_F = \epsilon_D + \frac{k_B T}{2} \ln \frac{(N_D - N_A)}{2N_c} \quad (\eta = \epsilon_D^* + \frac{1}{2} \ln \frac{(N_D - N_A)}{2N_c})$$

$$\epsilon_F' = \epsilon_A' + \frac{k_B T}{2} \ln \frac{(N_A - N_D)}{2N_V} \quad (\eta = \epsilon_A'^* + \frac{1}{2} \ln \frac{(N_A - N_D)}{2N_V})$$

$$\Rightarrow n = \left( \frac{N_D - N_A}{2N_c} \right)^{1/2} e^{\epsilon_D/k_B T}$$

$$p = \left( \frac{N_A - N_D}{2N_V} \right)^{1/2} e^{\epsilon_A'/k_B T}$$



Compensated N-type semiconductor

## Boltzmann transport equation (BTE)

So far we have described a semiconductor in equilibrium. We have used the corresponding equilibrium functions  $f_0$  ( $f_{\text{ee}}$ ,  $f_{\text{hh}}$  and  $f_{\text{ek}}$ )

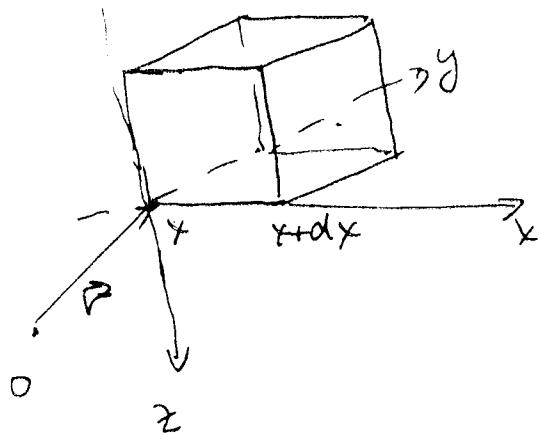
In the next chapters we will deal with non-equilibrium situation, when external fields are applied (bias, temperature gradient, magnetic field ...).

The system of electrons out of equilibrium is described by non-equilibrium distribution function  $f(\vec{r}, \vec{v}, t)$ .

Number of electrons that are at time  $t$  in position  $\vec{r}$  (in  $d^3r$  elementary volume) and with velocity  $\vec{v}$  (in  $d^3v$  elementary volume) is

$$f(\vec{r}, \vec{v}, t) d^3v d^3r$$

Let us now analyse in the  $d^3r d^3v$  volume of the phase space the change of the number of electrons  $\Delta N$ . We choose one direction of movement of electrons; e.g. the "x" direction.



$$\Delta N_x = f(\vec{r}, x, y, z, t) d^3v - f(\vec{r}, x+dx, y, z, t) d^3v$$

Because we study the movement of particle in direction  $+x$  with velocity  $v_x$ ;  $dv = N_x dt$

$$\Delta N_x = f(\vec{r}, x, y, z, t) d^3v v_x dt dy dz - f(\vec{r}, x+dx, y, z, t) N_x dt dy dz$$

We multiply this equation by  $\frac{dx}{dt}$   
and obtain

$$\Delta N_x = \frac{f(\vec{r}, x, y, z, t) d^3v v_x dt dx dy dz - f(\vec{r}, x+dx, y, z, t) N_x dt dx dy dz}{dx}$$

which means that

$$\Delta N_x = - \frac{\partial f(\vec{r}, x, y, z, t)}{\partial x} v_x dt dx dy dz$$

The same approach can be applied in  $y$  and  $z$  directions. In total we have

$$\Delta N_p = - \left( \frac{\partial f(\vec{r}, x, y, z, t)}{\partial x} v_x + \frac{\partial f(\vec{r}, x, y, z, t)}{\partial y} v_y + \frac{\partial f(\vec{r}, x, y, z, t)}{\partial z} v_z \right) d^3v dt dx dy dz$$

We can symbolically write it as

$$\Delta N_{\vec{r}} = -\vec{v} \cdot \nabla_{\vec{r}} f d^3v d^3r dt \quad \text{or}$$

$$\Delta N_{\vec{r}} = -\vec{v} \cdot \nabla_{\vec{r}} f d\vec{v} d^3r dt$$

We described a change of number of electrons in the elementary volume  $d^3v d^3r$  due to the flow in  $\vec{v}$  space.

Electrons can come to or leave the  $d^3v d^3r$  volume also by change of velocity  $\vec{v}$  (acceleration or deceleration). To describe it we can apply the same approach as in  $\vec{r}$  space and obtain

$$\Delta N_{\vec{v}} = -\vec{v} \cdot \nabla_{\vec{v}} f d^3v d^3r dt = -\vec{v} \cdot \nabla_{\vec{v}} f d^3v d^3r dt$$

$$\Delta N_{\text{tot}} = \Delta N_{\vec{r}} + \Delta N_{\vec{v}} = -(\vec{v} \cdot \nabla_{\vec{r}} f + \vec{v} \cdot \nabla_{\vec{v}} f) d^3v d^3r dt$$

The total balance  $\Delta N_{\text{tot}}$  can be described also as a change of a number of electrons in the volume  $d^3v d^3r$  between times  $t$  and  $t+dt$ .

$$\Delta N_{\text{tot}} = [f(\vec{v}, \vec{r}, t+dt) - f(\vec{v}, \vec{r}, t)] d^3v d^3r$$

We multiply by  $\frac{dt}{dt}$  and obtain

$$\Delta N_{\text{tot}} = \frac{f(\vec{v}, \vec{r}, t+dt) - f(\vec{v}, \vec{r}, t)}{dt} d^3v d^3r dt$$

$$\Delta N_{\text{tot}} = \frac{\partial f}{\partial t} d^3v d^3r dt$$

Dividing the terms by  $d\vec{v}d\vec{v}dt$  we obtain

$$\frac{\partial f}{\partial t} = -\vec{v} \nabla_{\vec{v}} f - \vec{a} \nabla_{\vec{v}} f$$

$\underbrace{\quad}_{\text{the so called "field" term of BTE}}$

We have now described acting of the external field (potential gradient, magnetic field). To the equation we have to include also scattering of particles. Thanks to scattering there is not a permanent increase of velocity (like in vacuum). In solid state, thanks to scattering, particles will have a constant velocity  $\vec{v}_0 = \mu \vec{E}$ . It is called drift velocity; the constant  $\mu$  is called "mobility". In order to describe scattering we introduce a quantity

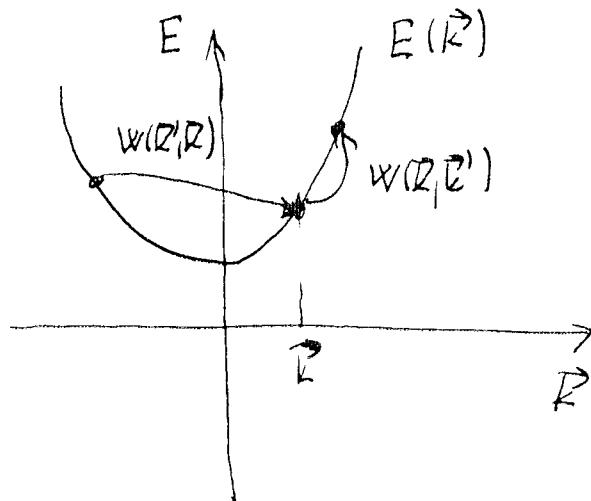
$W(\vec{v}, \vec{v}')$  - probability of scattering of electron with velocity  $\vec{v}$  to the state with velocity  $\vec{v}'$ .

This scattering will the total concentration of particles in phase volume  $d^3v d^3r$  decrease. On the contrary the scattering  $\vec{v}' \rightarrow \vec{v}$  described by the probability  $W(\vec{v}', \vec{v})$  will increase the total number of particles in  $d^3v d^3r$ .

When describing transport in solid state we use the quasi-imulsion  $\vec{p}$ :

$$\vec{p} = \hbar \vec{k} = m^* \vec{v}$$

Therefore we will further work with probabilities  $W(E, \vec{z})$  and  $W(E', \vec{z})$



The intensity of transitions  $\vec{R} \rightarrow \vec{R}'$  and  $\vec{R}' \rightarrow \vec{R}''$  is not given only by the probability of transitions, but also by occupation of the initial and final states.

The total balance can be written as

$$\frac{\partial f}{\partial t} = \underbrace{-\vec{v} \nabla_{\vec{r}} f - \vec{a} \nabla_{\vec{v}} f}_{\text{field term}} + \underbrace{\sum_{\vec{R}'} W(\vec{R}', \vec{R}) f(\vec{R}') (1-f(\vec{E})) - W(\vec{E}, \vec{R}'') f(\vec{R}'') (1-f(\vec{R}'))}_{\text{scattering term}}$$

This is the Boltzmann transport equation (BTE)

Conditions of validity of BTE

- it's a single-particle description  
we use in the description statistical distribution function. This means that there must be a sufficient number of particles in the system
- When describing the distribution we have together the knowledge of position  $\vec{r}$  and velocity  $\vec{v}$ . This corresponds to the classical description

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On the contrary the scattering probability will be described quantum-mechanically. The LSE can be therefore considered as semi-classical equation

The conditions of validity will be further determined by uncertainty relations

at first we use the relation between the coordinate and the momentum

$\Delta x \cdot \Delta p \gg \frac{\hbar}{2}$ . The uncertainty in momentum can be connected to kinetic energy  $\Delta T$

$$E = \frac{p^2}{2m} = \frac{\Delta T}{3} \quad (\text{from equipartition theorem})$$

$$E = \frac{3}{2} k_B T, \text{ but}$$

$$\Rightarrow \Delta x \gg \frac{\hbar}{2\Delta p} = \frac{\hbar}{2\sqrt{2mk_B T}}; \quad \text{we are interested only in order of magnitude estimate}$$

here  $\lambda_B = \frac{\hbar}{\sqrt{2mk_B T}}$  is the de Broglie wavelength

at  $T=300 \text{ K}$   $\lambda_B \approx 10-20 \text{ nm}$  depending on  $m$

This results means that the coordinate (position) of the particle cannot be defined with precision of  $\lambda_B$ . This is equivalent to the requirement that the potential must change slowly relative to  $\lambda_B$ .

Now we will deal with the uncertainty of energy and time

$$\Delta E \cdot \Delta t \gg \frac{\hbar}{2}$$

$E \propto k_B T \Rightarrow \tau \gg \frac{\hbar}{k_B T}$ ; multiplying by  $v$   
we obtain the mean free path

$$\langle l \rangle = \tau \cdot v \gg \frac{\hbar v}{k_B T}$$

The velocity is connected with momentum  $p$

$$v = \frac{p}{m} = \sqrt{\frac{2mk_B T}{m}}$$

$$\langle l \rangle \gg \frac{\sqrt{2mk_B T} \cdot \hbar}{m k_B T} \approx \frac{\hbar}{\sqrt{2mk_B T}} = \lambda_B$$

It means that the mean free path must be much larger than the de Broglie wavelength

We will again use the relation

$$\Delta E \cdot \Delta t \gg \frac{\hbar}{2} \Rightarrow \Delta t \gg \frac{\hbar}{2k_B T}$$

and transform the relation to frequency

$$f \approx \frac{1}{\Delta t} \ll \frac{2k_B T}{\hbar} \approx 10^{12} \text{ Hz}$$

It means that the frequency of changes of conditions in the sample must be smaller than 1 THz

Today the electronics typically works in 6THz range.

This condition is therefore sufficiently fulfilled.

Before we proceed with further analysis of BTE, let us discuss, how to use the result of the solution of BTE, the distribution function  $f$  to calculate useful and experimentally measurable physical quantities - like e.g. electric current.

The electric current  $I = \frac{Q}{t}$  is the el. charge that passes through area  $S$  in time  $t$ .

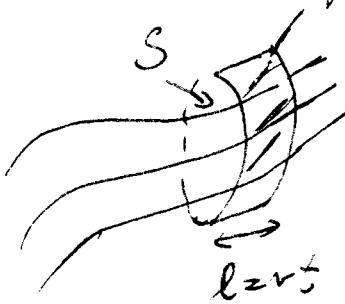
The electric current density  $j = \frac{I}{S} = \frac{Q}{St} = \frac{\rho v}{St}$

$\rho$  ... el. charge density  
 $v$  ... volume of the sample

The electric charge passes in time  $t$  the length  $l$ . that is connected to velocity  $v$   $l = vt$

$$V = S \cdot l = Svt$$

$$V = Sl$$



$$\Rightarrow \vec{j} = \frac{\rho Svt}{St} = \rho \vec{v}$$

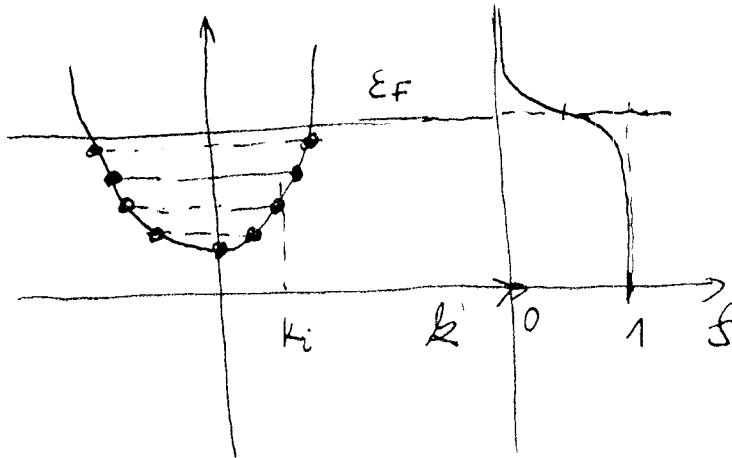
If we work in the reciprocal state; we can write this equation separately for each state  $E$ :

$$j(E) = \rho v(E)$$

The total electric current density is then

$$\vec{j} = \sum_{\vec{E}} j(\vec{E}) = \sum_{\vec{E}} p v(\vec{E})$$

BIEG



Each state can contain 2 electrons (spin)

If the crystal has volume V then

$$p(\vec{E}) = -\frac{2e f(\vec{E})}{V}$$

$f(\vec{E})$  -- distribution function -- how many electrons are in the  $\vec{k}$  state

We have for the el. current density

$$\vec{j} = \sum_{\vec{E}} p v(\vec{E}) = \sum_{\vec{E}} \frac{(-2e) f(\vec{E})}{V} v(\vec{E})$$

Now in the quasi-continuum we proceed from summation to integration by relation

$$\sum_{\vec{E}} \rightarrow g_k \int d\vec{k} \quad g_k \text{ - density of states in the } \vec{k} \text{-space}$$

↓

$$\vec{j} = -\frac{2e}{(2\pi)^3} \int_{R^3} f(\vec{E}) v(\vec{E}) d\vec{k}$$

$$g_k = \frac{V}{(2\pi)^3} \quad (\text{in the 3D space})$$

→ will be derived  
in lecture on solid state physics

We will now discuss the relation between probabilities  $W(\vec{E}, \vec{E}')$  and  $W(\vec{E}', \vec{E})$ .

We will use the principle of detailed balance. It says that in thermodynamic equilibrium the scattering rates  $\vec{E} \rightarrow \vec{E}'$  and  $\vec{E}' \rightarrow \vec{E}$  are equal

$$W(\vec{E}, \vec{E}') f_0(\vec{E}) (1 - f_0(\vec{E}')) = W(\vec{E}', \vec{E}) f_0(\vec{E}') (1 - f_0(\vec{E}))$$

$$W(\vec{E}, \vec{E}') \cdot \frac{1}{1 + e^{\frac{\epsilon - \epsilon_F}{k_B T}}} \cdot \left( 1 - \frac{1}{1 + e^{\frac{\epsilon - \epsilon_F}{k_B T}}} \right) = W(\vec{E}', \vec{E}) \cdot \frac{1}{1 + e^{\frac{\epsilon - \epsilon_F}{k_B T}}} \cdot \left( 1 - \frac{1}{1 + e^{\frac{\epsilon - \epsilon_F}{k_B T}}} \right)$$

$$W(\vec{E}, \vec{E}') \cdot \frac{1}{1 + e^{\frac{\epsilon - \epsilon_F}{k_B T}}} \cdot \frac{e^{\frac{\epsilon - \epsilon_F}{k_B T}}}{1 + e^{\frac{\epsilon - \epsilon_F}{k_B T}}} = W(\vec{E}', \vec{E}) \cdot \frac{1}{1 + e^{\frac{\epsilon - \epsilon_F}{k_B T}}} \cdot \frac{e^{\frac{\epsilon - \epsilon_F}{k_B T}}}{1 + e^{\frac{\epsilon - \epsilon_F}{k_B T}}}$$

$$\Rightarrow W(\vec{E}, \vec{E}') \cdot e^{\frac{\epsilon}{k_B T}} = W(\vec{E}', \vec{E}) e^{\frac{\epsilon}{k_B T}}$$

We will further deal only with elastic scattering,  
when  $\epsilon = \epsilon' \Rightarrow$

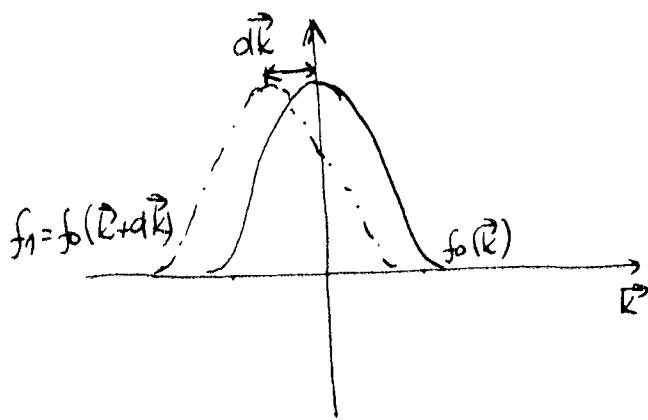
$$W(\vec{E}, \vec{E}') = W(\vec{E}', \vec{E})$$

Introduction of relaxation time  $\tau$

We will consider only small deviations from equilibrium after application of the external fields. The non-equilibrium distribution function  $f$  will be considered in the form

$$f(\vec{k}) = f_0(\vec{k} + \vec{\omega k})$$

This is a shifted Fermi-Dirac distribution



$$F \cdot dt = \hbar d\vec{k} = qE dt$$

electric force

$$qE dt = -eE dt = \hbar d\vec{k}$$

$$\Rightarrow -d\vec{k} = \frac{e E dt}{\hbar}$$

example of  $d\vec{k}$  when the force  
is electric field

For small deviations from equilibrium we can approximate  $f(\vec{k})$  using Taylor expansion

$$f(\vec{k}) = f_0(\vec{k}) + \nabla_{\vec{k}} f_0(\vec{k}) \cdot d\vec{k} = f_0 + f_1$$

In a parabolic band we have  $E = \frac{\hbar^2 k^2}{2m_e^*}$

$$\nabla_{\vec{k}} f_0 = \frac{\partial f_0}{\partial \vec{k}} \cdot \frac{\partial \vec{k}}{\partial E} = \frac{\partial f_0}{\partial E} \frac{\hbar^2 \vec{k}}{m_e^*}$$

We can then re-write the scattering term

$$\left( \frac{\partial f}{\partial t} \right)_S = \sum_{\vec{k}'} \left\{ W(k', k) f(\vec{k}') (1 - f(\vec{k})) - W(\vec{k}, \vec{k}') f(\vec{k}) (1 - f(\vec{k}')) \right\}$$

Taking into account  $W(\vec{k}, \vec{k}') = W(\vec{k}', \vec{k})$  we obtain

$$\left( \frac{\partial f}{\partial t} \right)_S = \sum_{\vec{k}'} W(\vec{k}, \vec{k}') \left( f_1(\vec{k}') - f_1(\vec{k}) \right) = -f_1(\vec{k}) \sum_{\vec{k}'} W(\vec{k}, \vec{k}') \left( 1 - \frac{f_1(\vec{k}')}{f_1(\vec{k})} \right)$$

$$= -\frac{f_1(\vec{k})}{\tau} ; \text{ where we have introduced the relaxation time } \tau \text{ as}$$

$$\frac{1}{\tau} = \sum_{\vec{k}'} W(\vec{k}, \vec{k}') \left( 1 - \frac{f_1(\vec{k}')}{f_1(\vec{k})} \right)$$

Physical meaning of relaxation time

$$\left(\frac{\partial f}{\partial t}\right)_S = - \frac{f_1}{\tau} = - \frac{(f-f_0)}{\tau} ; \quad \frac{d(f-f_0)}{(f-f_0)} = - \frac{dt}{\tau}$$

$$\ln(f-f_0) = -\frac{t}{\tau} + \ln C$$

$$t=0 \quad \ln(f-f_0)|_{t=0} = \ln C$$

$$\ln\left(\frac{(f-f_0)}{(f-f_0)_{t=0}}\right) = -\frac{t}{\tau}$$

$$(f-f_0) = (f-f_0)_{t=0} e^{-\frac{t}{\tau}}$$

$$\text{When } t=\tau \quad (f-f_0)_\tau = \frac{(f-f_0)_{t=0}}{e}$$

$\Rightarrow$  Relaxation time is a time at which deviation from equilibrium drops to  $1/e$  of its initial value.

Let us continue with derivation of the formula for relaxation time  $\tau$

Taking into account that  $f_1(\vec{E}) = \frac{\partial f_0}{\partial \vec{\varepsilon}} \cdot \frac{\hbar^2 k}{m_e^*} d\vec{k}$

we introduce a new function  $\vec{X} = \frac{\hbar^2}{m_e^*} d\vec{k}$

$$\text{Then } f_1(\vec{E}) = \left(\frac{\partial f_0}{\partial \vec{\varepsilon}}\right) \vec{X} \cdot \vec{E}$$

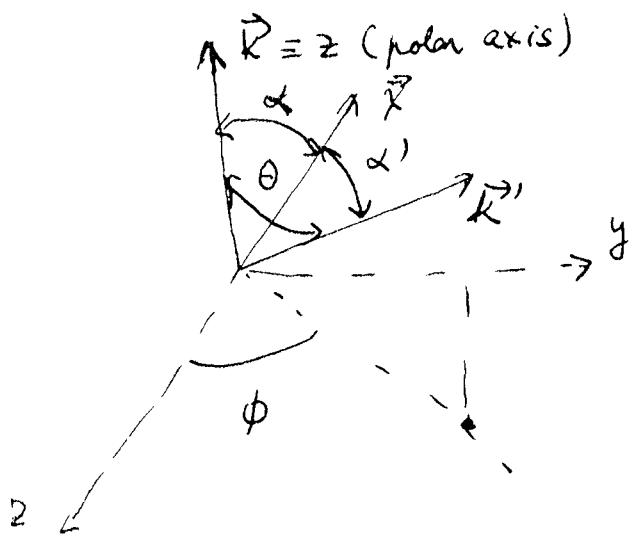
$$f_1(\vec{E}') = \left(\frac{\partial f_0}{\partial \vec{\varepsilon}}\right) \vec{X} \cdot \vec{E}'$$

For our case of elastic scattering  $\vec{\varepsilon} = \vec{\varepsilon}'$

$$\Rightarrow \frac{\partial f_0}{\partial \vec{\varepsilon}} = \frac{\partial f_0}{\partial \vec{\varepsilon}'}$$

$$\frac{1}{\tau} = \sum_{\vec{E}'} W(\vec{E}, \vec{E}') \left( 1 - \frac{\vec{X} \cdot \vec{E}}{\vec{X} \cdot \vec{E}'} \right)$$

To proceed with the calculation we introduce the coordinate system and vectors using spherical coordinates



We define the coordinate system such a way that  $\vec{z}$  is in  $yz$  plane

$$\vec{R} = \begin{pmatrix} 0 \\ 0 \\ k \end{pmatrix} \quad \vec{k} = \begin{pmatrix} 0 \\ x \sin \theta \cos \phi \\ x \sin \theta \sin \phi \end{pmatrix}$$

$$k_x' = k' \sin \theta \cos \phi$$

$$k_y' = k' \sin \theta \sin \phi$$

$$k_z' = k' \cos \theta$$

$$\Rightarrow \vec{x} \cdot \vec{k}' = x k' \sin \theta \sin \phi + x k' \cos \theta \cos \phi$$

$$\vec{x} \cdot \vec{k} = x k \cos \theta$$

$$\frac{1}{c} = \sum_{\vec{k}'} W(\vec{k}, \vec{k}') \left( 1 - \frac{x k \sin \theta \sin \phi}{x k \cos \theta} + \frac{x k \cos \theta \cos \phi}{x k \cos \theta} \right) =$$

$$= \sum_{\vec{k}'} W(\vec{k}, \vec{k}') \left( 1 - \tan \theta \sin \phi + \cos \theta \right)$$

We switch from summation to integration

$$\frac{1}{\bar{v}} = \frac{V}{(2\pi)^3} \int W(\vec{k}, \vec{k}') (\tan \theta \sin \theta \sin \phi + \cos \theta - 1) d\vec{k}' =$$

$$= \frac{V}{(2\pi)^3} \int_0^{\infty} \int_0^{2\pi} \int_0^{\pi} W(\vec{k}, \vec{k}') (\tan \theta \sin \theta \sin \phi + \cos \theta - 1) k'^2 dk' \sin \theta d\theta d\phi$$

Because  $\int_0^{2\pi} \sin \phi = 0$  we obtain

$$\frac{1}{\bar{v}} = \frac{V}{(2\pi)^3} \int_0^{\infty} \int_0^{2\pi} \int_0^{\pi} W(\vec{k}, \vec{k}') (1 - \cos \theta) \underbrace{k'^2 \sin \theta d\theta d\phi}_{d\vec{k}'} dk'$$

Returning to summation we have

$$\frac{1}{\bar{v}} = \sum_{\vec{k}'} W(\vec{k}, \vec{k}') (1 - \cos \theta)$$

Physical meaning of relaxation time

$$\left(\frac{\partial f}{\partial t}\right)_S = -\frac{f_1}{\tau} = -\frac{(f-f_0)}{\tau}; \quad \frac{d(f-f_0)}{(f-f_0)} = -\frac{dt}{\tau}$$

$$\ln(f-f_0) = -\frac{t}{\tau} + \ln C$$

$$t=0 \quad \ln(f-f_0)|_{t=0} = \ln C$$

$$\ln\left(\frac{(f-f_0)}{(f-f_0)_{t=0}}\right) = -\frac{t}{\tau}$$

$$(f-f_0) = (f-f_0)_{t=0} e^{-\frac{t}{\tau}}$$

$$\text{When } t=\tau \quad (f-f_0)_C = \frac{(f-f_0)_{t=0}}{e}$$

$\Rightarrow$  Relaxation time is a time at which deviation from equilibrium drops to  $1/e$  of its initial value

Let us continue with derivation of the formula for relaxation time  $\tau$

Taking into account that  $f_1(E) = \frac{\partial f_0}{\partial \varepsilon} \cdot \frac{\hbar^2 k}{m_e^*} dE$

We introduce a new function  $\vec{X} = \frac{\hbar^2}{m_e^*} dE$

$$\text{Then } f_1(E) = \left(\frac{\partial f_0}{\partial \varepsilon}\right) \vec{X} \cdot \vec{k}$$

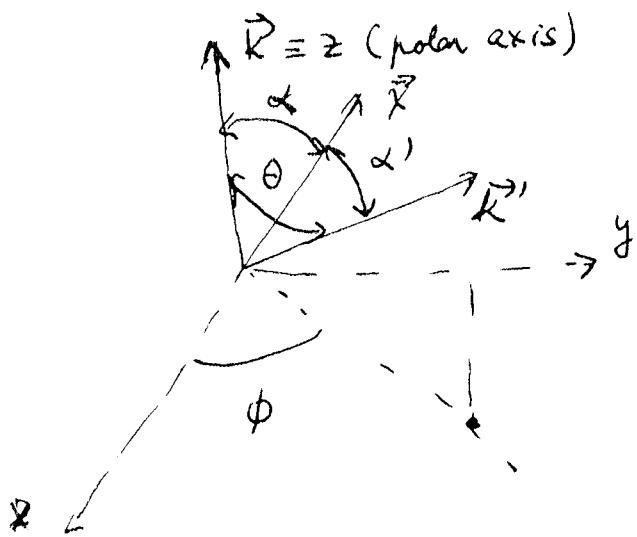
$$f_1(E') = \left(\frac{\partial f_0}{\partial \varepsilon'}\right) \vec{X} \cdot \vec{k}'$$

For our case of elastic scattering  $\varepsilon = \varepsilon'$

$$\Rightarrow \frac{\partial f_0}{\partial \varepsilon} = \frac{\partial f_0}{\partial \varepsilon'}$$

$$\frac{1}{\tau} = \sum_{E'} W(E, E') \left( 1 - \frac{\vec{X} \cdot \vec{k}'}{\vec{X} \cdot \vec{k}} \right)$$

To proceed with the calculation we introduce the coordinate system and vectors using spherical coordinates



We define the coordinate system such a way that  $\vec{x}$  is in  $yz$  plane

$$\vec{k} = \begin{pmatrix} 0 \\ 0 \\ k \end{pmatrix} \quad \vec{x} = \begin{pmatrix} 0 \\ x \sin \theta \cos \phi \\ x \sin \theta \sin \phi \end{pmatrix}$$

$$k_x' = k' \sin \theta \cos \phi$$

$$k_y' = k' \sin \theta \sin \phi$$

$$k_z' = k' \cos \theta$$

$$\Rightarrow \vec{x} \cdot \vec{k}' = x k' \sin \theta \sin \phi + x k' \cos \theta \cos \phi$$

$$\vec{x} \cdot \vec{k} = x k \cos \theta$$

$$\frac{1}{c} = \sum_{\vec{k}'} W(\vec{k}, \vec{k}') \left( 1 - \frac{x k \sin \theta \sin \phi}{x k \cos \theta} - \frac{x k \cos \theta \cos \phi}{x k \cos \theta} \right) =$$

$$= \sum_{\vec{k}'} W(\vec{k}, \vec{k}') (1 - \tan \theta \sin \phi - \cot \theta)$$

We switch from summation to integration

$$\frac{1}{\sigma} = \frac{V}{(2\pi)^3} \int W(\vec{E}, \vec{E}') (-tg 2 \sin \theta \sin \phi - \cos \theta + 1) d\vec{E}' =$$

$$= \frac{V}{(2\pi)^3} \int_0^{\infty} \int_0^{2\pi} \int_0^{\pi} W(\vec{E}, \vec{E}') (-tg 2 \sin \theta \sin \phi - \cos \theta + 1) k'^2 dk' \sin \theta d\theta d\phi$$

Because  $\int_0^{2\pi} \sin \phi = 0$  we obtain

$$\frac{1}{\sigma} = \frac{V}{(2\pi)^3} \int_0^{\infty} \int_0^{2\pi} \int_0^{\pi} W(\vec{E}, \vec{E}') (1 - \cos \theta) \underbrace{k'^2 \sin \theta d\theta d\phi dk'}_{d\vec{E}'}$$

Returning to summation we have

$$\frac{1}{\sigma} = \sum_{\vec{E}'} W(\vec{E}, \vec{E}') (1 - \cos \theta)$$

## Calculation of relaxation time

During scattering of carriers several scattering mechanisms can be simultaneously active. The resulting relaxation time can be calculated using the so called Matthiessen rule.

$$\frac{1}{\tau} = \sum_i \sum_{\vec{R}, \vec{R}'} W_i(\vec{R}, \vec{R}') (1 - \cos \theta_i) = \sum_i \frac{1}{\tau_i}$$

Here  $i$  is an index of the scattering mechanism. The Matthiessen rule can be derived from the probability theory - the scattering mechanisms are alternative, therefore the probabilities  $W_i$  are summed (the probability rule of summing of probabilities.)

When calculating  $\tau_i$  we switch from summation to integration, it means that we have to multiply the integral with the density of states in the  $\vec{k}'$  space

$$g_{30}(\vec{k}') = \frac{V}{(2\pi)^3} = \frac{L^3}{(2\pi)^3}$$

Here  $V$  is the volume of the sample with a shape of cube with side  $L$

$$\frac{1}{\tau_i} = \frac{V}{(2\pi)^3} \int_{\vec{R}'} W_i(\vec{R}, \vec{R}') (1 - \cos \theta_i) d\vec{k}' = \\ \sim g_{30}(\vec{k}')$$

$$= \int d\varphi \int_0^{\pi} \int_0^{\infty} \frac{V}{(2\pi)^3} W_i(\vec{R}, \vec{R}') k'^2 dk' (1 - \cos \theta_i) d\theta_i =$$

$\underbrace{\qquad\qquad\qquad}_{2\pi} \qquad \underbrace{\qquad\qquad\qquad}_{\pi} \qquad \underbrace{\qquad\qquad\qquad}_{2\pi}$

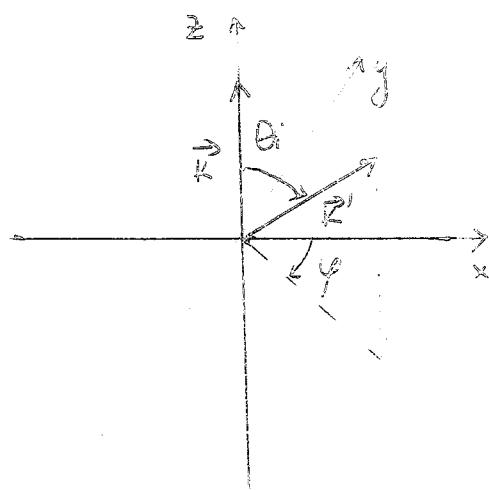
$$W_i(k, \theta_i)$$

$$= 2\pi \int_0^{\pi} W_i(k, \theta_i) (1 - \cos \theta_i) d\theta_i$$

We switched to spherical coordinates  $k', \theta_i, \varphi$

$$dk' = k'^2 \sin \theta_i d\theta_i d\varphi dk'$$

We have chosen the polar axis II to  $\vec{R}'$   
 $\theta_i$  is representing both the scattering angle  
 and polar angle in this case.



We also introduced

$$W_i(k, \theta_i) = \frac{V}{(2\pi)^3} \int_0^{\infty} k'^2 W_i(\vec{R}, \vec{R}') dk'$$

To proceed with the calculation we have  
 to use some formula for  $W_i(\vec{R}, \vec{R}')$

We use the Fermi golden rule

$$W_i(\vec{R}, \vec{R}') = \frac{2\pi}{\hbar} |M_i(\vec{R}, \vec{R}')|^2 \delta(\varepsilon(\vec{R}) - \varepsilon(\vec{R}'))$$

$M_i(\vec{R}, \vec{R}')$  ... Matrix element of transition from state  $\vec{R}$  to  $\vec{R}'$

$\delta(\varepsilon(\vec{R}) - \varepsilon(\vec{R}'))$  Law of energy conservation for elastic scattering

$$M_i(\vec{R}, \vec{R}') = \frac{1}{V} \int \Psi_{\vec{R}'}^*(\vec{r}) H^\dagger \Psi_{\vec{R}}(\vec{r}) d\vec{r}$$

$\Psi$  ... wave function of electron and scattering center

$H^\dagger$  ... interaction Hamiltonian

$$W_i(k, G_i) = \frac{V}{(2\pi)^3} \frac{2\pi}{\hbar} \int_0^\infty |M_i(\vec{R}, \vec{R}')|^2 \delta(\varepsilon(\vec{R}) - \varepsilon(\vec{R}')) k'^2 dk'$$

Let us introduce  $\varepsilon(\vec{R}) = \varepsilon$   $\varepsilon(\vec{R}') = \varepsilon'$

$$\varepsilon' = \frac{\hbar^2 k'^2}{2m_e^*} \rightarrow k' = \frac{\sqrt{2m_e^* \varepsilon'}}{\hbar}$$

$$dk' = \frac{\sqrt{2m_e^*}}{2\sqrt{\varepsilon'} \hbar} d\varepsilon'$$

$$W_i(k, G_i) = \frac{V}{4\pi^2 \hbar} \int_0^\infty |M_i(\vec{R}, \vec{R}')|^2 \delta(\varepsilon - \varepsilon') \frac{2m_e^* \varepsilon'}{\hbar^2} \frac{\sqrt{2m_e^*}}{2\sqrt{\varepsilon'} \hbar} d\varepsilon'$$

$$W_i(k, \theta_i) = \frac{V}{4\pi} \int_{-\infty}^{\infty} |M_i(R, R')|^2 g_{3D}(\varepsilon) \delta(\varepsilon - \varepsilon') d\varepsilon'$$

We have used the formula for density of states in the energy space in 3D

$$g_{3D}(\varepsilon') = \frac{(2m_e^*)^{3/2}}{2\pi^2 \hbar^3} \sqrt{\varepsilon'}$$

$$\Rightarrow W_i(k, \theta_i) = \frac{V}{4\pi} |M_i(R, R')|^2 g(\varepsilon)$$

We assumed that  $M_i(R, R')$  does not depend on energy and used the properties of  $\delta$ -function

Now we proceed with calculation of  $\Sigma_i$

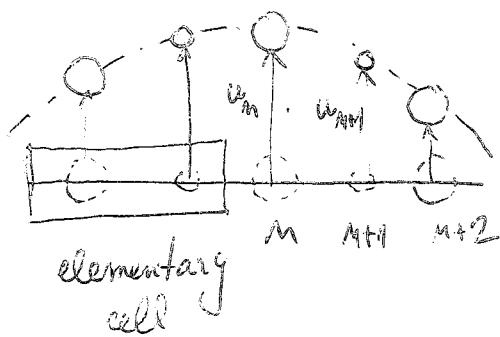
$$\frac{1}{\Sigma_i} = \frac{1}{2\pi g(\varepsilon)} \int_{-\pi}^{\pi} \frac{V}{4\pi} |M_i(R, R')|^2 (1 - \cos \theta_i) \sin \theta_i d\theta_i$$

To evaluate  $\Sigma_i$  one has to know the matrix element for each scattering mechanism

We will now continue to discuss individual scattering mechanisms

Scattering on acoustic phonons (non-polar)

From the theory we know that in case of acoustic vibrations (acoustic phonons) atoms in the elementary cell vibrate in phase.



$\vec{u}_m$  ... displacement of the  $m$ -th atom

$\vec{u}_{m+1}$  ... displacement of the  $(m+1)$ -th atom etc

Example - elementary cell with 2 atoms  
(GaAs, InSb, CdTe)

or even Si  
(elementary semiconductor but 2 Si atoms in the elementary cell are different due to different bond strengths)

In the acoustic vibration the displacements of the neighbor atoms are similar - in the same direction ("are in phase")

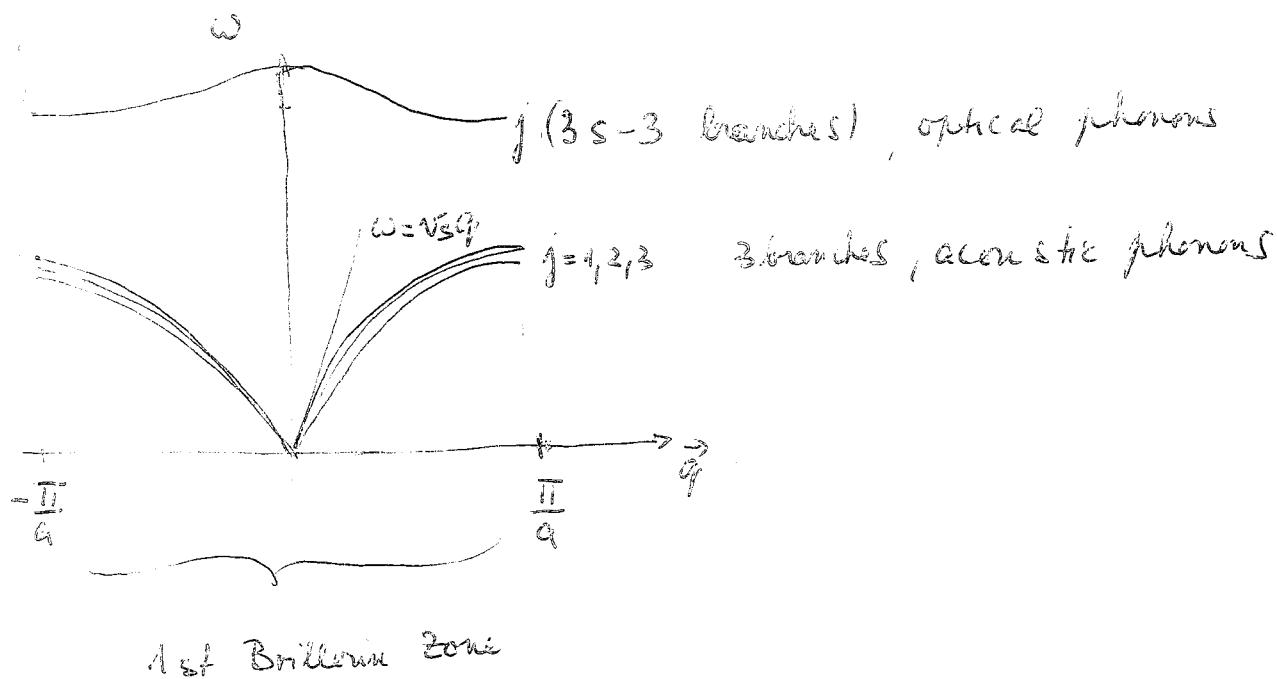
$$\vec{u}_{m,l} = \frac{1}{N} \sum_{\vec{q}} \left\{ \vec{e}_{ej}(\vec{q}) b_j(\vec{q}) e^{i\vec{q}\vec{r}_m} + \vec{e}_{ej}^*(\vec{q}) b_j^*(\vec{q}) e^{-i\vec{q}\vec{r}_m} \right\}$$

$\vec{e}_{ej}$  ... vector of polarization - determines the direction of oscillation of the  $l$ -th atom participating

in a monochromatic lattice wave with wave vector  $\vec{q}$ .  $j$  is the index of the phonon branch with frequency  $\omega_j(\vec{q})$

The scattering of carriers or acoustic phonons takes place because due to propagation of elastic wave the elementary cell is deformed. This results in the change of the lattice constant. In case of long waves ( $q \rightarrow 0$ ) the interaction Hamiltonian can be written as

$$H_{LA}^I = E_A \operatorname{div} \vec{u}_A(\vec{r}) \rightarrow H_{LA}^I \sim i\vec{q} \cdot \vec{e}_{q,j}$$



Because  $H_{LA}^I \sim i\vec{q} \cdot \vec{e}_{q,j}$ ,  $H_{LA}^I = 0$  if  $\vec{q} \perp \vec{e}_{q,j}$

$\vec{q}$  ... direction of wave propagation

$\vec{e}_{q,j}$  ... direction of oscillation of atoms in the wave

It means, that only longitudinal phonons ( $\vec{q} \parallel \vec{e}_{q,j}$ )

participate in the interaction ( $\hbar \omega \neq 0$ )

Now we will show that only long-wavelength phonons participate in the interaction with free carriers

The scattering on phonons is in general non-elastic. We will, however, use the relaxation time approximation for situations, when the change of energy of carrier at scattering is small.

To show, that only long-wavelength phonons participate in interactions, we will calculate the conservation of momentum and energy during the interaction.

$$\vec{R}' = \vec{k} \pm \vec{q}$$

$$\vec{R}'^2 = \vec{k}^2 \pm 2\vec{k}\cdot\vec{q} + \vec{q}^2 = k^2 + 2kq\cos\theta + q^2$$

$$\epsilon(\vec{R}') = \epsilon(\vec{k}) \pm \hbar\omega_q. \quad \omega_q \text{ frequency of acoustic phonon}$$

$$\frac{\hbar^2 k'^2}{2m_q^*} = \frac{\hbar^2 k^2}{2m_q^*} \pm \hbar\omega_q$$

$$\frac{\hbar^2 k'^2}{2m_q^*} \pm \frac{\hbar^2}{2m_q^*} 2kq\cos\theta + \frac{\hbar^2 q^2}{2m_q^*} = \frac{\hbar^2 k^2}{2m_q^*} \pm \hbar\omega_q$$

$$q^2 = \mp 2kq\cos\theta \pm \frac{2m_q^*}{\hbar} \omega_q$$

$$q = 2k(\mp \cos\theta \pm \frac{m_q^*}{\hbar k} \omega_q)$$

$$m_q^* v = \hbar k$$

$$q = 2k \left( \mp \cos \theta \pm \frac{\omega_q}{v_s} \right) \quad \omega_q = v_s \cdot q$$

↑  
velocity of acoustic  
wave

$$q = 2k \left( \mp \cos \theta \pm \frac{v_s}{n} \right)$$

$$q_{\max} = 2k \left( 1 + \frac{v_s}{n} \right) \quad n_s \approx 10^5 \text{ m/s}$$

$$n \approx 10^7 / \text{m/s}$$

$$\Rightarrow q_{\max} \approx 2k$$

$$\frac{q_{\max}}{\frac{\pi}{a}} \approx \frac{2 \frac{m_e^* v}{\hbar} \frac{\pi}{a}}{\pi \cdot \frac{\pi}{a}} \approx 1/4$$

$\Rightarrow$  Only acoustic waves with wave vector from  
the interval between 0 and  $\frac{\pi}{4a}$  ( $1/4$  of the Brillouin zone)

participate in the interaction with electrons  
(or holes)

The matrix element for scattering on non-polar optical phonons (longitudinal) holds

$$|M_{LA}(\vec{R}, \vec{R}')|^2 = E_{de}^2 k_B T \frac{1}{\rho v_s^2 V}$$

$E_{de}$  ... deformation potential of the conduction band (material parameter)

$\rho$  ... density of the matter

The relaxation time for scattering on long-wavelength non-polar longitudinal acoustic phonons is

$$\frac{1}{\tau_{LA}} = \frac{\pi V}{2\hbar} g(\epsilon) \int_0^{\pi} |\mathbf{M}_{LA}|^2 (1 - \cos \theta) \sin \theta d\theta$$

$$\begin{aligned} \frac{1}{\tau_{LA}} &= \frac{\pi V}{2\hbar} \frac{(2m_e)^{3/2}}{2\pi^2 \hbar^3} \epsilon^{1/2} \frac{E_i c k_B T}{\rho v_s^2 V} \int_0^{\pi} (1 - \cos \theta) \sin \theta d\theta \\ &\quad - \overbrace{\int_0^1 (1-x) dx} = 2 \end{aligned}$$

$$\Rightarrow \frac{1}{\tau_{LA}} \sim \epsilon^{1/2} k_B T \quad \epsilon \sim k_B T$$

$$\begin{aligned} \Rightarrow \frac{1}{\tau_{LA}} &\sim (k_B T)^{3/2} \quad \tau_{LA} \sim (k_B T)^{-3/2} \\ &\log \tau_{LA} \sim -3/2 \log T \end{aligned}$$

### Scattering on polar acoustic phonons

In crystals without a center of symmetry with a partial ionic bond there is present also perturbation Hamiltonian connected with electric dipole of the oscillation

The resulting relaxation time  $\tau_{AP}^{(P)}$  is

$$\tau_{AP}^{(P)} = \tau_{P2} \sim T^{-1/2}$$

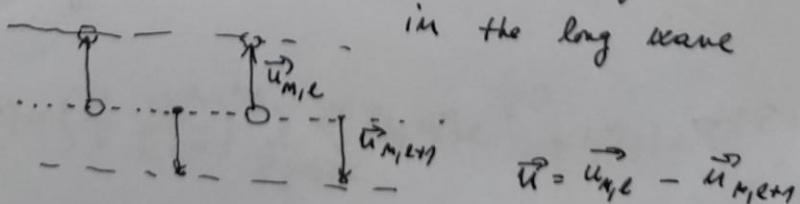
The scattering on polar acoustic phonons is also called piezoelectric scattering, because piezoelectric effect is present in these types of crystals.

### Scattering on non-polar optical phonons

The atoms of the elementary cell oscillate in anti-phase

The interaction Hamiltonian is

$$H_{LO}^{(OP)} = \frac{\pi}{a} \cdot D_0 \vec{u} \quad u \dots \text{shift of atoms}$$



### Scattering on polar optical phonons

The atoms of the base vibrate in anti-phase.

Due to presence of electric charges vibrations cause a time dependent electric dipole.

We will suppose a base of two atoms

$$\vec{u}_{n,e}(\vec{q}) = \frac{1}{\sqrt{N}} \left\{ \vec{e}_{ej}(\vec{q}) b_j(\vec{q}) e^{i\vec{q} \cdot \vec{q}_n} + c.c. \right\}$$

$\vec{u}_{n,e}(\vec{q})$  is the displacement of the  $n$ -th atom of the  $j$ -th branch with wave vector  $\vec{q}$ .

$b$  is the index of atom in the elementary cell  
( $b=1,2$  in our case)

$\vec{e}$  is the polarization vector

$\vec{q}_n$  ... lattice vector of the  $n$ -th cell

Long-wavelength vibrations in optical branch of a crystal with ionic or partially ionic bond result in polarization of the lattice

We know from the results of solid state theory, that  $\vec{P}$  in this case can be written as

$$\vec{P}(F) = \left( \frac{M}{V} \frac{\omega_0^2}{\epsilon_0 \epsilon_r} \right)^{1/2} \sum_{\vec{q} \parallel \vec{F} = \sqrt{16}} \vec{e}_j \cdot (b_j(\vec{q}) e^{i\vec{q} \cdot \vec{F}} + b_j^*(\vec{q}) e^{-i\vec{q} \cdot \vec{F}})$$

Where  $M = M_1 + M_2$ ,  $\omega_0$  is the average frequency

of optical phonons,  $\vec{e}_j$  is a unit vector related to polarization vectors of two atoms in the elementary cell by relations

$$\vec{e}_{ij} = \left(\frac{M_1}{M_2}\right)^{1/2} \vec{e}_j \quad \vec{e}_{2ij} = -\left(\frac{M_1}{M_2}\right)^{1/2} \vec{e}_j.$$

$$\vec{P} = \vec{D} - \epsilon_0 \vec{E} \quad \Rightarrow \quad \operatorname{div} \vec{E} = \frac{1}{\epsilon_0} (\underbrace{\operatorname{div} \vec{D} - \operatorname{div} \vec{P}}_{\rho}) = \\ = \frac{1}{\epsilon_0} (\rho + \rho')$$

$\rho$  ... density of free charge

$\rho'$  ... equivalent density of charge describing the influence of the dielectrics on electric field

We will assume that the density of free charge  $\rho = 0$ . Then

$$\operatorname{div} \vec{E} = \frac{\rho'}{\epsilon_0} \quad \vec{E} = -\nabla \varphi \quad \Delta \varphi = -\frac{\rho'}{\epsilon_0}$$

Poisson equation

$$\Rightarrow \Delta \varphi = \frac{\operatorname{div} \vec{P}}{\epsilon_0}$$

In our case

$$\operatorname{div} \vec{P} = \left(\frac{M}{V} \frac{\omega_0^2}{\epsilon_r \epsilon_0}\right)^{1/2} \sum_{\vec{q}, j} i \underbrace{(\vec{q} \cdot \vec{e}_{qj}(\vec{q}))}_{\sim b_j(\vec{q})} e^{i \vec{q} \cdot \vec{r}} + \text{etc.} \\ \neq 0 \text{ only if } \vec{q} \parallel \vec{e}_{qj}.$$

If  $\Delta\varphi(\vec{r}) \sim (\vec{q} \cdot \vec{e}_{qj}(\vec{q}))$  then also

$$\nabla_{\vec{r}} \varphi \text{ and } \varphi \sim \vec{q} \cdot \vec{e}_{qj}(\vec{q})$$

(the term  $\vec{q} \cdot \vec{e}_{qj}(\vec{q})$  does not depend on  $\vec{r}$ , so remains unchanged when integrating  $\Delta\varphi(\vec{r})$  and  $\nabla_{\vec{r}} \varphi(\vec{r})$  over  $\vec{r}$ )

$\Rightarrow$  the interaction Hamiltonian

$$H' = -e\varphi \sim \vec{q} \cdot \vec{e}_{qj}(\vec{q})$$

$\Rightarrow$  The scattering happens only on longitudinal optical phonons

$$\begin{array}{c} \vec{q} \\ \longrightarrow \\ \vec{e}_{qj}(\vec{q}) \end{array}$$

The scattering on optical phonons is in general non-elastic. It means that the relaxation time approximation can be used only in the case that nonelasticity is small. This happens at high temperatures  $T \gg \frac{k_B}{\omega}$

In this case the energy of electron is high compared to the energy of electron.

In this case  $|\vec{q}| \ll |R|$ ,  $R' = k \pm \vec{q} \approx k$

We will use the matrix element

$$|M_{L0}|^2 = \sum_{+-} \frac{e^2 \hbar \omega_{LO}}{2V\epsilon_0} \left( \frac{1}{\epsilon_{\infty}} - \frac{1}{\epsilon_s} \right) \cdot \frac{1}{k^2} F_q \begin{cases} M_q \\ M_{q+1} \end{cases} \xrightarrow{\substack{\text{absorption of} \\ \text{phonon}}} \xrightarrow{\substack{\text{emission of} \\ \text{phonon}}}$$

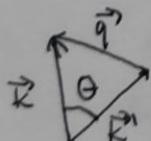
$$M_q = \frac{1}{e \frac{\hbar \omega_{LO}}{kT} - 1} \quad F_q = \frac{k^2}{\frac{1}{R_s^2} + q^2}$$

$R_s$  ... screening length

If we neglect screening ( $R_s \rightarrow \infty$ ;  $F_q \sim \frac{k^2}{q^2}$ )

$$\frac{1}{\epsilon_{LO}^{(+)}} = \sum_{+-} \frac{\pi V}{2\hbar} \frac{(2m_e)^{3/2}}{2\pi^2 k^3} \cdot \sqrt{\epsilon} \int_0^{\pi} \frac{e^2 \hbar \omega_{LO}}{2V\epsilon_0} \cdot \left( \frac{1}{\epsilon_{\infty}} - \frac{1}{\epsilon_s} \right) \cdot \frac{1}{q^2} \begin{cases} M_q \\ M_{q+1} \end{cases} \cdot (1 - \cos \theta) \sin \theta d\theta$$

$\vec{q} = \vec{R} - \vec{R}'$  ; if  $|\vec{R}| \approx |\vec{R}'|$  ... elastic scattering, then



$$|\vec{q}| = 2|\vec{k}| \sin \frac{\theta}{2} \Rightarrow q^2 = 2k^2(1 - \cos \theta)$$

$$|\vec{R}| = k$$

$$|\vec{q}| = q$$

$$\frac{1}{q^2} = \frac{1}{2k^2(1 - \cos \theta)} = \frac{k^2}{4m_e \epsilon} \cdot \frac{1}{1 - \cos \theta}$$

$$\frac{1}{C_{LO}^{(P)}} = \sum_{+-} C \varepsilon^{1/2} \int_0^{\pi} \frac{1}{q^2} \cdot \left\{ \begin{matrix} m_q \\ m_{q+1} \end{matrix} \right\} (1 - \cos \theta) \sin \theta d\theta$$

$$C = \frac{\pi V}{2\hbar} \frac{(2m_e)^{3/2}}{2\pi^2 k^3} \frac{e^2 \hbar \omega_{LO}}{2V\varepsilon_0} \left( \frac{1}{\varepsilon_\infty} - \frac{1}{\varepsilon_s} \right)$$

$$\frac{1}{C_{LO}^{(P)}} = \sum_{+-} C \varepsilon^{1/2} \frac{\hbar^2}{4m_e^2 \varepsilon} \int_0^{\pi} \frac{(1 - \cos \theta)}{(1 + \cos \theta)} \sin \theta d\theta \left\{ \begin{matrix} m_q \\ m_{q+1} \end{matrix} \right\} =$$

$$= C \frac{\hbar^2}{4m_e^2} \varepsilon^{-1/2} \int_0^{\pi} \underbrace{(m_q + m_{q+1})}_{\approx 2m_q} \cdot \sin \theta d\theta$$

$$m_q = \frac{1}{l \frac{\hbar \omega_{LO}}{k_B T} - 1} ; \text{ at high temperatures} \\ \frac{\hbar \omega_{LO}}{k_B T} \text{ is small}$$

$$\Rightarrow l \frac{\hbar \omega_{LO}}{k_B T} \approx 1 + \frac{\hbar \omega_{LO}}{k_B T}$$

$$\Rightarrow m_q \approx \frac{k_B T}{\hbar \omega_{LO}} \quad \int_0^{\pi} \sin \theta d\theta = 2$$

$$\frac{1}{C_{LO}^{(P)}} = C \cdot \frac{\hbar^2}{4m_e^2} \varepsilon^{-1/2} \cdot \frac{4k_B T}{\hbar \omega_{LO}} \quad \varepsilon \propto k_B T$$

$$\Rightarrow \frac{1}{C_{LO}^{(P)}} \approx T^{1/2} ; \quad C_{LO}^{(P)} \approx T^{-1/2}$$

$$\log C_{LO}^{(P)} \approx -1/2 \log T$$

Summary of scattering for phonons  
 at a high-temperature limit  
 (where this type of scattering usually  
 dominates)

Non-polar acoustic phonons	$\tau_{4A} \sim T^{-3/2}$
Polar acoustic phonons	$\tau_{PZ} \sim T^{-1/2}$
Non-polar optical phonons	$\tau_{LO}^{(NO)} \sim T^{-3/2}$
Polar optical phonons	$\tau_{LO}^{(O)} \sim T^{-1/2}$

Scattering on ionized impurities

$$\frac{1}{\tau_I} \sim \varepsilon^{-3/2} \quad (\sim T^{-3/2})$$

$$\tau_I \sim T^{3/2}$$

Combined scattering on ionized impurities  
 and phonons (presented for acoustic  
 phonons)

$$\frac{1}{\tau} = \frac{1}{\tau_I} + \frac{1}{\tau_{4A}}$$

We will continue with description of scattering on ionized impurities.  
as an example let us calculate  $M_i(\vec{R}, \vec{R}')$  for  
scattering on ionized impurities

The perturbing potential is the so-called "Screened Coulomb potential"

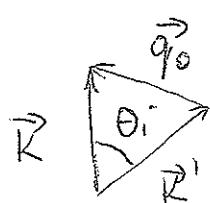
$$\varphi = \pm \frac{e}{4\pi\epsilon_0\epsilon_r r} \cdot e^{-\frac{r}{R_s}}$$

Here  $R_s$  is the so-called screening length.

The screening happens due to mobile carriers (electrons or holes) that are attracted to impurity atoms by Coulomb force and effectively decrease the Coulomb force between the screened impurity atom and test charge.

The corresponding interaction Hamiltonian is then

$$H' = \pm e\varphi$$



Let us define  $\vec{q} = \vec{R} - \vec{R}'$

$$q_0 = 2k \sin \frac{\theta_i}{2}$$

$$|\vec{R}| = |\vec{R}'|$$

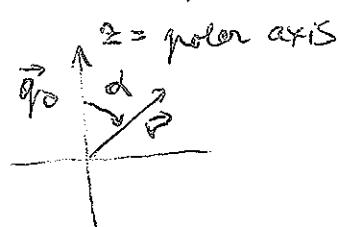
$\sim$   
elastic

scattering

We will now calculate  $M_i(\vec{E}, \vec{R}')$

using polar coordinates  $r, \alpha, \gamma$

We will align the polar axis with vector  $\vec{q}_0$



We will choose a plane wave as  $\Psi_E(\vec{r}) = e^{i\vec{k}\cdot\vec{r}}$

$$M_i(\vec{R}, \vec{R}') = \frac{1}{V} \frac{e^2}{4\pi\epsilon_0\epsilon_r} \int_0^{2\pi} d\phi \int_0^\pi \int_0^\infty \frac{1}{r} e^{-\frac{r}{R_S}} e^{i(\vec{R}-\vec{R}')\vec{P}} \frac{\overrightarrow{q}_0}{r^2 dr \sin\theta d\theta} =$$

$$= \frac{e^2}{2\epsilon_0\epsilon_r V} \int_0^\infty r e^{-\frac{r}{R_S}} \int_0^\pi e^{iqr \cos\theta} \sin\theta d\theta dr =$$

$$\cos\theta = t \quad -\sin\theta d\theta = dt$$

$$= \frac{e^2}{2\epsilon_0\epsilon_r V} \int_0^\infty r e^{-\frac{r}{R_S}} \int_{-1}^1 -e^{iqrt} dt dr =$$

$$= \frac{e^2}{2\epsilon_0\epsilon_r V} \int_0^\infty r e^{-\frac{r}{R_S}} \left[ \frac{e^{iqrt}}{iqr} \right]_{-1}^1 dr =$$

$$= \frac{e^2}{2\epsilon_0\epsilon_r V} \int_0^\infty r e^{-\frac{r}{R_S}} \frac{2i \sin qr}{iqr} dr =$$

$$= \frac{e^2}{2\epsilon_0\epsilon_r q} \int_0^\infty e^{-\frac{r}{R_S}} e^{iqr} dr$$

table integral

$$\int e^{ar} \sin br dr = \frac{e^{ar}}{a^2 + b^2} (a \sin br - b \cos br)$$

$$\text{We set } q = -\frac{1}{R_s} \quad b = q_0$$

$$M_I(R, R') = \frac{e^2}{V \epsilon_0 \epsilon_r q_0} \left[ \frac{1}{\left(\frac{1}{R_s}\right)^2 + q_0^2} \left( -\frac{e^{-\frac{r}{R_s}}}{R_s} \sin qr - e^{-qr} \cos qr \right) \right]_0^\infty =$$

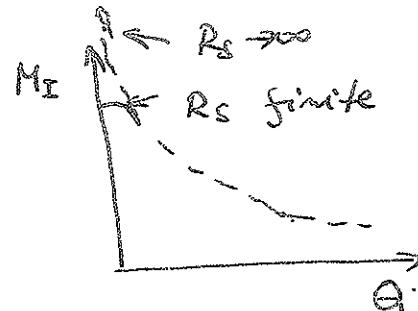
$$= \frac{e^2}{V \epsilon_0 \epsilon_r q_0} \left( \frac{1}{\left(\frac{1}{R_s}\right)^2 + q_0^2} \right) q_0 = \frac{e^2}{V \epsilon_0 \epsilon_r} \cdot \frac{1}{\left(\frac{1}{R_s^2}\right)^2 + q_0^2}$$

$$q_0 = 2k \sin \frac{\Theta_i}{2}$$

$$\Theta_i \rightarrow 0 \quad q_0 \rightarrow 0$$

$$\text{for } R_s \rightarrow \infty \quad M_I \rightarrow \infty$$

(unscreened)



$$N_I = \frac{N}{V}$$

concentration  
of impurities

$$\frac{1}{C_I} = \frac{\pi V}{2\pi} g(\varepsilon) N_I \int_0^\pi |M_I|^2 (1-\cos \Theta_i) \sin \Theta_i d\Theta_i$$

$$\frac{1}{C_I} = \frac{\pi V}{2\pi} g(\varepsilon) N_I \int_0^\pi \left( \frac{e^2}{V \epsilon_0 \epsilon_r} \right)^2 \cdot \left( \frac{1}{\frac{1}{R_s^2} + q_0^2} \right)^2 (1-\cos \Theta_i) \sin \Theta_i d\Theta_i$$

$$q_0^2 = 4\ell^2 \sin^2 \frac{\Theta_i}{2} = 2\ell^2 (1-\cos \Theta_i) \quad \ell = \frac{\hbar^2 k^2}{2m^* \epsilon} \quad \ell^2 = \frac{2m^* \epsilon}{\hbar^2}$$

$$\frac{1}{C_I} = \frac{\pi V}{2\pi} g(\varepsilon) \left( \frac{e^2}{V \epsilon_0 \epsilon_r} \right)^2 N_I \int_0^\pi \frac{(1-\cos \Theta_i) \sin \Theta_i d\Theta_i}{\left( \frac{4m^* \epsilon}{\hbar^2} (1-\cos \Theta_i) + \frac{1}{R_s^2} \right)^2} =$$

$$= \frac{\pi V}{2\pi} g(\varepsilon) \left( \frac{e^2}{V \epsilon_0 \epsilon_r} \right)^2 \left( \frac{\pi^2}{4m^* \epsilon} \right)^2 N_I \int_0^\pi \frac{(1-\cos \Theta_i) \sin \Theta_i d\Theta_i}{\left( 1-\cos \Theta_i + \frac{\pi^2}{4m^* \epsilon R_s^2} \right)^2} =$$

$$= \frac{\pi V}{2k} g(\epsilon) \left( \frac{e^2}{V \epsilon_{0r}} \right)^2 \cdot \left( \frac{\pi^2}{4m^2 \epsilon} \right)^2 N \int_0^t \frac{dt}{(t+b)^2} =$$

(substitution  $t - \epsilon_0 r = t$ )

$$= \frac{\pi V}{2k} g(\epsilon) \left( \frac{e^2}{V \epsilon_{0r}} \right)^2 \left( \frac{\pi^2}{4m^2 \epsilon} \right)^2 \underbrace{\left[ \left( \frac{-2}{b+2} \right) + \ln \left( \frac{b+2}{2} \right) \right]}_{\text{This term is only weakly dependent on energy}}$$

$$\Rightarrow \frac{1}{\tau_I} \sim \epsilon^{1/2} \cdot \frac{1}{\epsilon^2} \sim \epsilon^{-3/2}$$

$$\Rightarrow \tau_I \sim \epsilon^{3/2} (T^{3/2})$$

We have used the integral

$$\int \frac{t}{T^2} dt = \frac{b}{a^2 T} + \frac{1}{a^2} \ln T$$

$$T = at + b$$

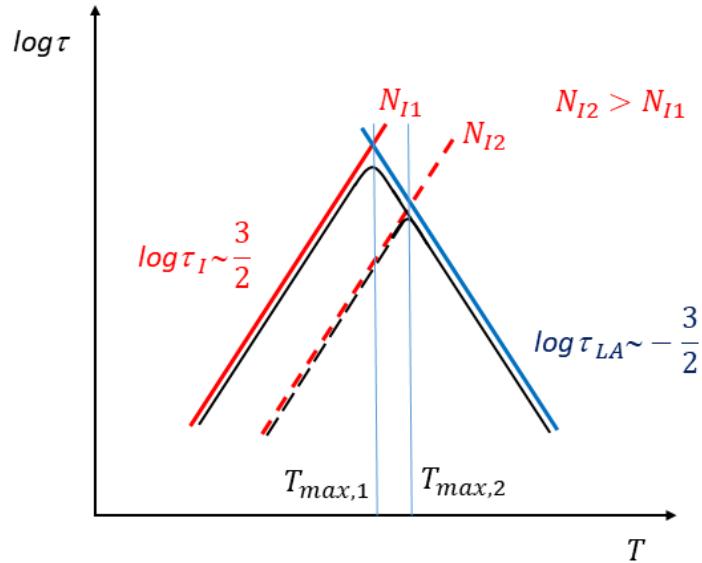
In our case  $a=1$

$$\int \frac{t}{(bt+b)^2} dt = \frac{b}{bt+b} + \ln(bt+b)$$

$$\left[ \frac{b}{bt+b} + \ln(bt+b) \right]_0^2 = \frac{b}{2+b} - 1 + \ln \left( \frac{b+2}{b} \right) =$$

$$= \frac{-2}{b+2} + \ln \left( \frac{b+2}{b} \right)$$

The following picture shows an example of application of the Matthiessen rule for a combination of two scattering mechanisms – scattering on ionized impurities and non-polar acoustical phonons.



We can see that the relaxation time has a maximum for a given concentration of ionized impurities. If this concentration is higher, the maximum is smaller and is shifted gto higher temperature. Multiplying the „y“ axis by  $\frac{e}{m^*}$  we obtain the diagram for the temperature dependence of mobility  $\mu = \frac{e}{m^*} \tau$ .

# ①

 Solution of Boltzmann transport equation

$$\frac{\partial f}{\partial t} = - \vec{v} \cdot \nabla_{\vec{p}} f - \vec{q} \cdot \nabla_{\vec{p}} f - \frac{f_1}{\tau} \quad f = f_0 + f_1$$

$$m_e^* v = k_B T \quad \nabla_{\vec{p}} = \frac{m_e^*}{k_B} \nabla_{\vec{k}}$$

$$m_e^* d\vec{v} = h dk \quad \rightarrow$$

$$\Rightarrow \frac{d}{d\vec{v}} = \frac{m_e^*}{h} \frac{d}{dk}$$

$$\Rightarrow \frac{\partial f}{\partial t} = - \vec{v} \cdot \nabla_{\vec{p}} f - \frac{f}{m_e^*} \cdot \frac{1}{h} \nabla_{\vec{k}} f - \frac{f_1}{\tau}$$

Let us show an example of a solution for a simple situation - application of  $\vec{E}$ -field in a homogeneous semiconductor in a stationary case (i.e.  $\frac{\partial f}{\partial t} = 0$ )

Homogeneous semiconductor  $\equiv \nabla_{\vec{p}} f = 0$

$$\vec{E}\text{-field} \rightarrow \vec{F} = -e \vec{E} \times$$

$$F_x = -e E_x$$

$$\Rightarrow \text{BTE reduces to } \frac{1}{h} \vec{F} \cdot \nabla_{\vec{k}} f = -\frac{f_1}{\tau}$$

$$\times: \quad -\frac{e}{h} E_x \frac{\partial f}{\partial k_x} = -\frac{f_1}{\tau}$$

$$\Rightarrow f_1 = -\frac{\tau}{h} F_x \frac{\partial f}{\partial k_x} = \frac{\tau}{h} e E_x \cdot \frac{\partial f}{\partial k_x}$$

$$\frac{\partial f}{\partial k_x} = \frac{\partial f}{\partial \epsilon} \cdot \frac{\partial \epsilon}{\partial k_x} \quad ; \quad \frac{\partial \epsilon}{\partial k_x} = \frac{k_x^2}{m_e^*} = \frac{k_x^2}{m_e^*} = \tau N_x \\ (\text{since } m_e^* v_x = \hbar k_x)$$

$$\Rightarrow f_1 = -\tau N_x F_x \frac{\partial f_0}{\partial \epsilon} = \tau N_x e E_x \frac{\partial f_0}{\partial \epsilon}$$

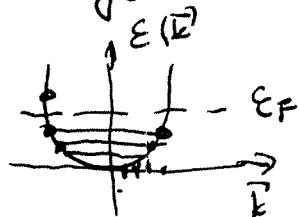
(2)

## Electric current

We have shown previously that

$$j = \rho_c v \quad \rho_c \dots \text{density of electric charge}$$

$$\rho_c = -\frac{2e}{V} \sum_{\vec{k}} f(\vec{k})$$



$$j = -\frac{2e}{V} \sum_{\vec{k}} f(\vec{k}) \vec{v}(\vec{k})$$

We switch from summation to integration multiplying by density of states in  $k$  space  $\frac{V}{8\pi^3}$

$$\vec{j}_* = -\frac{2e}{V} \cdot \frac{V}{8\pi^3} \int f(\vec{k}) \vec{v}(\vec{k}) d^3k \rightarrow j_x = -\frac{2e}{V} \frac{V}{8\pi^3} \int f(\vec{k}) N_x d^3k$$

$$f(\vec{k}) = f_0(\vec{k}) - \sigma v_x (-eE_x) \frac{\partial f}{\partial \epsilon}$$

$$j_x = -\frac{e}{4\pi^3} \int v_x f_0(\vec{k}) d^3k - \frac{e^2}{4\pi^3} E_x \int \sigma v_x^2 \frac{\partial f_0}{\partial \epsilon} d^3k$$

Since  $E$  is an even function of  $\vec{k}$ ,  $v_x f_0(\vec{k})$  is an odd function  $N_x$ . Since integration with respect to  $dk_x$  ranges from  $(-\infty \text{ to } +\infty)$  the first term on the right hand side becomes zero and only the second term remains

$$j_x = -\frac{e^2 E_x}{4\pi^3} \int \sigma v_x^2 \frac{\partial f_0}{\partial \epsilon} d^3k$$

(3)

We can express the electron density  $n$  as

$$n = 2 \cdot \frac{\sum_{\vec{E}} f_0(\vec{k})}{V} = \begin{array}{c} \text{Diagram showing energy levels } \epsilon(E) \text{ on the vertical axis and } \vec{k} \text{ on the horizontal axis.} \\ \text{Two electrons are shown in a state at energy } E. \end{array}$$

$$= \frac{2}{V} \cdot \frac{V}{(2\pi)^3} \cdot \int f_0(\vec{k}) d^3k = \frac{1}{4\pi^3} \int f_0(\vec{k}) d^3k$$

$\underbrace{\qquad}_{g_{\vec{k}} \text{ ... density of states in } \vec{k}\text{-space}}$

We can then write

$$j_x = -\frac{e^2 n E_x}{4\pi^3} \cdot 4\pi^3 \cdot \frac{\int \sigma v_x^2 \frac{\partial f_0}{\partial \epsilon} d^3k}{\int f_0 d^3k} =$$

$$= -e^2 n E_x \frac{\int \sigma v_x^2 \frac{\partial f_0}{\partial \epsilon} d^3k}{\int f_0 d^3k}$$

$$\frac{\partial f_0}{\partial \epsilon} = -\frac{1}{k_B T} \cdot \frac{e^{\frac{\epsilon - \epsilon_F}{k_B T}}}{(1 + e^{\frac{\epsilon - \epsilon_F}{k_B T}})^2} = -\frac{1}{k_B T} f_0(1-f_0)$$

$$\text{because } 1-f_0 = 1 - \frac{1}{1 + e^{\frac{\epsilon - \epsilon_F}{k_B T}}} = \frac{e^{\frac{\epsilon - \epsilon_F}{k_B T}}}{1 + e^{\frac{\epsilon - \epsilon_F}{k_B T}}}$$

We introduce  $\phi(\epsilon) = \sigma f_0(1-f_0)$

$$d^3k = dk_x dk_y dk_z$$

$$\int \sigma v_x^2 \frac{\partial f_0}{\partial \epsilon} d^3k = \int v_x^2 \phi(\epsilon) d^3k = \int v_y^2 \phi(\epsilon) d^3k =$$

$$= \int v_z^2 \phi(\epsilon) d^3k = \frac{1}{3} \int v^2 \phi(\epsilon) d^3k$$

$$(\epsilon = \frac{1}{2} m(v_x^2 + v_y^2 + v_z^2)) = \frac{1}{2} m v^2$$

(4)

$$\begin{aligned}
 j_x &= \frac{e^2 n E_x}{k_B T} \cdot \frac{1}{3} \cdot \frac{\int_0^\infty \epsilon^2 \phi(\epsilon) d^3 k}{\int_0^\infty d^3 k} = \\
 &= \frac{1}{3} \frac{e^2 n E_x}{k_B T} \cdot \frac{\int_0^\infty \frac{2\epsilon}{m_e^*} \phi(\epsilon) 4\pi k^2 dk}{\int_0^\infty 4\pi k^2 dk} = \\
 &= \frac{2}{3} \frac{e^2 n E_x}{k_B T} \cdot \frac{\int_0^\infty \frac{\epsilon}{m_e^*} \phi(\epsilon) 4\pi k^2 dk}{\int_0^\infty 4\pi k^2 dk}
 \end{aligned}$$

$$4\pi k^2 dk = 4\pi \cdot \frac{2m_e^* \epsilon}{\hbar^2} dk$$

$$dE = \frac{\hbar^2}{m_e^*} k dk = \frac{\hbar^2}{m_e^*} \frac{\sqrt{2m_e^* \epsilon}}{\hbar} d\epsilon$$

$$dk = \frac{m_e^*}{\hbar} \cdot \frac{1}{\sqrt{2m_e^* \epsilon}} d\epsilon$$

$$\Rightarrow 4\pi k^2 dk = \frac{8\pi m_e^* \epsilon}{\hbar^3} \cdot m_e^* \cdot \frac{1}{\sqrt{2m_e^* \epsilon}} d\epsilon =$$

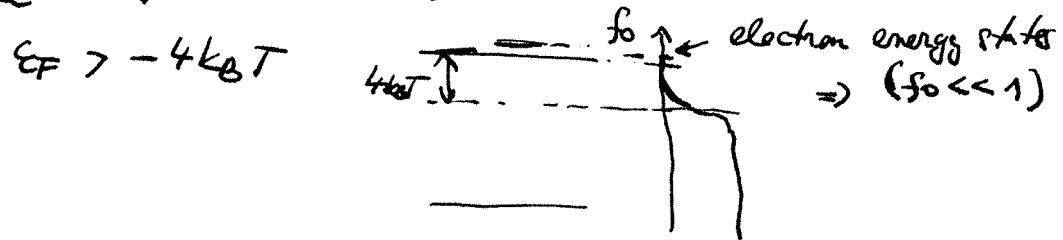
$$= \frac{8\pi}{\hbar^3} \cdot \frac{1}{\sqrt{2}} \cdot m_e^{*3/2} \epsilon^{1/2} d\epsilon$$

$$\begin{aligned}
 j_x &= \frac{2}{3} \frac{e^2 n E_x}{k_B T m_e^*} \cdot \frac{\int_0^\infty \phi(\epsilon) \epsilon^{3/2} d\epsilon}{\int_0^\infty \phi(\epsilon) \epsilon^{1/2} d\epsilon} = \\
 &= \frac{2}{3} \frac{e^2 n E_x}{k_B T m_e^*} \cdot \frac{\int_0^\infty \epsilon f_0(1-f_0) \epsilon^{3/2} d\epsilon}{\int_0^\infty f_0 \epsilon^{1/2} d\epsilon}
 \end{aligned}$$

(5)

Now, let us suppose that the semiconductor is non-degenerate. Then  $f_0 \ll 1$

(because for non-degenerate semiconductors



$$\text{Therefore } 1-f_0 \approx 1 \quad (f_0(1-f_0) = f_0 - f_0^2)$$

$\Rightarrow j_x$  reduces to  $\xrightarrow{\text{small}} \xrightarrow{\text{very small}}$

$$j_x = \frac{2}{3} \frac{e^2 n E_x}{k_B T m_e^*} \frac{\int_0^\infty f_0 e^{3/2} dE}{\int_0^\infty f_0 E^{1/2} dE}$$

Integration per-particle gives

$$\int_0^\infty E^{3/2} f_0 dE = \frac{3}{2} k_B T \int_0^\infty E^{1/2} dE$$

$$\Rightarrow j_x = \frac{2}{3} \frac{e^2 n E_x}{k_B T m_e^*} \cdot \frac{3}{2} \frac{\int_0^\infty E f_0 E^{3/2} dE}{\int_0^\infty f_0 E^{3/2} dE} = \\ = \frac{e^2 n E_x}{m_e^*} \cdot \langle \tau \rangle ; \text{ where } \langle \tau \rangle = \frac{\int_0^\infty \tau f_0 E^{3/2} dE}{\int_0^\infty f_0 E^{3/2} dE}$$

From previous calculations we know that

$$j_x = \rho_e v_x = (-e) \cdot n \langle v_x \rangle \quad \leftarrow \text{drift velocity}$$

$$\Rightarrow j_x = \frac{(-e) \cdot (-e) \cdot n E_x}{m_e^*} \langle \tau \rangle = \frac{\mu n}{m_e^*} \mu E_x$$

where  $\mu = \frac{e}{m_e^*} \langle \tau \rangle$   
is mobility

$$j_x = \rho_c \langle v_x \rangle = \rho_c \underbrace{(-\mu E_x)}_{\langle v_x \rangle} = (-me)(-\mu)E_x = me\mu E_x \quad (6)$$

$\rho_c$  ... charge density ( $e/n$ )  
for electrons

$\tau e P$   
for holes

$$j_x = ne\mu E_x = \sigma E_x \quad V = RI \quad I = \frac{1}{R} \cdot V$$

$\sigma$  ... electric conductivity

$$\uparrow j = \sigma \cdot E$$

Equation above represents the Ohm's law

# Solution of Boltzmann transport equation (general case) - stationary

$$\vec{v} \cdot \nabla_{\vec{P}} f - \frac{e}{\hbar} [\vec{E} + \vec{v} \times \vec{B}] \nabla_{\vec{P}} f = - \frac{f_1}{\tau} = - \frac{(f-f_0)}{\tau}$$

$$f_1 = - \left( \frac{\partial f_0}{\partial \vec{x}} \right) \vec{x} \cdot \vec{E} \quad \vec{x} = \frac{\hbar \Delta \vec{k}}{m^*}$$

We are looking for  $f_1$  with the precision to the 1. st term of Taylor expansion (small deviations)

We calculate  $\nabla_{\vec{P}} f_0; \nabla_{\vec{P}} f_1, \nabla_{\vec{E}} f_0, \nabla_{\vec{E}} f_1$   
and perform linearization (1. st term in  $\vec{E}$ )

$\Rightarrow$  This leads to equation

$$\vec{x} = \vec{a} + \vec{b} \vec{x}$$

We introduce  $\vec{x}^* = - \frac{m^*}{\hbar e} \vec{x} ; \gamma = \frac{e}{m^*}$

$\Rightarrow$  Solution of the equation is

$$\vec{x}^* = \frac{\tau \vec{P} + \gamma c^2 [\vec{B} \times \vec{P}] + \gamma^2 c^3 (\vec{B} \cdot \vec{P}) \vec{B}}{1 + \gamma c^2 B^2}$$

$$\vec{P} = \frac{e}{\hbar} (x - \gamma) \nabla_{\vec{P}} T + \frac{e T}{\hbar} \nabla_{\vec{P}} \gamma - \nabla_{\vec{P}} \varphi$$

$$x = \frac{e}{k_B T} \quad \gamma = \frac{e P}{k_B T}$$

$$\text{For } \vec{B} = 0 \text{ we have } \vec{x}^* = \tau \vec{P}$$

The density of electric current and the density of energy flux (8)

$$\vec{J} = \sum_{\vec{k}} \frac{2}{V} f(\vec{k}, \vec{r}_t, t) \vec{v} \quad \text{- density of flux of particles}$$

$$\vec{j}_e = - \frac{2e}{V} \sum_{\vec{k}} f(\vec{k}, \vec{r}_t, t) \vec{v} \quad \text{the density of electric current (electronic)}$$

$$n^{\vec{k}} = \frac{f(\vec{k})}{m_e^{3/2}}$$

$$\vec{j}_e = - \frac{2e}{V} \frac{\int f(\vec{k}, \vec{r}_t, t) \vec{v} d^3 k}{\frac{(2\pi)^3}{V}} \quad \text{Volume on 1 state of the k-space}$$

$$\vec{j}_e = - \frac{e\hbar}{4\pi^3 m_e} \int f(\vec{k}, \vec{r}_t, t) \vec{k} \cdot d^3 k$$

kinetic energy  
 ↓  
 potential energy

$$\vec{w}_e = \sum_{\vec{k}} \frac{2}{V} f(\vec{k}, \vec{r}_t, t) \vec{v} (\epsilon - e\varphi)$$

$$\vec{w}_e = \frac{\hbar}{4\pi^3 m_e} \int f(\vec{k}, \vec{r}_t, t) (\epsilon - e\varphi) \vec{k} \cdot d^3 k$$

$f = f_0 + f_1$        $\int f_0(\vec{k}) \vec{k} \cdot d^3 k = 0$   
 ↑ even function

Then

$$\vec{j}_e = - \frac{e\hbar}{4\pi^3 m_e} \int \left( -\frac{\partial f_0}{\partial \epsilon} \right) \vec{k} \cdot \vec{k} \cdot d^3 k$$

(9)

We integrate in spherical coordinates, introduce

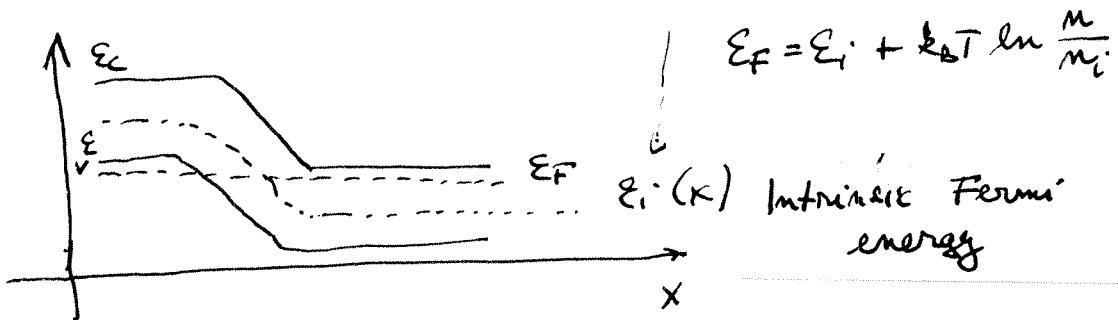
$$\langle \chi^* \rangle = \frac{\int_0^\infty -\left(\frac{\partial f}{\partial \varepsilon}\right) \chi^* \varepsilon^{3/2} d\varepsilon}{\int_0^\infty \left(-\frac{\partial f_0}{\partial \varepsilon}\right) \varepsilon^{3/2} d\varepsilon}$$

We will from this point assume, that magnetic field vector  $\vec{B} \parallel z$ .

We obtain after some calculations

$$\vec{j}_e = \frac{e^2 \kappa}{m_e \epsilon^*} \langle \chi^* \rangle = \overleftrightarrow{\sigma} \nabla_B \frac{\epsilon_F(\vec{r})}{e} + \overleftrightarrow{\sigma} D_B T$$

Inhomogeneous semiconductor



$$\overleftrightarrow{\sigma} = \begin{pmatrix} \sigma_{xx} & -\sigma_{xy} & 0 \\ \sigma_{xy} & \sigma_{xx} & 0 \\ 0 & 0 & \sigma_{zz} \end{pmatrix} \quad \vec{B} \parallel z$$

$$\overleftrightarrow{B} = \begin{pmatrix} -B_{xx} & B_{xy} & 0 \\ -B_{xy} & -B_{xx} & 0 \\ 0 & 0 & B_{zz} \end{pmatrix}$$

We repeat the last figure from the previous lecture and explain its meaning.

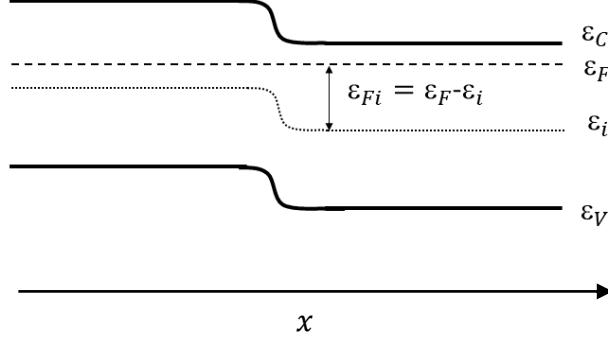


Figure – an example of the spatial profile of bands in an inhomogeneous semiconductor. Here  $\varepsilon_F$  is the Fermi energy and  $\varepsilon_i$  is the intrinsic Fermi energy. Their difference  $\varepsilon_{Fi}$  characterizes the spatial changes.

The concentration of electrons (non-degenerate case) is

$$n(\mathbf{r}) = N_C e^{\frac{\varepsilon_F}{k_B T}}$$

The intrinsic concentration is

$$n_i = N_C e^{\frac{\varepsilon_i}{k_B T}}$$

We can write

$$N_C = n_i e^{-\frac{\varepsilon_i}{k_B T}}$$

$$n(\mathbf{r}) = n_i e^{\frac{\varepsilon_F - \varepsilon_i}{k_B T}}, \quad \varepsilon_F - \varepsilon_i = k_B T(\mathbf{r}) \ln \frac{n(\mathbf{r})}{n_i} = \varepsilon_{Fi}$$

$$\nabla_{\mathbf{r}} \varepsilon_{Fi} = k_B \nabla_{\mathbf{r}} T \ln \frac{n(\mathbf{r})}{n_i} + k_B T \nabla_{\mathbf{r}} \ln \frac{n(\mathbf{r})}{n_i} = k_B \nabla_{\mathbf{r}} T \ln \frac{n(\mathbf{r})}{n_i} + k_B T \frac{\nabla_{\mathbf{r}} n(\mathbf{r})}{n(\mathbf{r})}$$

The intrinsic Fermi energy  $\varepsilon_{Fi}$  can be written using the potential as  $\varepsilon_{Fi} = -e\varphi_i$ . Then the corresponding electric field is

$$\mathbf{E}_i = -\nabla_{\mathbf{r}} \varphi_i = \frac{\nabla_{\mathbf{r}} \varepsilon_{Fi}}{e}.$$

The total electric field  $\mathbf{E}^*$  in the sample is a sum of the electric field  $\mathbf{E} = -\nabla_{\mathbf{r}} \varphi$  formed as a result of the application of external bias and the electric field  $\mathbf{E}_i$  formed due to the gradient of concentration of electrons (or holes).

$$\mathbf{E}^* = \mathbf{E} + \mathbf{E}_i$$

The solution of the Boltzmann transport equation leads to the equation for the density of the electric current

$$\mathbf{j} = \vec{\sigma} \mathbf{E}^* + \vec{\beta}_0 \nabla_{\mathbf{r}} T,$$

Which can be written as

$$\mathbf{j} = \vec{\sigma} \mathbf{E} + \vec{\sigma} \frac{k_B T}{e} \frac{\nabla_{\mathbf{r}} n(\mathbf{r})}{n(\mathbf{r})} + \frac{k_B}{e} \ln \frac{n(\mathbf{r})}{n_i} \nabla_{\mathbf{r}} T + \vec{\beta}_0 \nabla_{\mathbf{r}} T.$$

We define a new tensor  $\vec{\beta}$  combining the 3<sup>rd</sup> and 4<sup>th</sup> term of the equation and obtain the drift-diffusion equation

$$\mathbf{j} = \vec{\sigma} \mathbf{E} + \vec{\sigma} \frac{k_B T}{e} \frac{\nabla_{\mathbf{r}} n(\mathbf{r})}{n(\mathbf{r})} + \vec{\beta} \nabla_{\mathbf{r}} T$$

The first term represents the electric current caused by externally applied bias (drift term), the second term is the electric current due to diffusion of carriers caused by the concentration gradient and the third term is the electric current caused by gradient of temperature.

Hence  $\overleftrightarrow{\tau} = \begin{pmatrix} \sigma_{xx} & -\sigma_{xy} & 0 \\ \sigma_{xy} & \sigma_{yy} & 0 \\ 0 & 0 & \sigma_{zz} \end{pmatrix}$

$$\sigma_{xx} = \frac{e^2 \kappa}{m_e^*} \left\langle \frac{\tau}{1+b^2} \right\rangle \quad \sigma_{xy} = \frac{e^2 \kappa}{m_e^*} \left\langle \frac{\tau b}{1+b^2} \right\rangle$$

$$\sigma_{zz} = \frac{e^2 \kappa}{m_e^*} \langle \tau \rangle$$

$$b = \frac{e}{m_e^*} CB = j \tau B$$

$$\overleftrightarrow{\beta} = \begin{pmatrix} -\beta_{xx} & \beta_{xy} & 0 \\ -\beta_{xy} & -\beta_{yy} & 0 \\ 0 & 0 & -\beta_{zz} \end{pmatrix}$$

$$\beta_{xy} = -\frac{e n k_B}{m_e^*} \left\langle \frac{\tau(x-y)}{1+b^2} \right\rangle$$

$$\beta_{xz} = -\frac{e n k_B}{m_e^*} \left\langle \frac{\tau b(x-y)}{1+b^2} \right\rangle$$

$$\beta_{zz} = \frac{e n k_B}{m_e^*} \langle \tau(x-y) \rangle$$

Transition relations to holes

$$-e \rightarrow +e \quad \gamma \rightarrow \gamma' \quad x \rightarrow x' \quad b \rightarrow b_h$$

$$b_h = \frac{e}{m_e^*} \tau B$$

With the same approach it is possible to derive the equation for heat transfer

$$\vec{w} = T \overleftrightarrow{\beta} \vec{E} + \vec{x} \nabla T$$

$$\vec{\kappa} = \vec{\kappa}_e + \vec{\kappa}_p$$

$\vec{\kappa}_p$  - diagonal matrix describes the thermal conductivity of lattice

$$\vec{\kappa} = \begin{pmatrix} -\kappa_{xx} - \kappa_p & \kappa_{xy} & 0 \\ -\kappa_{xy} & -\kappa_{yy} - \kappa_p & 0 \\ 0 & 0 & -\kappa_{zz} - \kappa_p \end{pmatrix}$$

If both electrons and holes are present the following equations are valid

$$\vec{j} = \vec{j}_e + \vec{j}_h \quad \vec{w} = \vec{w}_e + \vec{w}_h$$

The equations for  $\vec{j}$  and  $\vec{w}$  can be re-formulated

$$\vec{j} = \vec{\sigma} \vec{E}^* + \vec{\beta} D_F T$$

$$\vec{w} = T \vec{\beta} \cdot \vec{E}^* + \vec{\kappa} D_F T$$

$\vec{\beta}$  .. unit tensor

$$\vec{\sigma} \vec{E}^* = \vec{j} - \vec{\beta} D_F T \quad 1 \cdot \text{F}^{-1}$$

$$\vec{E}^* = \vec{\sigma}^{-1} \vec{j} - \underbrace{\vec{\beta}^{-1} \vec{\sigma} D_F T}_{\vec{\alpha}} \quad \vec{\sigma}^{-1} = \vec{\rho}$$

$$\vec{\rho} \quad \vec{\alpha} \quad \vec{\alpha} = \vec{\sigma}^{-1} \vec{\beta}$$

$\vec{\rho}$  .. resistivity tensor

$\vec{\alpha}$  - Seebeck coefficient

$$\vec{w} = T \vec{\beta} (\vec{\rho} \vec{j} - \vec{\alpha} D_F T) + \vec{\kappa} D_F T$$

$$\vec{w} = T \vec{\beta} \vec{\rho} \vec{j} + \underbrace{(\vec{\beta} \vec{\alpha} + \vec{\kappa}) D_F T}_{\vec{\Pi} = \vec{\alpha} T} \quad \text{Bridgman relation}$$

$\vec{\Pi}$  ... Peltier coefficient

$\vec{\kappa}$  ... thermal conductivity

$$\vec{\rho} = \begin{pmatrix} \rho_{xx} & \rho_{xy} & 0 \\ -\rho_{yx} & \rho_{yy} & 0 \\ 0 & 0 & \rho_{zz} \end{pmatrix} \quad \rho_{xx} = \rho_{yy}$$

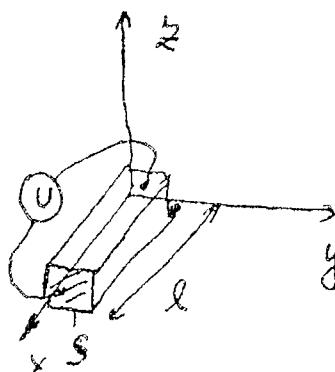
$$\vec{\alpha} = \begin{pmatrix} \alpha_{xx} & \alpha_{xy} & 0 \\ -\alpha_{yx} & \alpha_{yy} & 0 \\ 0 & 0 & \alpha_{zz} \end{pmatrix} \quad \alpha_{xx} = \alpha_{yy}$$

$$\vec{\Pi} = \begin{pmatrix} \Pi_{xx} & \Pi_{xy} & 0 \\ -\Pi_{yx} & \Pi_{yy} & 0 \\ 0 & 0 & \Pi_{zz} \end{pmatrix} \quad \Pi_{xx} = \Pi_{yy}$$

$$\vec{\gamma} = \begin{pmatrix} -\gamma_{xx} & \gamma_{xy} & 0 \\ -\gamma_{yx} & -\gamma_{yy} & 0 \\ 0 & 0 & -\gamma_{zz} \end{pmatrix} \quad \gamma_{xx} = \gamma_{yy}$$

Transport effects without B

Ohm's law: Theory:



$$\vec{E} = (E_x, 0, 0) \quad \begin{matrix} E - \text{field} \\ \text{due to} \\ \text{applied bias} \end{matrix}$$

$$\vec{B} = (0, 0, 0)$$

$$\Rightarrow b = 0$$

$$\vec{E}' = \vec{E}$$

$$\vec{J} = \sigma \vec{E}$$

$$j_x = \tau_{xx}(0) \cdot E_x = \frac{e^2 n \langle v \rangle}{m_e^*} E_x \quad j = \sigma E$$

$$\tau_{xx}(0) \equiv \tau_0$$

$$R = \frac{V}{I} = \rho_0 \cdot \frac{l}{S} \quad \Rightarrow \quad \rho_0 = \frac{V}{I} \cdot \frac{S}{l}$$

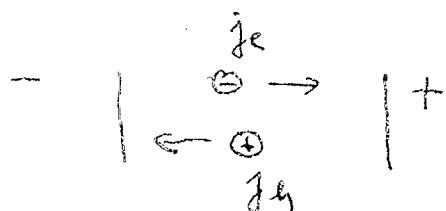
$$\frac{I}{S} = \frac{1}{\rho_0} \cdot \frac{V}{l}$$

$$j = \frac{1}{\rho_0} \cdot E = \sigma \cdot E$$

$\Rightarrow \tau_0$  from experiment equals  $\frac{e^2}{m_e^*} \cdot n \langle v \rangle$

Because  $\tau_0 \sim e^2$  electrons and holes contribute to electric current

$$\vec{J} = \vec{j}_e + \vec{j}_h = \left( \frac{e^2 n}{m_e^*} \langle v_e \rangle + \frac{e^2 p}{m_h^*} \langle v_h \rangle \right) \vec{E}$$



## Thermal conductivity

Thermal conductivity of material consists of thermal conductivity of electrons (holes) which are derived from BTE and thermal conductivity of lattice, which is added to the formulas

$$\vec{J} = (0, 0, \alpha)$$

$$\vec{W} = \Sigma D_B T$$

$$\vec{B} = (0, 0, 0)$$

$$W_x = -\lambda_{xx} \nabla_x T$$

$$D_B T = (\nabla_x T, 0, 0)$$

$$W_x = -[\lambda_{xx}(0) + \lambda_y - T B_{xx}(0) \alpha_{xx}(0)] \nabla_x T$$

$$W_x = -[\lambda_{xx}(0) + \lambda_y - T \frac{B_{xx}^2(0)}{\sigma_{xx}(0)}] \nabla_x T$$

$$W_x = -[\lambda_{xx}(0) - T \cdot \frac{B_{xx}^2(0)}{\sigma_{xx}(0)}] \nabla_x T - \lambda_y \nabla_x T$$

After applying formulas for  $\lambda_{xx}(0), B_{xx}(0)$

and  $\sigma_{xx}(0)$  we obtain

$$W_x = [L \cdot \sigma_{xx}(0) \cdot T - \lambda_y] \nabla_x T$$

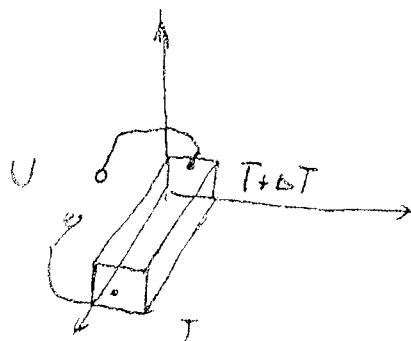
$$L = \left(\frac{k_B}{e}\right)^2 \left( \langle \alpha_x^2 \rangle - \frac{\langle \alpha_x \rangle^2}{\langle z \rangle} \right) \quad x = \frac{e}{k_B T}$$

$L$  = Lorentz number

$$\lambda_{xx} = \frac{m k_B T}{m_e^*} \left\langle \frac{T (x_y)^2}{1+b^2} \right\rangle \quad \lambda_{xy} = \frac{k_B T m}{m_e^*} \left\langle \frac{T (x-y)^2 b}{1+b^2} \right\rangle$$

## Thermoelectric (Seebeck) effect

The Seebeck effect was discovered in 1821 by German physicist Thomas Seebeck (born in Tallinn, graduated in Göttingen).



$U$  - open circuit voltage  
formed by Seebeck effect  
due to a temperature  
gradient in the sample.

$$U = \alpha \cdot \Delta T \quad (\text{experiment})$$

$$j_x = \sigma_{xx}(0) E_x^* - \beta_{xx}(0) D_x T = 0 \quad (\text{open circuit})$$

$$E_x^* = \frac{\beta_{xx}(0)}{\sigma_{xx}(0)} D_x T \quad -\nabla_x \phi^* = \alpha_{xx}(0) \cdot D_x T$$

$\downarrow$

$$\alpha_{xx}(0) \quad \text{Seebeck coefficient}$$

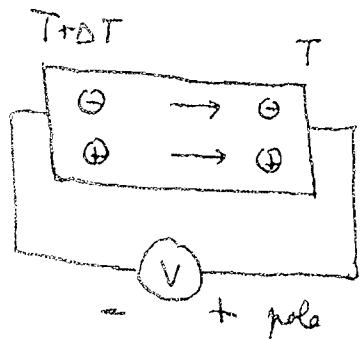
Using the Seebeck effect it is possible  
the type of the semiconductor

$$\alpha_{xx}(0) \sim e^2 \quad \beta_{xx}(0) \sim (-e)$$



the same for  
electrons ( $-e$ )  
and holes ( $+e$ )

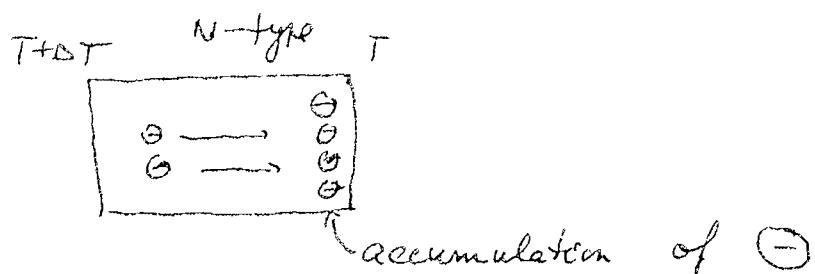
different for electrons  
and holes



Electrons and holes diffuse against the temperature gradient.

If the semiconductor is n-type, the diffusion of electrons will cause decrease of the potential on the (+) end that is at lower T.

(negative charge is built on the cooler end to stop the flow of electrons from the hotter end.

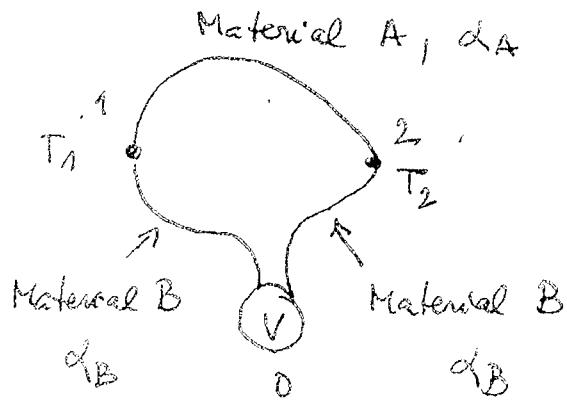


In case of P-type semiconductor the situation is opposite.

Another application of Seebeck effect  
- the thermocouple

Thermocouple is formed from two materials with different Seebeck coefficients.

It is used to measure temperature difference, or absolute temperature.



The bias measured by the voltmeter

$$\begin{aligned}
 U &= \int_1^2 E_A dx + \int_0^1 E_B dx + \int_0^1 E_B dx = \\
 &= \int_1^2 E_A dx + \int_1^2 E_B dx = \int_1^2 (E_A - E_B) dx \\
 &= \int_{T_1}^{T_2} (\alpha_A - \alpha_B) \cdot \frac{dT}{dx} dx = (\alpha_A - \alpha_B)(T_2 - T_1)
 \end{aligned}$$

$\alpha_A, \alpha_B$  ... Seebeck coefficients of materials A and B

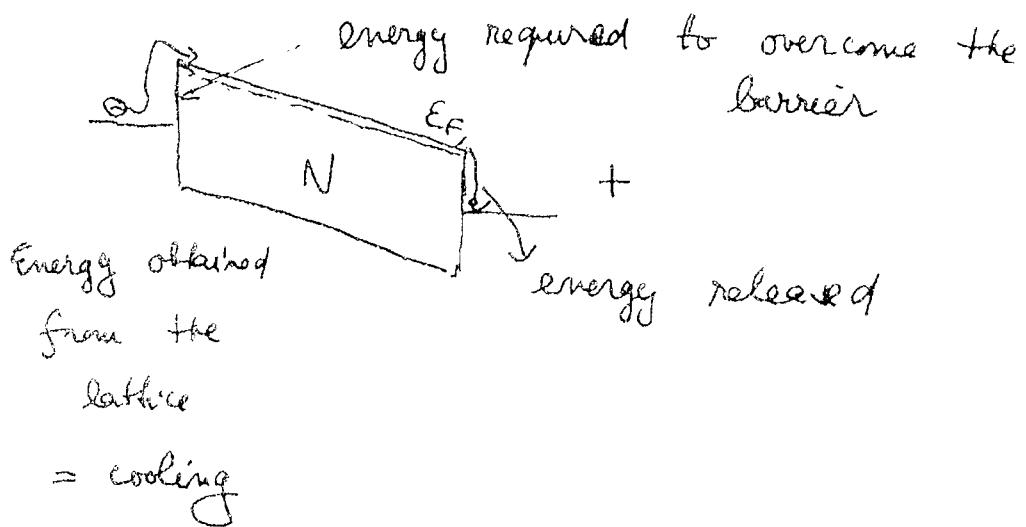
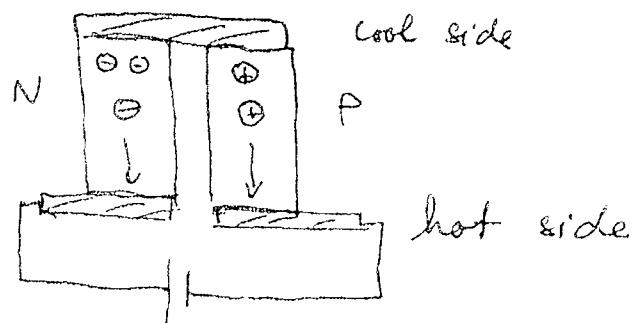
Normally we fix  $T_1$  (mixture of ice and water, nitrogen, helium)

and knowing  $\alpha_A$  and  $\alpha_B$  we calculate  $T_2$

## Peltier effect

Peltier effect consists of formation of temperature gradient as a result of flow of electric current.

$$W_x = \Pi_{xx} j_x$$



When we reverse the direction of the electric current, the hot and cold sides exchange

## Calculation of efficiency of the Peltier element

$$\Pi_x = \Pi_{xx} j_x + \lambda_{xx} \nabla_x T$$

↑                      ↓

Primary effect -  $j_x \rightarrow \nabla_x T$

Secondary effect  
The gradient due to current flow results in opposite flow of carriers



$$R = \rho \cdot \frac{l}{S} = \frac{V}{I}$$

$$V = \rho \frac{l I}{S} = \rho l j$$

$$\frac{V}{l} = \rho \cdot j \quad E = \rho \cdot j$$

$$E = \frac{1}{\sigma} j \quad j = \sigma E$$

$$\frac{\Pi \cdot j}{\lambda \nabla_x T} = \frac{\alpha T j}{\lambda \nabla_x T} = \frac{\alpha T \cdot \sigma \cdot \frac{V}{l}}{\lambda \cdot \frac{\Delta T}{l}} =$$

$$= \frac{\alpha^2 T \cdot \sigma \cdot U}{\lambda \cdot \alpha \cdot \Delta T} = \frac{\alpha^2 T}{\lambda} \cdot T \cdot \frac{U}{2T} = Z \cdot T \cdot \frac{U}{U_T}$$

Selbeck voltage  $U_T$

$Z = \frac{\alpha^2 \sigma}{\lambda}$  For a high efficiency of the effect  $Z$  must be high, high  $\alpha$  and  $T$ , low  $\lambda$

Drift-diffusion equation - introduction  
of mobility and diffusion coefficient

$$\vec{j} = \vec{F} E + \vec{F} \frac{k_B T}{e} \cdot \frac{\nabla \ln n(\vec{r})}{m} + \vec{B} D_T T$$

assuming  $D_T T$  we can calculate in  
the absence of magnetic field ( $B=0$ )

$$j_x = \nabla_{xx} E_x + \nabla_{xx} \frac{k_B T}{e} \cdot \frac{dn(x)}{dx} - \frac{1}{m}$$

$$\nabla_{xx} = \frac{e^2 n}{m e^2} \langle \vec{v} \rangle = e \cdot m \cdot \mu_e$$

where  $\mu_e = \frac{e}{m_e} \langle \vec{v} \rangle$  we call "mobility"

$$j_x = e n \mu_e E_x + \frac{e n \mu_e k_B T}{e} \cdot \frac{1}{m} \cdot \frac{dn(x)}{dx} =$$

$$= e n \mu_e E_x + \mu_e k_B T \frac{dn(x)}{dx} =$$

$$= e n \mu_e E_x + e D_e \cdot \frac{dn(x)}{dx}$$

$$D_e = \frac{k_B T}{e} \cdot \mu_e \text{ - we call}$$

"diffusion constant"

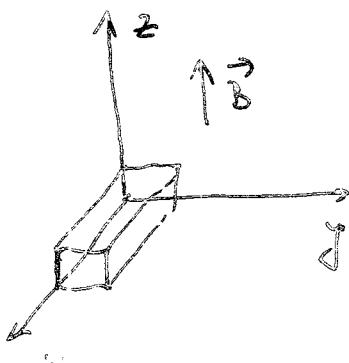
## Transport effects in magnetic field

If the deviation from equilibrium in the sample is small (condition under which we solved the Boltzmann transport equation), then all  $\tau_{ij}$  elements of the transport tensors are not a function of  $\vec{B}$  (i.e. "b" in the eqs.)  $\Rightarrow$  all the transport effects || to "z" direction do not depend on  $\vec{B}$  (e.g.  $j_z = \tau_{zz} E_z + f(\vec{B})$ )

On  $\vec{B}$  depend therefore only transversal effects (i.e. when  $\vec{B}$  is perpendicular to the acting forces)

$$\tau_{zz} = \frac{e^2 n}{m_e^*} \langle v \rangle$$

### Transversal magnetoresistance



$$\vec{E} \cdot \vec{p} j \quad \vec{j} = (j_x, 0, 0)$$

$$\vec{B} = (0, 0, B)$$

$$\rho(0) = \frac{1}{\tau_{xx}(0)}$$

$$E_x = \rho_{xx} j_x \quad \rho_{xx} = \frac{\tau_{xx}}{\tau_{xx}^2 + \tau_{xy}^2}$$

$$\Delta \rho(B) = \rho_{xx}(B) - \rho_{xx}(0) = \frac{\tau_{xx}}{\tau_{xx}^2 + \tau_{xy}^2} - \frac{1}{\tau_{xx}(0)}$$

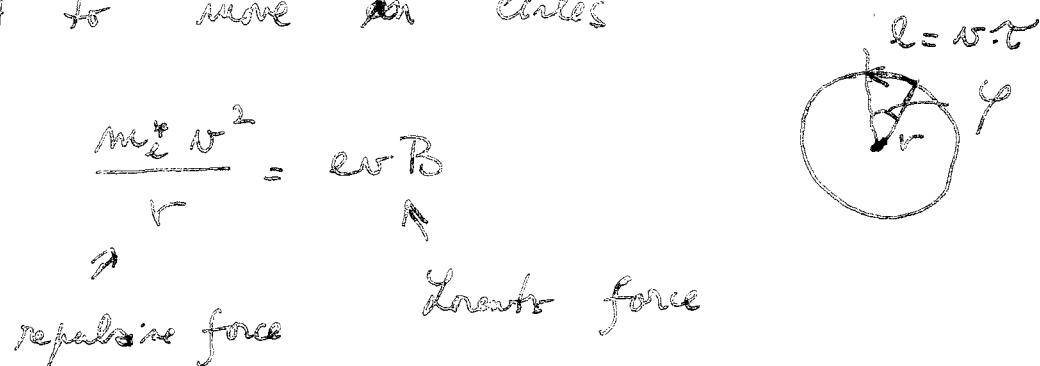
$$\tau_{xx} = \frac{e^2 n}{m_e^*} \left\langle \frac{v}{1+b^2} \right\rangle \quad \tau_{xy} = \frac{e^2 n}{m_e^*} \cdot \left\langle \frac{v_b}{1+b^2} \right\rangle$$

$$b = \frac{e}{m^*} v B = \\ = j v B$$

### Microscopic explanation

If magnetic field is applied perpendicular to the sample then electrons in the sample

start to move in circles



$\ell = v\tau$  mean free path

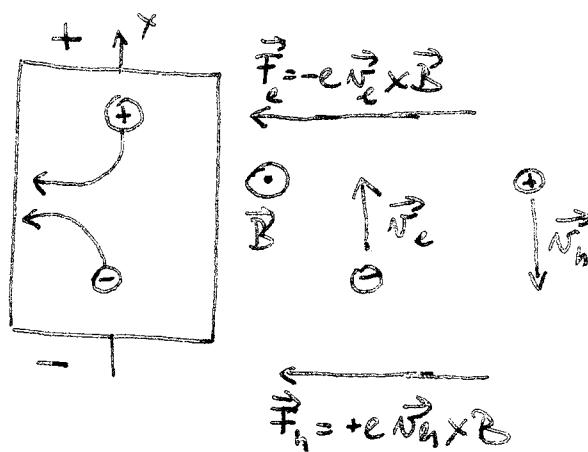
$$\tan \gamma \approx \gamma = \frac{\ell}{r} = \frac{v\tau \cdot eB}{m^* v} = \left(\frac{e}{m^*}\right) \cdot \frac{\tau}{v} \cdot B$$

$\gamma$  = „rotation angle“

the mobility  
of electrons

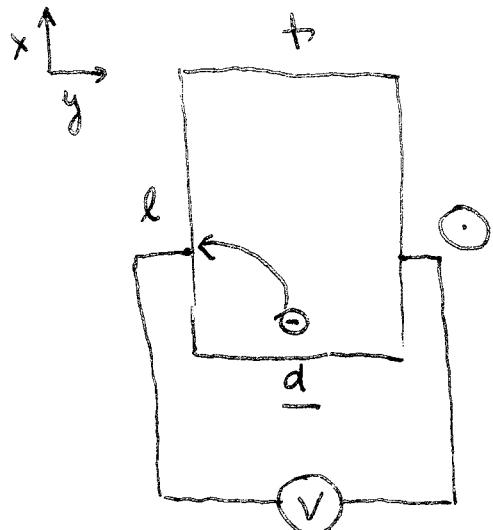
The angle  $\gamma$  does not depend on velocity, it depends only on the ratio  $\frac{\tau}{m^*}$

(analogically for holes)



The Lorentz force deflects both electrons and holes in the same direction, perpendicular to velocity and  $\vec{B}$

Let us now focus e.g. on N-type semiconductor  
(electrons are majority carriers)



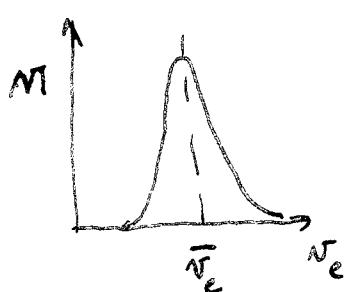
$$U_H = \frac{E_y}{d}$$

Electrons drifting from the cathode to the anode are deflected by the Lorentz force and accumulated on the left side of the sample  
⇒ transversal electric field  $E_y$  is formed (Hall voltage  $U_H$  can be measured)

The E-field  $E_y$  compensates the action of the Lorentz field, in this quasiequilibrium electrons with velocity  $\bar{v}_e$  are no more deflected and drift directly from the cathode to the anode

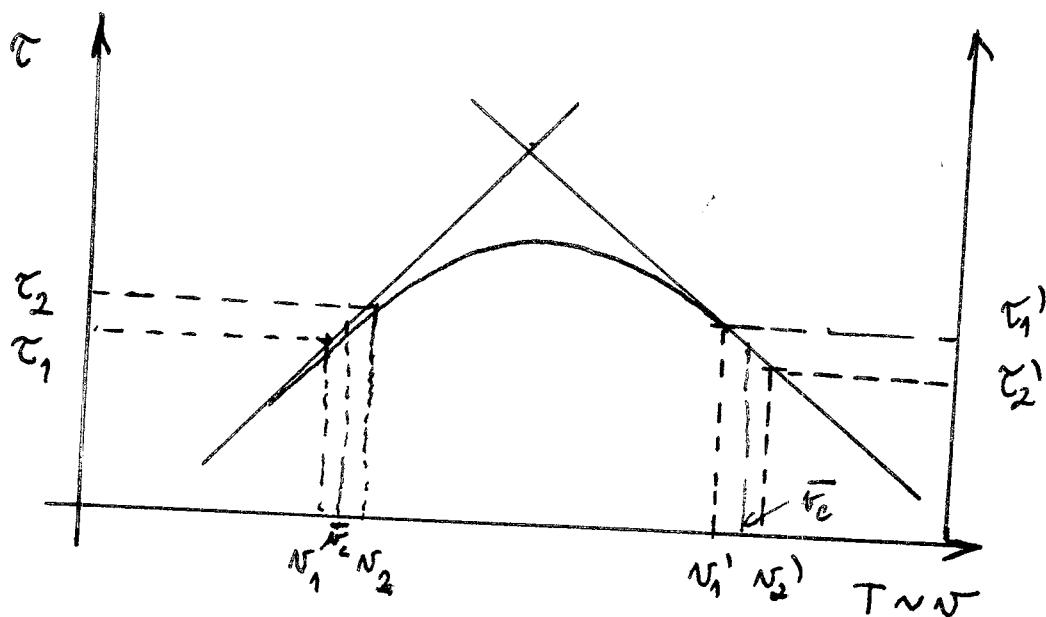
$$eE_y = e\bar{v}_e B \Rightarrow \bar{v}_e = \frac{E_y}{B}$$

However, the electrons in the material have a certain distribution of velocities

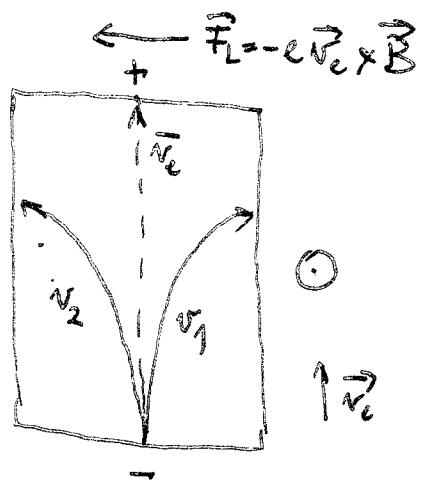


The previous equation holds only for electrons with velocity  $\bar{v}_e$ . Electrons with  $v_e < \bar{v}_e$  and  $v_e > \bar{v}_e$  are deflected to both sides.

Different velocities correspond to different relaxation times  $\tau$  (and different rotation angles  $\varphi$ ) in dependence of temperature.

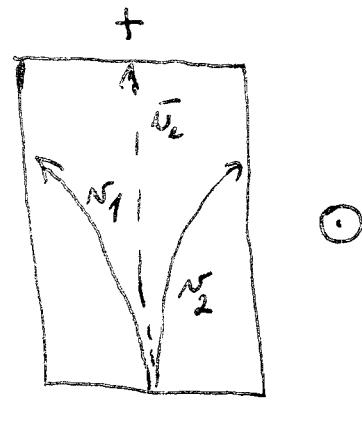


At low  $T$  (scattering on ionized impurities,  $v_2$  electrons (higher  $T$ ) have a larger  $\tau$  and larger  $\varphi$  than  $v_1$  electrons. The transversal Hall force ( $-eE_y$ ) compensates exactly action of the Lorentz force ( $-ev \cdot B$ ) for  $\bar{v}_e$  electrons with  $\varphi = \bar{\varphi}$  ( $\varphi = \bar{\varphi}$ ). Both  $v_2$  and  $v_1$  electrons are deflected from direct path (in the  $+x'$  direction).  $v_2$  electrons scatter less than  $\bar{v}_e$  electrons,  $\varphi_2 > \bar{\varphi}$ ,  $v_2$  electrons are deflected to the left.  $v_1$  electrons scatter more than  $\bar{v}_e$  electrons,  $\varphi_1 < \bar{\varphi}$ ,  $v_1$  el. are deflected to the right. At high  $T$  (scattering on phonons, the situation is reversed).



$$F_H = -eE_y$$

low T



high T

In both cases the paths of electrons with  $v \neq \bar{v}_e$  is longer than the path of  $\bar{v}_e$  electrons. This results in the higher resistivity in magnetic field

$$\rho(B) > \rho(0)$$

## The Hall effect

One of the most important transverse effects  
in the magnetic field

$$\vec{B} = (0, 0, B)$$

$$\vec{j} = (j_x, 0, 0)$$

$$\vec{V}_F T = (0, 0, 0)$$

$$\vec{E} = \tilde{\rho} \vec{j} \quad - E_x = \rho_{xx} j_x \text{ (standard resistivity in magnetic field)}$$

$$E_y = -\rho_{xy} j_x$$

The experimentally observed transverse electric field depends on the electric current flowing in the "x" direction and the magnetic field in "z" direction.

Experiment:  $E_y = R_H j_x B$

From our model is clear that

$$E_y = -\rho_{xy} j_x \Rightarrow R_H = -\frac{\rho_{xy}}{B}$$

After including the relations for  $\rho_{xy}$  we have

$$R_H = -\frac{\sigma_{xy}}{\sigma_{xx}^2 + \sigma_{xy}^2} \cdot \frac{1}{B} = -\frac{m^*}{e^2 n} \cdot \frac{1}{d} \cdot \frac{1}{B} \cdot \left\langle \frac{cb}{1+b^2} \right\rangle$$

$$D = \left\langle \frac{e}{1+b^2} \right\rangle + \left\langle \frac{eb}{1+b^2} \right\rangle$$

We can write  $R_H$  as

$$R_H = - \frac{v_H^{(e)}}{eM} \quad v_H^{(e)} = + \frac{1}{e} \cdot \frac{m_e^*}{D} \cdot \frac{1}{B} \cdot \left\langle \frac{eb}{1+b^2} \right\rangle$$

$v_H^{(e)}$  is called Hall scattering factor (for electrons)

$v_H^{(e)} \approx 1$  in many cases

Let us define the Hall mobility

$$\mu_H = v_H^{(e)} \cdot \mu_e = \frac{v_H}{eM} \cdot eM\mu = |R_H| \tau_e$$

$$E_y = R_H j_x \cdot B \Leftarrow \frac{U_H}{d} \Rightarrow U_H = R_H j_x B \cdot d = R_H \tau_e E_x \cdot B \cdot d =$$

$$= \mu_H \cdot \frac{U_x}{d} \cdot B \cdot d ; \quad R_H = \frac{U_H}{\tau_e E_x B \cdot d} = \frac{U_H d}{\tau_e U_x B \cdot d}$$

From the measured  $R_H$  we can calculate concentration of carriers

$$R_H = - \frac{v_H^{(e)}}{e \cdot M} \quad (\text{N-type}) \quad R_H = \frac{v_H^{(n)}}{eP}$$

$$M = - \frac{v_H^{(e)}}{e R_H} \quad P = \frac{v_H^{(n)}}{e R_H}$$

Hall effect for two types of carriers

$$R_H = -\frac{1}{B} \cdot \frac{\sigma_{xy}}{\sigma_{xx}^2 + \sigma_{xy}^2} \quad \dots \text{1 type}$$

$$R_H = -\frac{1}{B} \cdot \frac{\sigma_{xy}^{(1)} + \sigma_{xy}^{(2)}}{(\sigma_{xx}^{(1)} + \sigma_{xx}^{(2)})^2 + (\sigma_{xy}^{(1)} + \sigma_{xy}^{(2)})^2}$$

Let us use an abbreviation

$$R_1 = -\frac{1}{B} \cdot \frac{\sigma_{xy}^{(1)}}{(\sigma_{xx}^{(1)} + \sigma_{xy}^{(1)})^2} \quad R_2 = -\frac{1}{B} \cdot \frac{\sigma_{xy}^{(2)}}{(\sigma_{xy}^{(2)} + \sigma_{xx}^{(2)})^2}$$

$$\Gamma_1 = \frac{\sigma_{xx}^{(1)2} + \sigma_{xy}^{(1)2}}{\sigma_{xx}^{(1)}} \quad \Gamma_2 = \frac{\sigma_{xx}^{(2)2} + \sigma_{xy}^{(2)2}}{\sigma_{xx}^{(2)2}}$$



$$R = \frac{1}{D_0} [R_1 \Gamma_1^2 + R_2 \Gamma_2^2 + B^2 R_1 R_2 \Gamma_1^2 \Gamma_2^2 (R_1 + R_2)]$$

$$D_0 = (\Gamma_1 + \Gamma_2)^2 + B^2 \Gamma_1^2 \Gamma_2^2 (R_1 + R_2)^2$$

For weak  $B$  we can write

$$R = \frac{R_1 \Gamma_1^2 + R_2 \Gamma_2^2}{(\Gamma_1 + \Gamma_2)^2}$$

The above written equations are general,  
i.e. they are valid if the two types are

electrons and holes or e.g. two types of electrons with a different effective mass.

For the case of electrons and holes we can write

$$R_1 = R_e = -\frac{V_H^{(e)}}{m_e} \quad R_2 = R_h = \frac{V_H^{(h)}}{p_e}$$

$$\sigma_1 = m_e \mu_e \quad \sigma_2 = p_e \mu_h$$

$$R_H = \frac{-\frac{V_H^{(e)}}{m_e} m_e^2 \epsilon^2 \mu_e^2 + \frac{V_H^{(h)}}{p_e} \cdot p_e^2 \mu_h^2}{(\sigma_1 + \sigma_2)^2}$$

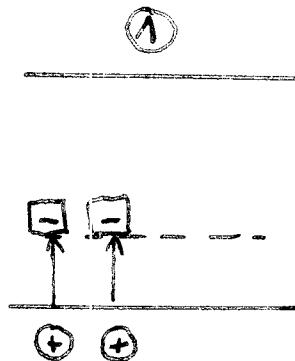
Assuming  $V_H^{(e)} \approx V_H^{(h)} = V_H$  we have

$$R_H = \frac{V_H}{\epsilon} \cdot \frac{p_e \mu_h^2 - m_e \mu_e^2}{(\sigma_1 + \sigma_2)^2}$$

$$R_H = 0 \quad \text{if} \quad m_e \mu_e^2 = p_e \mu_h^2$$

The mobility of electrons  $\mu_e$  is typically much higher than the mobility of holes  $\mu_h$ . if e.g.  $\mu_e = 10 \mu_h$ , then in p-type semiconductor at low T the conductivity is due to holes only

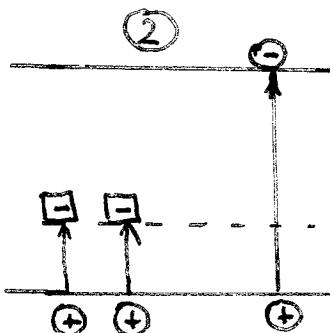
### P-type



low T

holes

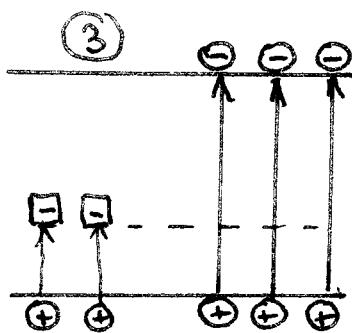
$$R_H > 0$$



higher T

holes + electrons

$$R_H \approx 0$$

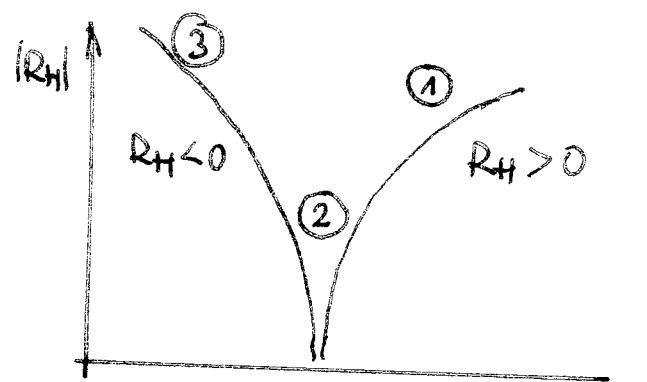


high T

$$n \propto p$$

$$R_H < 0$$

due to  $\mu_e > \mu_h$

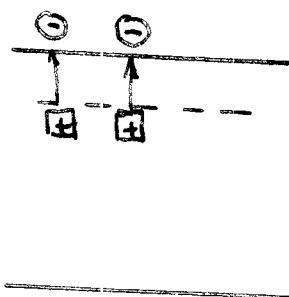


$$R_H = 0$$

$$m_e \mu_e^2 = p \mu_h^2$$

$$1/T$$

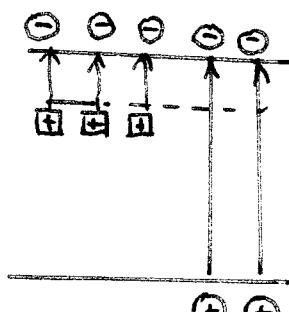
### N-type



low T

electrons from  
donors

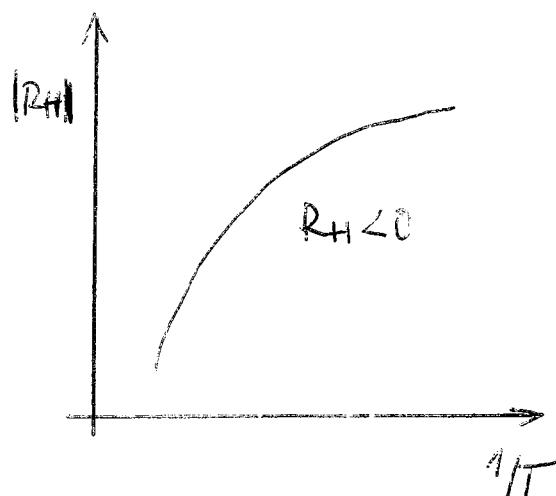
$$R_H < 0$$



electrons + holes  
but  $n \neq p$

$$\mu_e > \mu_h$$

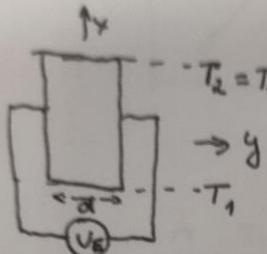
$$R_H < 0$$



$$1/T$$

## Nernst-Ettingshausen effect

Formation of electric field in the direction  $\perp y$  & perpendicular to temperature gradient  $\perp x$  and magnetic field  $B \perp z$

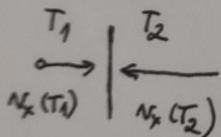


$$E_y = \frac{V_x}{d} = -QB_2 D_x T = -QB_2 \Delta T$$

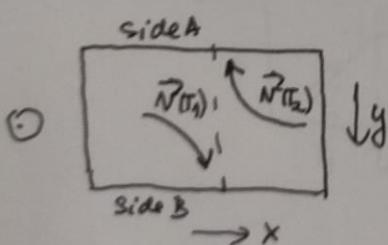
Nernst-Ettingshausen coefficient

### Qualitative explanation

In every layer of the sample  $\perp$  to  $\nabla T$  electrons move with thermal velocity in all directions



If on the left hand side of the thought boundary the temperature is smaller, the  $N_x(T_1)$  component is smaller than  $N_x(T_2)$ .

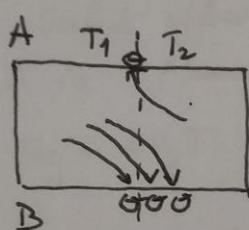
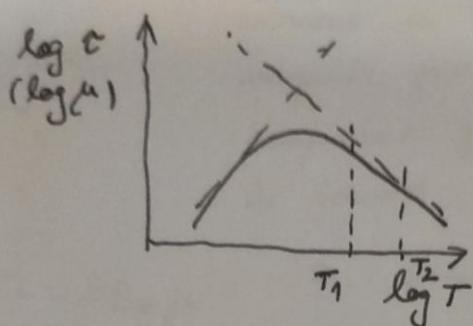


The  $\vec{v}(T_2)$  and  $\vec{v}(T_1)$  electrons just close to the boundary are deflected to opposite sides in the magnetic field.

Electric field in the  $y$  direction is formed, if the streams of  $\vec{v}(T_1)$  and  $\vec{v}(T_2)$  electrons are different. The sign of the transversal voltage and electric field depend on the temperature

dependence of the scattering mechanisms

CASE I



In this case

the  $N(T_2)$  electrons  
scatter more than  
 $N(T_1)$  electrons

$$\mu(T_2) < \mu(T_1)$$

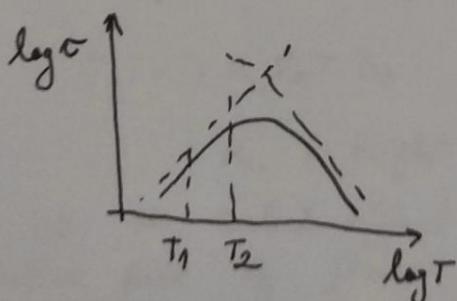
$$\tau(T_2) < \tau(T_1)$$

There are more  
electrons at side  $B$   
than at side  $A$

The direction of the  $E_y$

is A  
B

CASE II



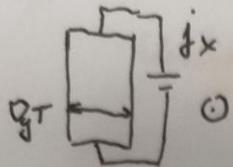
In this case the

$N(T_2)$  electrons  
scatter less than  
 $N(T_1)$  electrons.

The direction of  
 $E_y$  is A  
B

The sign of the effect is  
opposite

### Ettingshausen effect



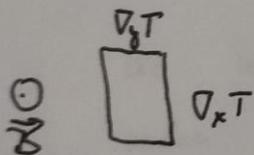
As a result of flow of electric current in the  $x$  direction when magnetic field  $B$  is in  $z$  direction, temperature gradient in  $y$  direction is formed

$$\nabla_y T = - \rho B_z j_x \quad \rho \dots \text{Ettingshausen coefficient}$$

Due to Seebeck effect this temperature gradient is transformed into electric field

$$E_y = \alpha \nabla_y T$$

### Righi - Lorentz effect



The temperature gradient in  $x$  direction in the magnetic field in  $z$  direction results in formation of temperature gradient in  $y$  direction.

$$\nabla_y T = - R_L \nabla_x T B_z$$

$$R_L \dots \text{Righi - Lorentz coefficient}$$

Due to the Seebeck effect is then a transverse electric field  $E_y$  formed

$$E_y = \alpha \nabla_y T$$

Electrons and holes out of equilibrium

$n_0, p_0$  .. equilibrium concentrations

$\Delta n, \Delta p$  .. deviation from equilibrium

$$\Delta n = n - n_0 \quad \Delta p = p - p_0 \quad \Delta n = \Delta p$$

Let  $g_0$  be a measure of the thermal generation of electron-hole pairs, which is always present

We will further examine the situation when after finishing of the excitation the system comes back to equilibrium.

We will use continuity equation for electrons

$$\frac{\partial n}{\partial t} = G - R + \frac{1}{e} \operatorname{div} \vec{j}_e = G - R - \operatorname{div} \vec{J}_e$$

$G$  ... generation of electrons

$R$  ... recombination of electrons

$G_0$  ... thermal generation of electrons

$$\text{In equilibrium } G_0 = R_0$$

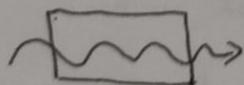
Let us assume, that electrons are generated by emission from the valence band only (we will not include emission from donors in this case). Therefore also recombination occurs by interaction with holes from the valence band.

$$\text{In equilibrium } G_0 = R_0 = r N_0 \cdot p_0$$

$r$  ... recombination coefficient

After switching-off the excitation  $G = G_0$

$$\frac{\partial n}{\partial t} = G_0 - R + \frac{1}{e} \operatorname{div} \vec{j}_e \quad R = r n p = \\ = r (N_0 + \Delta N) (p_0 + \Delta p)$$



Let us assume, that the sample is homogeneously illuminated which results in the deviation from equilibrium.

$$\Delta N = \Delta p \\ (\text{generation and rec. over the bandgap})$$

Due to homogeneous illumination  $\text{div} \vec{e} = 0$

$$\Rightarrow -\frac{d\Delta n}{dt} = R - G_0 = n_{mp} - n_{mop} = \\ = n(n_0 + \Delta n)(p_0 + \Delta p) - n_{mop}p_0 = \\ = n[n_{mop} + n_0 \Delta p + p_0 \Delta n + \Delta n \Delta p - n_{mop}]$$

Let us suppose we have e.g. p-type semiconductor, i.e.  $p_0 \gg n_0$

$\Delta n = \Delta p$  (small - small deviation from equilibrium)

$$\Rightarrow p_0 \Delta n \gg n_0 \Delta p \quad R \Delta n \gg \Delta n \Delta p$$

$$\Rightarrow -\frac{d\Delta n}{dt} = n p_0 \Delta n \quad -\frac{d\Delta n}{\Delta n} = n p_0 dt$$

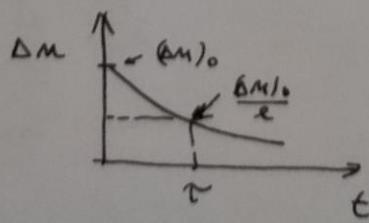
$$\frac{d\Delta n}{\Delta n} = -n p_0 dt = -\frac{dt}{\tau}$$

$$\Rightarrow \ln \Delta n = -\frac{t}{\tau} + C$$

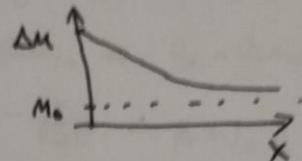
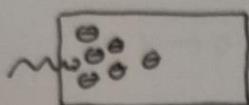
$$t=0 \quad \Delta n = (\Delta n)_0 \Rightarrow C = \ln (\Delta n)_0$$

$$\Rightarrow (\Delta n)_t = (\Delta n)_0 e^{-\frac{t}{\tau}}$$

$\sim \dots$  lifetime of minority electrons



In the next example we will examine stationary distribution of carriers when the sample is uniformly illuminated



The continuity equation

$$\frac{\partial n}{\partial t} = G - R + \frac{1}{e} \operatorname{div} \vec{j}_e \quad R = R_0 + R^1 \\ R_0 = G_0$$

$$\frac{\partial n}{\partial t} = n_{n_0} p_0 - n_{n_0} p_0 - R^1 + \frac{1}{e} \operatorname{div} \vec{j}_e$$

$$R^1 = n p_0 \Delta n = \frac{\Delta n}{\tau} \quad (\text{for the case of P-type SC - previous case})$$

$$\Rightarrow \frac{\partial n}{\partial t} = - \frac{\Delta n}{\tau} + \frac{1}{e} \operatorname{div} \vec{j}_e \rightarrow \frac{\partial n}{\partial t} = - \frac{\Delta n}{\tau} + \frac{1}{e} \cdot \frac{\partial j_e}{\partial x}$$

$$\frac{\partial n}{\partial t} = 0 \quad \text{in stationary case}$$

$$\Rightarrow \frac{\Delta n}{\tau} = \frac{1}{e} \cdot \frac{\partial j_e}{\partial x} \quad j_e = e D_e \cdot \frac{\partial n}{\partial x}$$

$$\Rightarrow \frac{\Delta n}{\tau} = D_e \cdot \frac{\partial^2 n}{\partial x^2} \quad (\text{diffusion current})$$

no drift current  
because there is  
no external el. field.

Diffusion equation

The solution of the equation is

$$\Delta N = C_1 e^{\frac{x}{L_D \tau}} + C_2 e^{-\frac{x}{L_D \tau}}$$

$$x \rightarrow \infty \quad \Delta N \rightarrow 0 \Rightarrow C_1 = 0$$

$$x \rightarrow 0 \quad \Delta N = (\Delta N)_0 \Rightarrow C_2 = (\Delta N)_0$$

$$\Delta N = (\Delta N)_0 e^{-\frac{x}{L_D \tau}} = (\Delta N)_0 e^{-\frac{x}{L_D}}$$

$L_D = \sqrt{L_D \tau}$  - Diffusion length of minority carriers (electrons in this case)

Diffusion length --- distance at which the carrier concentration difference  $\Delta N$  drops to  $1/e$  of its value at  $x=0$

Here we also introduce the drift length  
→ if the carriers drift in the external electric field  $\vec{E}$  the more with velocity  
 $\vec{v}_D = \mu_e \vec{E} \Rightarrow v_D = \frac{l}{t}$

$$\text{at } t = \tau \quad l = v_D \cdot \tau \quad \text{--- drift length}$$

### Poisson equation

If in the material exists uncompensated electric charge (e.g. space charge in p-n junctions or at metal / semiconductor interfaces), the solution of drift-diffusion equation must be coupled with Poisson equation.  $\operatorname{div} \vec{E} = \frac{\rho}{\epsilon_0} \quad \vec{E} = -\nabla \varphi^+$   
 $\operatorname{div} \nabla \varphi^+ = \Delta \varphi^+ = -\frac{\rho}{\epsilon_0}$

The solution of the equation is

$$\Delta N = C_1 e^{\frac{x}{D_{\text{eff}} t}} + C_2 e^{-\frac{x}{D_{\text{eff}} t}}$$

$$x \rightarrow \infty \quad \Delta N \rightarrow 0 \Rightarrow C_1 = 0$$

$$x \rightarrow 0 \quad \Delta N = (\Delta N)_0 \Rightarrow C_2 = (\Delta N)_0$$

$$\Delta N = (\Delta N)_0 e^{-\frac{x}{D_{\text{eff}} t}} = (\Delta N)_0 e^{-\frac{x}{L_e}}$$

$L_e = \sqrt{D_{\text{eff}} t}$  - Diffusion length of minority carriers (electrons in this case)

Diffusion length --- distance at which the carrier concentration difference  $\Delta N$  drops to  $1/e$  of its value at  $x=0$

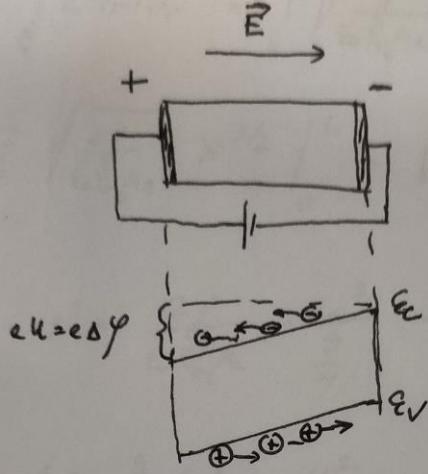
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→ if the carriers drift in the external electric field  $\vec{E}$  the more with velocity  
 $v_D = \mu_e E \Rightarrow v_D = \frac{l}{t}$

$$\text{at } t = \tau \quad l = v_D \cdot \tau \quad \text{--- drift length}$$

### Poisson equation

If in the material exists uncompensated electric charge (e.g. space charge in p-n junctions or at metal / semiconductor interfaces), the solution of drift-diffusion equation must be coupled with Poisson equation.  $\operatorname{div} \vec{E} = \frac{\rho}{\epsilon_0} \quad \vec{E} = -\nabla \varphi^+$   
 $\operatorname{div} \nabla \varphi^+ = \Delta \varphi^+ = -\frac{\rho}{\epsilon_0}$

Drift of carriers in a homogeneous semiconductor



Electric current in semiconductor when space charge is present

$$\Delta \varphi^* = -\frac{P}{\epsilon_0 \epsilon_r} \quad E_x^* = -\frac{d\varphi^*}{dx} \quad -\frac{dE_x^*}{dx} = \frac{d^2\varphi^*}{dx^2}$$

$$\Rightarrow \frac{dE^*}{dx} = \frac{P}{\epsilon_0 \epsilon_r} \quad J = P \cdot \vec{v} \quad \vec{n} = \mu \cdot \vec{E}^* \\ J_x = P N_x \quad N_x = \mu E_x^*$$

$$\frac{dE_x^*}{dx} = \frac{j_x}{\epsilon_0 \epsilon_r \mu_e E_x^*} \quad E_x^* dE_x^* = \frac{j_x}{\epsilon_0 \epsilon_r \mu_e} dx$$

$$\frac{E_x^{*2}}{2} = \frac{j_x}{\epsilon_0 \epsilon_r \mu_e} \cdot x$$

$$E_x^* = \sqrt{\frac{2j_x}{\epsilon_0 \epsilon_r \mu_e}} \times 1/2$$

$$U = \int_0^L E^*(x) dx = \int_0^L \sqrt{\frac{2j}{\epsilon_0 \epsilon_r \mu_0}} \times 1/2 dx =$$

$$= \frac{2}{3} \sqrt{\frac{2j}{\epsilon_0 \epsilon_r \mu_0}} \times \frac{1}{2} L = \sqrt{\frac{2j}{\epsilon_0 \epsilon_r \mu_0}} \cdot \frac{L^{3/2}}{\frac{3}{2}}$$

$$\Rightarrow U^2 = \frac{2j}{\epsilon_0 \epsilon_r \mu_0} \cdot \frac{L^3}{\frac{9}{4}} = \frac{8}{9} \cdot \frac{j}{\epsilon_0 \epsilon_r \mu_0} L^3$$

$$j = \frac{9}{8} \epsilon_0 \epsilon_r \mu_0 \frac{U^2}{L^3} \quad (\text{Hart - Guernay law})$$

Electric current in vacuum

The potential energy of the electron  
 $-e\gamma^*(x)$  changes into the kinetic energy  
 of the accelerated electron

$$e\gamma^* = \frac{1}{2} mv^2 \quad \frac{dE^*}{dx} = \frac{q}{\epsilon_0 \epsilon_r} \quad E^* = -\frac{d\gamma^*}{dx}$$

$$v = \sqrt{\frac{2e\gamma^*}{m\epsilon_0}} \quad \rho = \frac{j}{v} = j \cdot \sqrt{\frac{m}{2e\gamma^*}} \quad \frac{d^2\gamma^*}{dx^2} =$$

$$\frac{dE^*}{dx} = \frac{dE^*}{d\varphi^*} \cdot \frac{d\varphi^*}{dx} = \frac{j}{\epsilon_0} = \frac{j}{\epsilon_0} \sqrt{\frac{m}{2e\varphi}}$$

$$E^* = - \frac{d\varphi^*}{dx}$$

$$-E^* dE^* = \frac{\partial E^*}{\partial x} d\varphi^* = \frac{j}{\epsilon_0} \cdot \sqrt{\frac{m}{2e\varphi}} d\varphi^*$$

$$-\frac{E^{*2}}{2} = \frac{j}{\epsilon_0} \cdot 2\sqrt{\frac{m}{2e}} \cdot \varphi^{*1/2}$$

$$E^{*2} = - \frac{j}{\epsilon_0} 4\sqrt{\frac{m}{2e\varphi^*}}$$

$$E^* = -2\sqrt{\frac{j}{\epsilon_0} \sqrt{\frac{m}{2e\varphi^*}}} = -2\sqrt{\frac{j}{\epsilon_0} \sqrt{\frac{m}{2e}}} \varphi^{*1/4}$$

$$E^* = -\alpha \varphi^{*1/4} \quad \alpha = 2\sqrt{\frac{j}{\epsilon_0} \sqrt{\frac{m}{2e}}}$$

$$E^* = -\frac{d\varphi^*}{dx} = -\alpha \varphi^{*1/4}$$

$$\alpha dx = \varphi^{-1/4} d\varphi$$

$$\alpha x |_0^L = \frac{4}{3} \varphi^{*3/4}$$

$$\alpha L = \frac{4}{3} \varphi^{*3/4} \quad \varphi \rightarrow u$$

$$\alpha L = \frac{4}{3} u^{3/4} \quad \alpha^2 L^2 = \frac{16}{9} u^{3/2}$$

$$\frac{4j}{\epsilon_0} \sqrt{\frac{m}{2e}} L^2 = \frac{16}{9} u^{3/2}$$

$$j = \frac{4}{9} \cdot \epsilon_0 \cdot \sqrt{\frac{2e}{m}} \cdot \frac{u^{3/2}}{L^2}$$

## Ambipolar mobility and diffusion constant

When describing the deviation from equilibrium we assumed so far, that the semiconductor is a clear n-type or p-type. Then it is possible to include only excess minority electrons in p-type ( $\Delta n$ ) or excess holes in N-type ( $\Delta p$ ). In case, that both  $\Delta n$  and  $\Delta p$  are present (i.e.  $\Delta n \gg \rho_0$  and at the same time  $\Delta p \gg n_0$ );  $\Delta n$  and  $\Delta p$  can mutually influence - the transport is in this situation described as "ambipolar".

$$\vec{j}_e = e \mu_e \vec{E} + e D_{ee} \nabla n$$

$$\vec{j}_h = e \mu_h \vec{E} - e D_{hh} \nabla p$$

Drift-diffusion  
equation

$$\frac{\partial n}{\partial t} = G - R + \frac{1}{e} \operatorname{div} \vec{j}_e$$

Continuity equation

$$\frac{\partial p}{\partial t} = G - R - \frac{1}{e} \operatorname{div} \vec{j}_h$$

$$\frac{\partial n}{\partial t} = G - R + \mu_e \operatorname{div}(n \vec{E}) + e D_{ee} \operatorname{div} D_{ee} n$$

$$\frac{\partial p}{\partial t} = G - R - \mu_h \operatorname{div}(p \vec{E}) + D_{hh} \operatorname{div} D_{hh} p$$

$$M = M_0 + \Delta M$$

$$P = P_0 + \Delta P$$

$$\Delta M = \Delta P$$

$$\frac{\partial M_0}{\partial t} = \frac{\partial P_0}{\partial t} = 0 \quad \text{grad}_P M_0 = \text{grad}_P P_0 = 0$$

$$\frac{\partial M}{\partial t} = G - R + \mu_e \vec{E} \cdot \text{grad}_P (\Delta M) + \mu_m \text{div} \vec{E} + D_e \Delta(\Delta M)$$

$$\frac{\partial P}{\partial t} = G - R - \mu_m \vec{E} \cdot \text{grad}_P (\Delta P) - \mu_m P \text{div} \vec{E} + D_p \Delta(\Delta P)$$

$$\text{div} \vec{E} = \frac{1}{\mu_e M} \left( \frac{\partial \Delta M}{\partial t} - G + R + \mu_e \vec{E} \cdot \text{grad}_P (\Delta M) + D_e \Delta(\Delta M) \right) \quad (1)$$

$$\text{div} \vec{E} = - \frac{1}{\mu_m P} \left( \frac{\partial \Delta P}{\partial t} - G + R + \mu_m \vec{E} \cdot \text{grad}_P (\Delta P) - D_p \Delta(\Delta P) \right) \quad (2)$$

$$(1) - (2)$$

$$0 = \frac{\partial \Delta M}{\partial t} \left( \frac{1}{\mu_e M} + \frac{1}{P \mu_m} \right) + (G - R) \left( \frac{1}{\mu_e M} + \frac{1}{P \mu_m} \right) - \frac{1}{\mu_e} \vec{E} \cdot \text{grad}_P (\Delta M) + \\ + \frac{1}{P} (\vec{E} \cdot \text{grad}_P (\Delta P)) - \frac{D_e}{\mu_e M} \Delta(\Delta M) - \frac{D_p}{P \mu_m} \Delta(\Delta P)$$

$$\frac{\partial \Delta M}{\partial t} = \frac{1}{\left( \frac{1}{\mu_e M} + \frac{1}{P \mu_m} \right)} \left[ (G - R) \left( \frac{1}{\mu_e M} + \frac{1}{P \mu_m} \right) + \left( \frac{1}{\mu_e} - \frac{1}{P} \right) \vec{E} \cdot \text{grad}_P (\Delta M) + \right. \\ \left. + \frac{D_e}{\mu_e M} \Delta(\Delta M) + \frac{D_p}{P \mu_m} \Delta(\Delta P) \right]$$

$$\frac{\partial \Delta M}{\partial t} = G - R + \frac{(P - \mu_e) \mu_m \mu_R}{\mu_e M + P \mu_m} \vec{E} \cdot \text{grad}_P (\Delta M) +$$

$$+ \frac{D_e P \mu_R + \Delta M \mu_m}{\mu_e M + P \mu_m} \Delta(\Delta M)$$

$$\frac{\partial \Delta n}{\partial t} = G - R + (\mu^* \vec{E} \cdot \vec{\text{grad}} \varphi) (\Delta n) + D^* \Delta (\Delta n)$$

Laplace operator

$$\mu^* = \frac{(P-N)\mu_e \mu_h}{M\mu_e + P\mu_h} = \frac{P-N}{\frac{P}{M_e} + \frac{N}{\mu_h}}$$

Ambipolar mobility

$$D^* = \frac{P+N}{\frac{P}{D_e} + \frac{N}{D_h}} \quad \begin{matrix} \text{ambipolar diffusion} \\ \text{constant} \end{matrix}$$

$$\text{For } P=N \quad \mu^* = 0$$

(a group of excess carriers  $\Delta n = \Delta p$  does not move in an electric field - only diffusion takes place  $\Rightarrow$  the shape of the group packet is changing.)

$$\text{Strong N-type} \quad \mu^* = \frac{-N}{\frac{N}{M_h}} = -\mu_h \quad D^* = D_h$$

$$\text{Strong P-type} \quad \mu^* = \mu_e \quad D^* = D_e$$

## Ambipolar mobility and diffusion constant

When describing the deviation from equilibrium we assumed so far, that a semiconductor is a clear N-type or clear P-type. Then it is possible to study only excess minority carriers ( $\Delta n$  in P-type,  $\Delta p$  in N-type). The excess of majority carriers is in this case negligible compared to their equilibrium values ( $\Delta n \ll n_0$  in N-type,  $\Delta p \ll p_0$  in P-type). In case, that the excess values  $\Delta n, \Delta p$  are higher or if  $\Delta n \gtrsim n_0$  in N-type or  $\Delta p \gtrsim p_0$  in P-type), we have to include both excesses  $\Delta n, \Delta p$  in the calculation and take into account, that both charge clouds influence each other. The transport is in this situation described as ambipolar.

$$\vec{j}_e = e n_e \mu_e \vec{E} + e D_e \nabla n_e \quad \text{Drift-diffusion equation}$$

$$\vec{j}_h = e p_h \mu_h \vec{E} - e D_h \nabla p_h$$

$$\frac{\partial n}{\partial t} = G - R + \frac{1}{e} \operatorname{div} \vec{j}_e \quad \text{Continuity equation}$$

$$\frac{\partial p}{\partial t} = G - R - \frac{1}{e} \operatorname{div} \vec{j}_h$$

$$\frac{\partial n}{\partial t} = G - R + \mu_e e \operatorname{div}(n \vec{E}) + D_e \operatorname{div} \nabla^2 n$$

$$\frac{\partial p}{\partial t} = G - R - \mu_h e \operatorname{div}(p \vec{E}) + D_h \operatorname{div} \nabla^2 p$$

$$M = M_0 + \delta M \quad P = P_0 + \delta P \quad \delta n = \delta p$$

$$\frac{\partial M_0}{\partial t} = \frac{\partial P_0}{\partial t} = 0 \quad \text{grad}_P M_0 = \text{grad}_P P_0 = 0 \\ (\text{homogeneous semiconductor})$$

$$\frac{\partial M}{\partial t} = G - R + M_e \vec{E} \cdot \text{grad}_P (\delta n) + \mu_n n \text{div} \vec{E} + D_e \Delta (\delta n)$$

$$\frac{\partial P}{\partial t} = G - R - M_h \vec{E} \cdot \text{grad}_P (\delta p) - \mu_h p \text{div} \vec{E} + D_h \Delta (\delta p)$$

$$\text{div} \vec{E} = \frac{1}{\mu_e M} \left( \frac{\partial \delta n}{\partial t} - G + R + M_e \vec{E} \cdot \text{grad}_P \delta n + D_e \Delta (\delta n) \right) \quad (1)$$

$$\text{div} \vec{E} = -\frac{1}{\mu_h P} \left( \frac{\partial \delta p}{\partial t} - G + R + M_h \vec{E} \cdot \text{grad}_P \delta p - D_h \Delta (\delta p) \right) \quad (2)$$

$$(1) - (2) \Rightarrow$$

$$0 = \frac{\partial \delta n}{\partial t} \left( \frac{1}{\mu_e \mu_h} + \frac{1}{P \mu_h} \right) + (R - G) \left( \frac{1}{\mu_e \mu_h} + \frac{1}{P \mu_h} \right) - \frac{1}{\mu} \vec{E} \cdot \text{grad}_P (\delta n) +$$

$$+ \frac{1}{P} (E \cdot \nabla_P (\delta n) - \frac{D_e}{\mu_e} \Delta (\delta n) - \frac{D_h}{\mu_h} \Delta (\delta p))$$

$$\frac{\partial \delta n}{\partial t} = \frac{1}{\left( \frac{1}{\mu_e \mu_h} + \frac{1}{P \mu_h} \right)} \left[ G - R \left( \frac{1}{\mu_e \mu_h} + \frac{1}{P \mu_h} \right) + \left( \frac{1}{\mu} - \frac{1}{P} \right) \vec{E} \cdot \text{grad}_P (\delta n) + \right.$$

$$+ \frac{D_e}{\mu_e} \Delta (\delta n) + \frac{D_h}{\mu_h} \Delta (\delta p) \left. \right]$$

$$\frac{\partial \delta n}{\partial t} = G - R + \frac{(P - \mu) \mu_e \mu_h}{\mu_e + P \mu_h} \vec{E} \cdot \nabla_P (\delta n) +$$

$$+ \frac{D_e P \mu_h + D_h P \mu_e}{\mu_e + P \mu_h} \Delta (\delta n)$$

$$\frac{\partial \Delta n}{\partial t} = G - R + \mu^* \vec{E} \cdot \text{grad}_r(\Delta n) + D^* \Delta (\Delta n)$$

$$\mu^* = \frac{(P-n) \mu_e \mu_h}{n \mu_e + P \mu_h} = \frac{P-n}{\frac{P}{\mu_e} + \frac{n}{\mu_h}}$$

↑  
ambipolar mobility

$$D^* = \frac{P+n}{\frac{P}{D_e} + \frac{n}{D_h}} \quad \begin{matrix} \text{ambipolar diffusion} \\ \text{constant} \end{matrix}$$

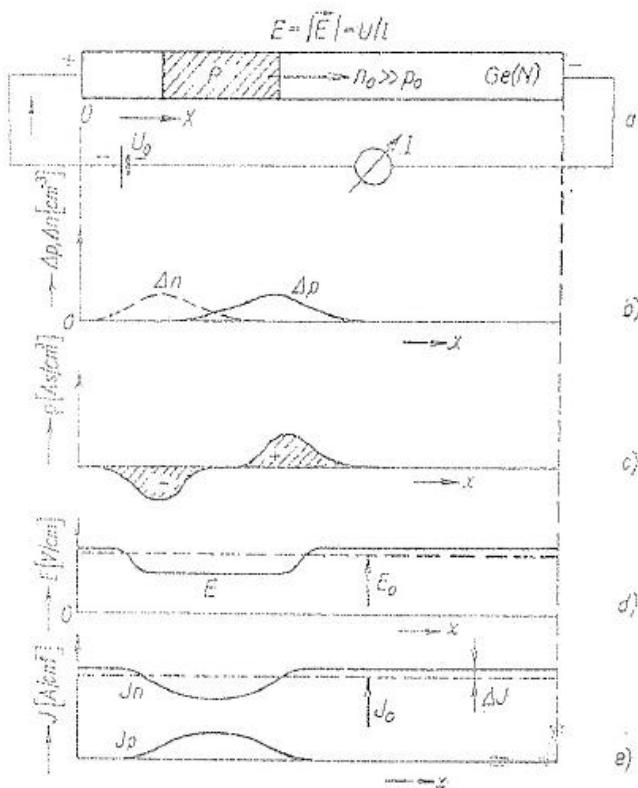
$$\text{For } P=n \quad \mu^* = 0$$

(group of excess carriers  $\Delta n = \Delta P$  does not move in an electric field; only diffusion takes place; the shape of the group need not change)

$$\text{Strong N-type} \quad \mu^* = -\frac{n}{m} = -\mu_A \quad D^* = D_h$$

$$\text{Strong P-type} \quad \mu^* = \mu_e \quad D^* = D_e$$

## Movement of injected group of minority carriers



Sample with the applied voltage

local distribution of excess carriers

distribution of space charge

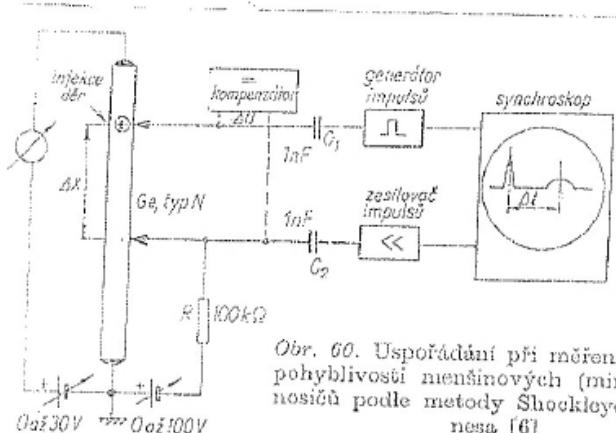
profile of electric field

density of flow of electrons and holes

In the electric field the groups of excess electrons and holes spatially separate.

Then an additional electric field between them is formed against the direction of the external field  $E_0$ . The electric field between  $\Delta n$  and  $\Delta p$  is smaller than  $E_0$ , outside it is slightly higher. The average internal field must equal  $E_0$ .

## Shockley - Haynes experiment



Obr. 60. Uspořádání při měření driftové pohyblivosti menšinových (minoritních) nосíčů podle metody Shockleye a Haynesa [6].

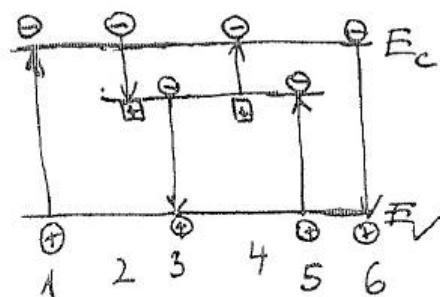
$$\vec{N} = \mu^* / E_0 = \frac{\Delta x}{t} = \mu^* \frac{\Delta u}{\Delta x}$$

$$\Rightarrow \mu^* = \frac{(\Delta x)^2}{\Delta u \cdot t}$$

## Influence of trapping and recombination centers on charge transport

When deriving equations for diffusion length and lifetime of minority carriers we assumed so far, that free electrons in conduction band recombine with free holes in the valence band. Therefore, we did not account for influence of energy levels in the bandgap.

The influence of energy levels on transport of charge can be described by the so called Shockley - Read - Hall model.

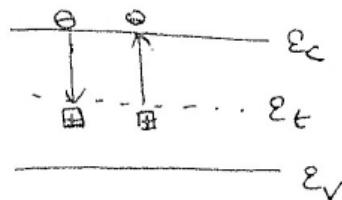


Each energy level can interact with the carriers in conduction and valence bands by a series of processes. All processes including interband one:

- 1) Interband generation
- 2) Trapping of electrons on level
- 3) Trapping of hole on the level
- 4) Emission of electron from the level
- 5) Emission of hole from the level
- 6) Interband recombination

Each level can be characterized by the following parameters

$\tau_e$	capture cross section for electrons	$[cm^2]$
$\tau_h$	capture-cross section for holes	$[cm^2]$
$E_t$	energy of the level	$[eV]$
$N_t$	concentration of the level	$[cm^{-3}]$
$n_t$	concentration of electrons on the level (occupied states)	$[cm^{-3}]$
$N_t - n_t$	concentration of unoccupied states on the level	$[cm^{-3}]$
$\gamma_e$	trapping coefficient for electrons $(\gamma_e = \tau_e \cdot N_{th}^e)$	$[cm^3/s]$
$\gamma_h$	trapping coefficient for holes $(\gamma_h = \tau_h \cdot N_{th}^h)$	$[cm^3/s]$
	$v_{th}^h$ ... thermal velocity, holes	



Trapping of electrons on the level

$$\frac{dn}{dt} = \gamma_e \cdot m (N_t - n_t) \quad \text{in equilibrium}$$

$$\text{Emission of electrons} \quad m = M_0 \quad n_t = n_{t0}$$

$$\frac{dn_t}{dt} = \alpha n_t \quad \alpha \dots \text{Some coefficient we will try to calculate}$$

Let us suppose that there is thermodynamic equilibrium

$n_0$  ... equilibrium concentration of electrons in the conduction band

$n_{t0}$  equilibrium concentration of electrons on the level

$$\frac{dn_0}{dt} = \underbrace{\alpha_e \cdot n_{t0}}_{\uparrow} - \underbrace{\beta e^{n_0} (N_t - n_{t0})}_{\uparrow}$$

Probability of emission of electron from the center to the conduction band

Probability of trapping of an electron on the level in the bandgap

$$\frac{dn_0}{dt} = 0 \quad \text{in equilibrium}$$

$$\Rightarrow n_{t0} = \frac{N_t}{\frac{\alpha_e}{\beta e^{n_0}} + 1}$$

$$\text{at the same time } n_{t0} = N_t \cdot f_0$$

$$f_0 = \frac{1}{1 + e^{\frac{E_F - E}{kT}}} = \frac{1}{1 + e^{-\gamma}}$$

$$n_0 \approx N_c e^\gamma = N_c e^{\frac{E_F}{kT}}$$

$$\Rightarrow \frac{\alpha_e}{j_e M_0} = e \frac{E_F - E_F}{kT} \quad (E = E_F \text{ in our case})$$

$$\Rightarrow \alpha_e = j_e M_0 e \frac{E_F - E_F}{kT} \quad N_c = M_0 e^{-\frac{E_F}{kT}}$$

$$\Rightarrow \alpha_e = j_e N_c e^{\frac{E_F}{kT}} ; \quad \alpha_e = j_e \cdot N_c$$

$$N_c = N_c e^{\frac{E_F}{kT}} \quad \dots \text{concentration of electrons for the case } E_F = E_F$$

By a similar way we achieve

$$\alpha_h = j_h \cdot P_1$$

$P_1$  ... concentration of holes for the case

$$E_F = E_F$$

$N_t - N_F$  ... concentration of trapped holes

$$\frac{du}{dt} = G + j_e \cdot N_F \cdot N_t - j_e n (N_t - N_F)$$

↑

Electrons emitted  
from the level  
to the CB

↑

Electrons trapped  
on the level -  
transition from  
CB to the level

$$\frac{dp}{dt} = \textcircled{5} + \beta_h (N_t - n_t) \cdot p_1 - \beta_a p \cdot n_t$$

↑

transition of electron  
from valence band  
to the level (free hole  
generation)

↑

Transition of  
electron from the  
level to the valence  
band = trapping  
of hole

$$\frac{dn_t}{dt} = \beta_a n (N_t - n_t) - \beta_e n_t n_g + \beta_a (N_t - n_t) p_g - \beta_a p \cdot n_t$$

$\tau_e = \tau_{eh}$  ... recombination center

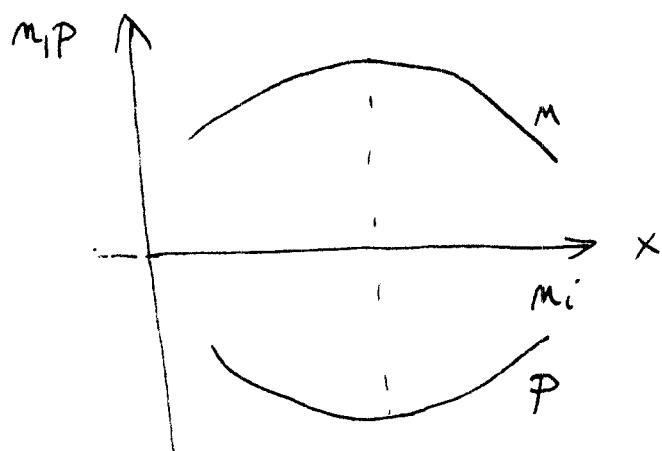
$\tau_e > \tau_h$  ... electron trap

$\tau_e < \tau_h$  ... hole trap



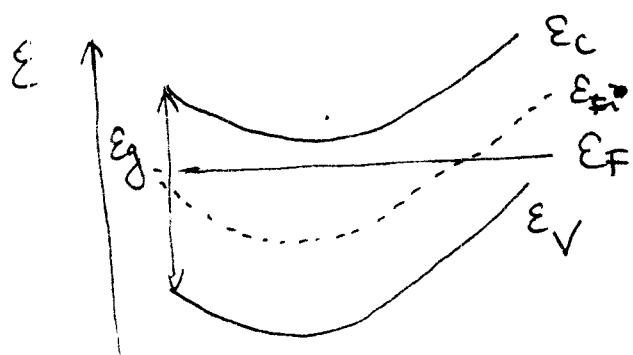
## Inhomogeneous semiconductors

In the next part we will discuss theoretical description of inhomogeneous semiconductors, where the inhomogeneity is caused by change of doping in the SC volume, that results in variation of concentration of free electrons and holes with a spatial coordinate



We assume an N-type semiconductor here

$$n.p = n_i^2$$



$E_{Fi}$  ... intrinsic

Fermi level defined  
by equation

$$n_i = N_c e^{-\frac{E_{Fi}}{kT}}$$

$n_i$  ... intrinsic  
concentration

In equilibrium is the Fermi level  $E_F$  independent of  $x$ . The spatial variation of  $n$  and  $p$  is reflected in spatial dependence of the bands  $\epsilon_c(x)$ ,  $\epsilon_v(x)$  and also  $E_{Fi}(x)$ .

We introduce the difference  $E_F - E_{Fi}(x)$  as the measure of spatial inhomogeneity.

We can write

$$M(x) = N_c e^{-\frac{E_F}{kT}} \quad m_i = N_c e^{-\frac{E_{F_i}}{kT}} \Rightarrow N_c = M_i e^{-\frac{E_{F_i}(x)}{kT}}$$

then  $m = m_i e^{-\frac{E_F - E_{F_i}}{kT}}$

$$\ln \frac{m}{m_i} = \ln \bar{m} = \frac{E_F - E_{F_i}(x)}{kT} =$$

$$= \Psi = \frac{eV}{kT}$$

$$\Rightarrow V = \frac{kT}{e} \cdot \Psi \quad \Psi \text{ is the so called reduced potential}$$

$$m_p = m_i^2 \Rightarrow \frac{m}{m_i} = \frac{m_i}{P} ; \ln \frac{m}{m_i} = -\ln \frac{P}{m_i} = -\ln \bar{P}$$

The potential  $V$  caused by the spatial profile of the energy bands results in formation of internal electric field

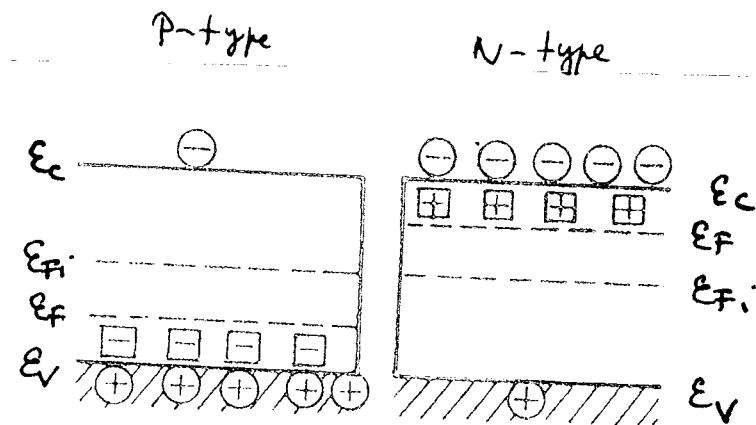
$$E^* = -\nabla_{\vec{r}} V = -\frac{kT}{e} \nabla_{\vec{r}} \Psi = -\frac{kT}{e} \nabla_{\vec{r}} \ln \bar{m} =$$

$$= -\frac{kT}{e} \cdot \frac{\nabla_{\vec{r}} \bar{m}}{\bar{m}} = \frac{kT}{e} \frac{\nabla_{\vec{r}} \bar{P}}{\bar{P}}$$

Therefore in any inhomogeneous semiconductor exists an internal electric field. There is no net electric current, because the drift current due to the E-field is compensated in equilibrium with diffusion current caused by the gradient of concentration of corresponding carriers (electrons or holes).

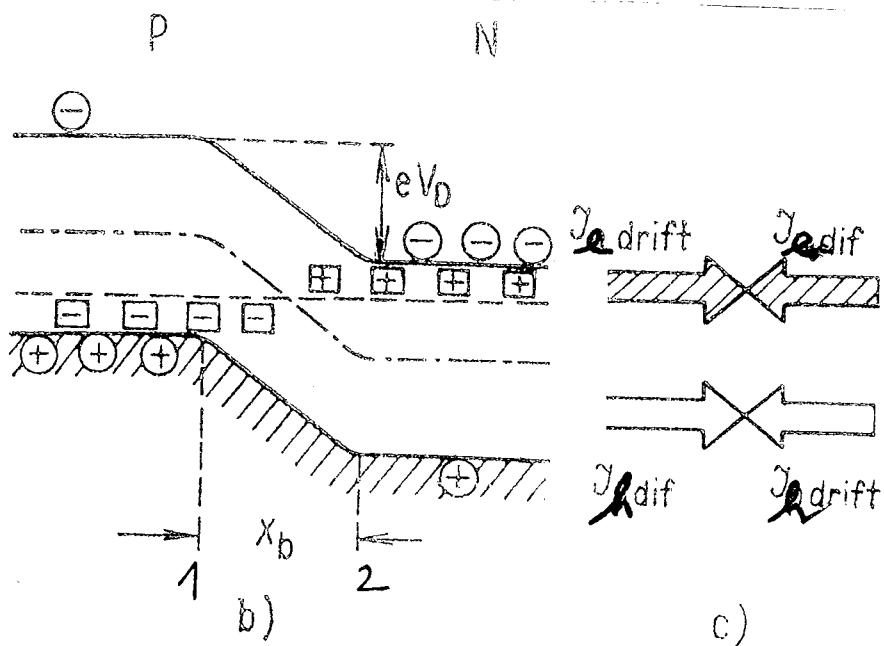
## P-N junction

The P-N junction is a transition region between two parts of the same semiconductor, part of which is doped by acceptors, part by donors.



## Semiconductor before P-N junction formation

The Fermi energy in P-type is lower than in N-type. After formation of P-N junction the Fermi energy must be everywhere the same.



## Semiconductor after formation of P-N junction.

$x_b$  ... width of the space charge region

During the formation of the P-N junction

- 1) Electrons from n-type diffuse to p-type due to the  $D_{n \rightarrow p}$
- 2) Holes from p-type diffuse to n-type due to  $D_{p \rightarrow n}$
- 3) As a result of diffusion of electrons from n-type, uncompensated positively charged donor atoms form a region of  $(+)$  charge in N-type. By the same mechanism, negative space charge of uncompensated acceptors is created in p-type
- 4) Space charge distribution results in creation of an internal electric field. This E-field opposes the diffusion currents
- 5) As a result of constant  $E_F$  throughout the material, an energy step  $eV_D$  is created in the energy diagram. Here  $V_D$  is the so called diffusion potential

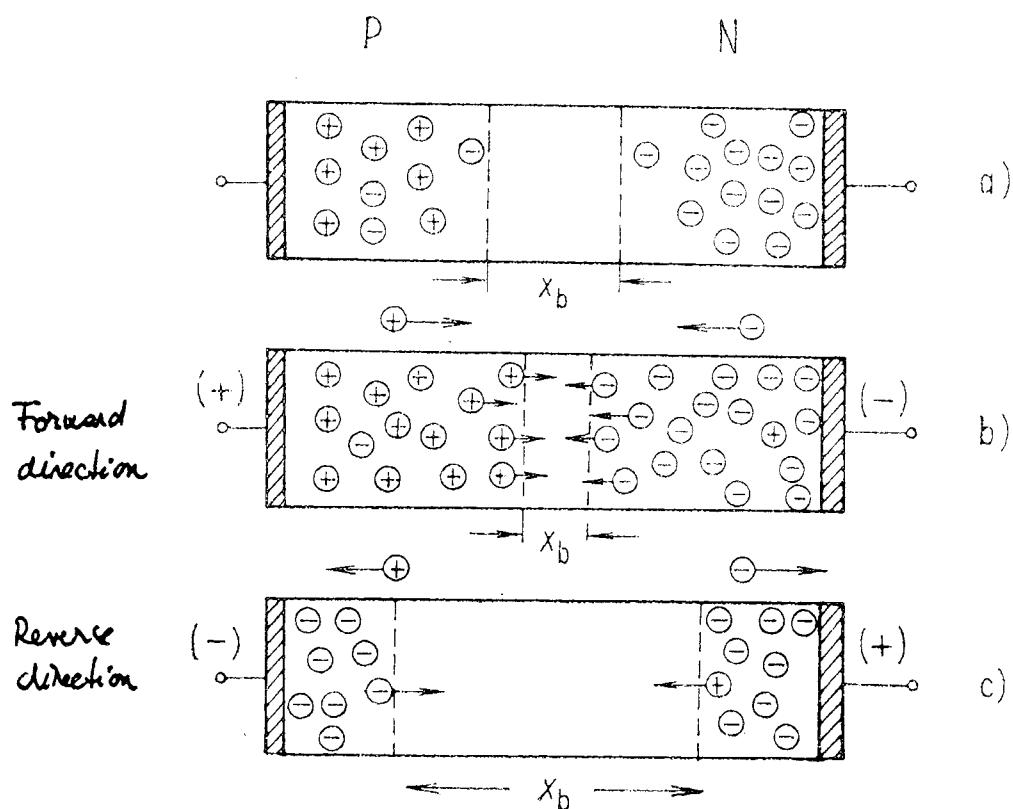
$$V_D = V_2 - V_1 = \frac{2T}{e} (\ln \bar{n}_2 - \ln \bar{n}_1) = \frac{2T}{e} \ln \frac{n_{n0}}{n_{p0}}$$

$n_{n0}$  = concentration of electrons in N-type in equilibrium (position 2)

$n_{p0}$  = concentration of electrons in P-type in equilibrium (position 1)

## P-N junction under bias

- 1) Forward direction (+) on P-type, (-) on N-type  
 Electrons from N-type are attracted to P-type. Holes from P-type are attracted to N-type. The space charge region is flooded by free carriers, the fixed charge of impurities is partially compensated, the width of the space charge region decreases. The injected minority carriers diffuse from the edge of the space charge region to the bulk. This diffusion results in the electric current, which is high.



The width of the space charge region without bias (a), in forward direction (b) and in reverse direction (c)

For the further calculation we set (1) at  $x=0$  and (2) at  $x=x_b$

The excess of minority holes  $\Delta P_2$  continues to move from (2) to the volume of the N-type by diffusion (there is <sup>nearly</sup> no electric field outside the space charge region, because the resistivity of this part is much higher than the resistivities of the neutral P and N-types and due to the Ohm law  $V = (R_p + R_{sc} + R_n)I \approx R_{sc}I$  ( $R_p I \ll R_{sc}I$ )). According to the orientation of the x-axis the diffusion of holes takes place in the (+x) direction.

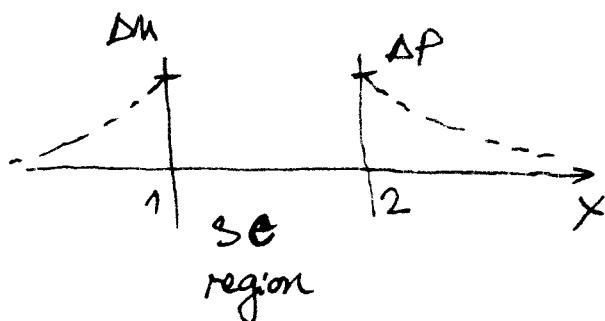
The excess of minority electrons  $\Delta n_1$ , diffuses to the P-type in (-x) direction.

From the example of return to equilibrium we were calculating, we know, that

$$\Delta P = \Delta P_2 e^{-\frac{(x-x_b)}{L_h}}$$

$$\Delta n = \Delta n_1 e^{\frac{x}{L_e}}$$

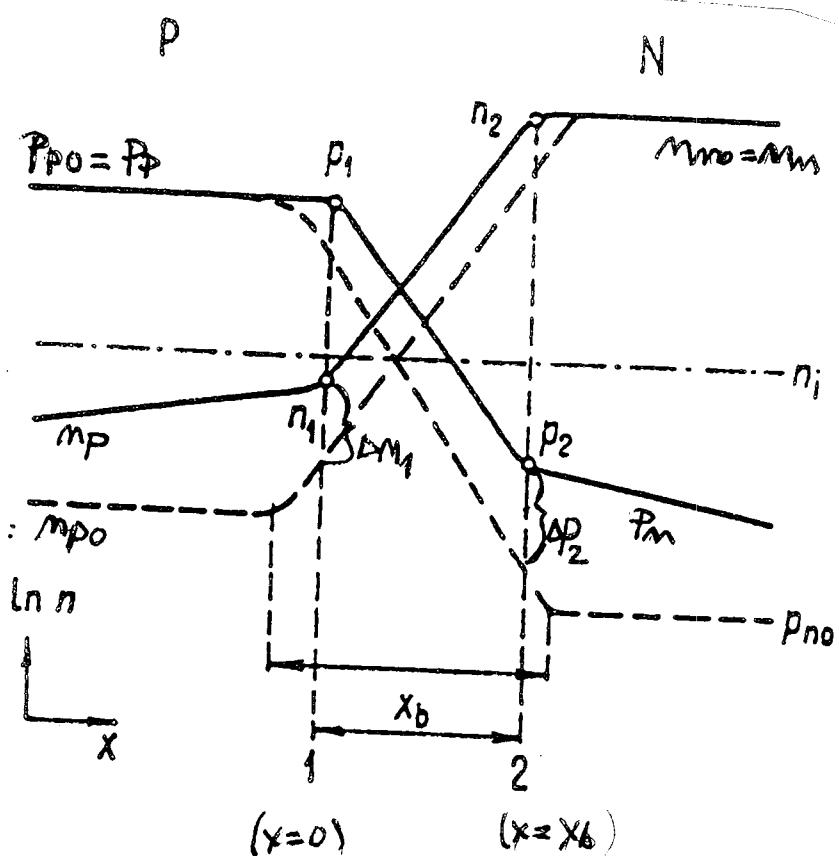
$L_e, L_h$   
diffusion lengths  
of electrons and  
holes



2) Reverse direction - (-) on P, (+) on N

The majority carriers are attracted from the edge of the space charge region to the contacts. The width of the space charge region increases compared to the situation without bias. Only minority carriers drift through the P-N junction (electrons from P-type are attracted by (+) on N and vice versa). The electric current in the reverse direction is composed of minority carriers and is small.

Calculation of the I-V characteristics



Here points (1) and (2) represent the edges of the space charge region under bias. In the picture we can see the forward direction.

We will calculate the contribution of excess carriers  $\Delta N_1, \Delta P_2$  to the electric current

$$j_e = e D_e \cdot \frac{d \Delta N}{dx} \quad j_h = -e D_h \cdot \frac{d \Delta P}{dx}$$

$\curvearrowleft$   
diffusion terms of the  
drift-diffusion equation

$$j_e = e \cdot \frac{D_e}{L_e} \cdot \Delta N \quad j_h = e \cdot \frac{D_h}{L_h} \cdot \Delta P$$

$$j = j_e + j_h$$

$$j = e \frac{D_e}{L_e} \cdot \Delta N_1 e^{\frac{x}{L_e}} \Big|_{x=0} + e \frac{D_h}{L_h} \cdot \Delta P_2 e^{-\frac{(x-x_b)}{L_h}} \Big|_{x=x_b}$$

$$j = e \frac{D_e}{L_e} \Delta N_1 + e \frac{D_h}{L_h} \cdot \Delta P_2$$

To calculate  $j$  we have to calculate  $\Delta N_1$  and  $\Delta P_2$  first

Equilibrium (no external voltage)

The diffusion potential

$$V_D = \frac{kT}{e} \ln \frac{N_{n0}}{N_{p0}} = -\frac{kT}{e} \ln \frac{P_{n0}}{P_{p0}} = \frac{kT}{e} \cdot \ln \frac{P_{p0}}{P_{n0}}$$

$$\Rightarrow \frac{P_{n0}}{P_{p0}} = e^{-\frac{eV_D}{kT}}$$

After application of external voltage  $V'$

$$V_D - V' = \frac{2T}{e} \ln \frac{P_1}{P_2} \quad (V' \text{ can be both positive and negative})$$

$$\frac{P_1}{P_2} = e^{\frac{e(V_D - V')}{kT}}$$

$$\frac{P_2}{P_1} = e^{-\frac{e(V_D - V')}{2T}} = \frac{P_{p0} + \Delta P_2}{P_{p0} + \Delta P_1}$$

$$e^{-\frac{V_D}{kT}} e^{\frac{eV'}{kT}} \approx \frac{P_{p0} + \Delta P_2}{P_{p0}} \quad \Delta P_1 \ll P_{p0}$$

$$\frac{P_{p0}}{P_{p0}} e^{\frac{eV'}{kT}} = \frac{P_{p0} + \Delta P_2}{P_{p0}}$$

$$P_{p0} + \Delta P_2 = P_{p0} e^{\frac{eV'}{kT}}$$

$$\Delta P_2 = P_{p0} \left( e^{\frac{eV'}{kT}} - 1 \right)$$

In a similar way we can derive

$$\Delta M_1 = M_{p0} \left( e^{\frac{eV'}{kT}} - 1 \right)$$

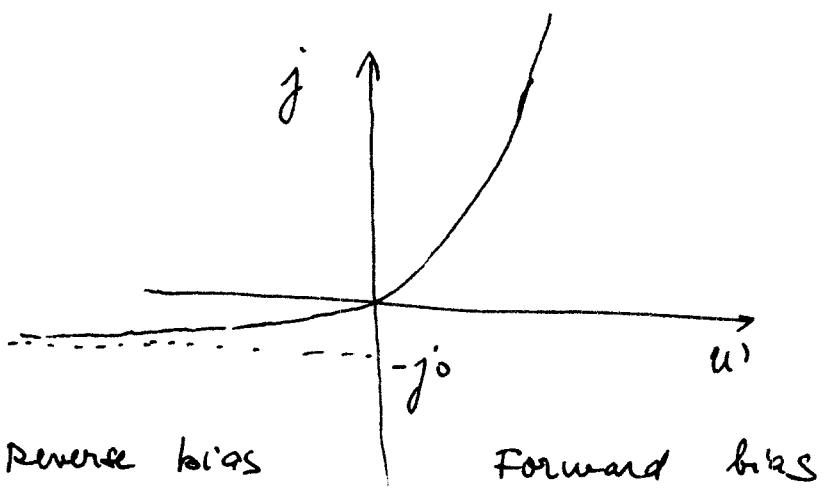
Then

$$j = \left[ e \frac{De}{Le} \cdot M_{p0} + e \frac{Dh}{Le} P_{p0} \right] \left( e^{\frac{eV'}{kT}} - 1 \right)$$

$$j = j_0 \left( e^{\frac{eV'}{kT}} - 1 \right)$$

For large  $V' < 0 \quad e^{\frac{eV'}{kT}} \rightarrow 0$

and  $j = -j_0$   
(reverse current)



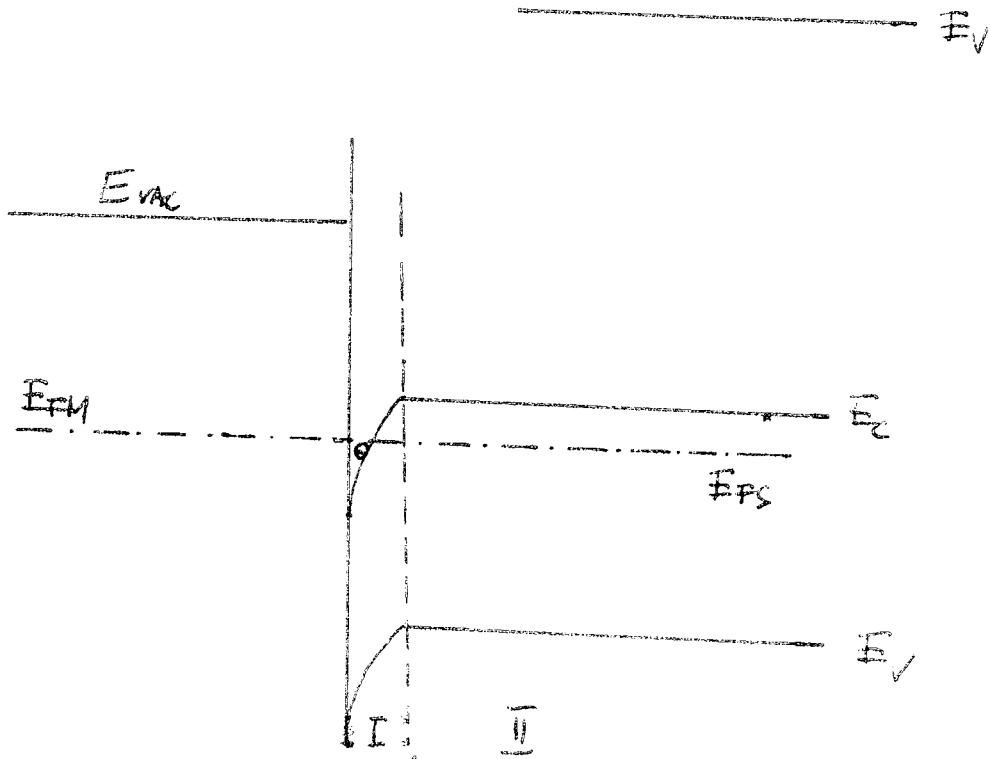
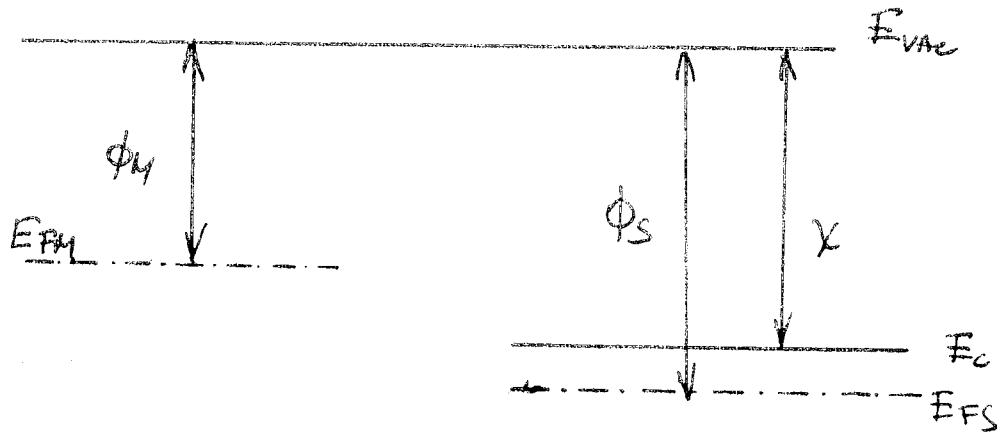
## Contact Metal - Semiconductor

Contact metal - semiconductor represents another example of inhomogeneous semiconductor structure. After depositing the metal it comes to charge transport between the metal and the semiconductor. As a result of this transfer the semiconductor becomes inhomogeneous. The charge transport and the properties of the M-S structure depend on difference between the work function of Metal and semiconductor and on the type (N or P) of the semiconductor. We will discuss all 4 possibilities and how the M-S structure behaves under bias.

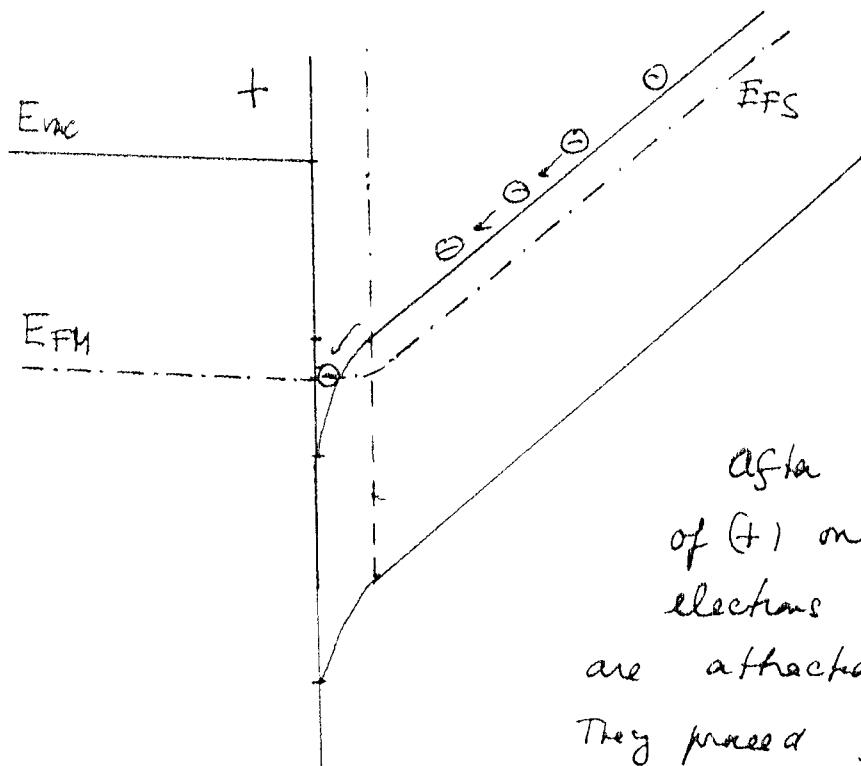
I. N type semiconductor, work function of metal is smaller than work function of the semiconductor ( $\phi_M < \phi_S$ )

Due to the fact, that  $\phi_M < \phi_S$ , the Fermi level in the metal is higher at the absolute energy scale, than the Fermi level in the SC ( $E_{FM} > E_{FS}$ ). After joining M and SC, electrons from M are transferred to SC. Because the SC is N-type (electrons are majority carriers), the new electrons from M form a highly conductive, enriched with electrons interface level.

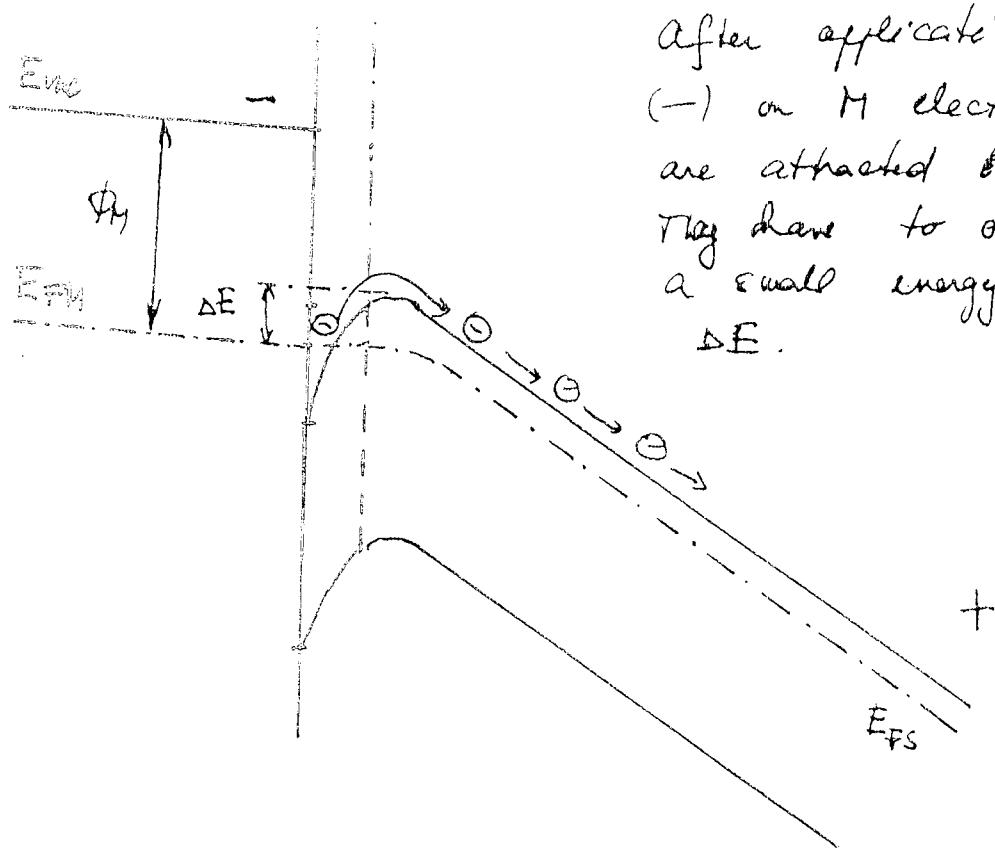
N-type semiconductor,  $\phi_H < \phi_S$



N-type,  $\phi_M < \phi_S$  under bias



After application  
of (+) on metal  
electrons from SC  
are attracted to M.  
They move freely, there  
is no energy barrier

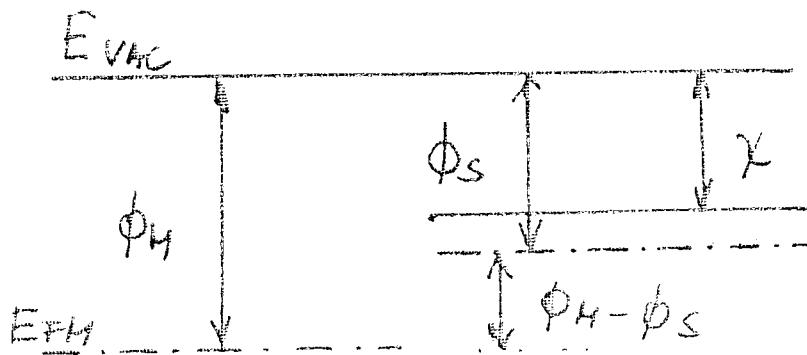


After application of  
(-) on M electrons  
are attracted to SC.  
They have to overcome  
a small energy barrier  
 $\Delta E$ .

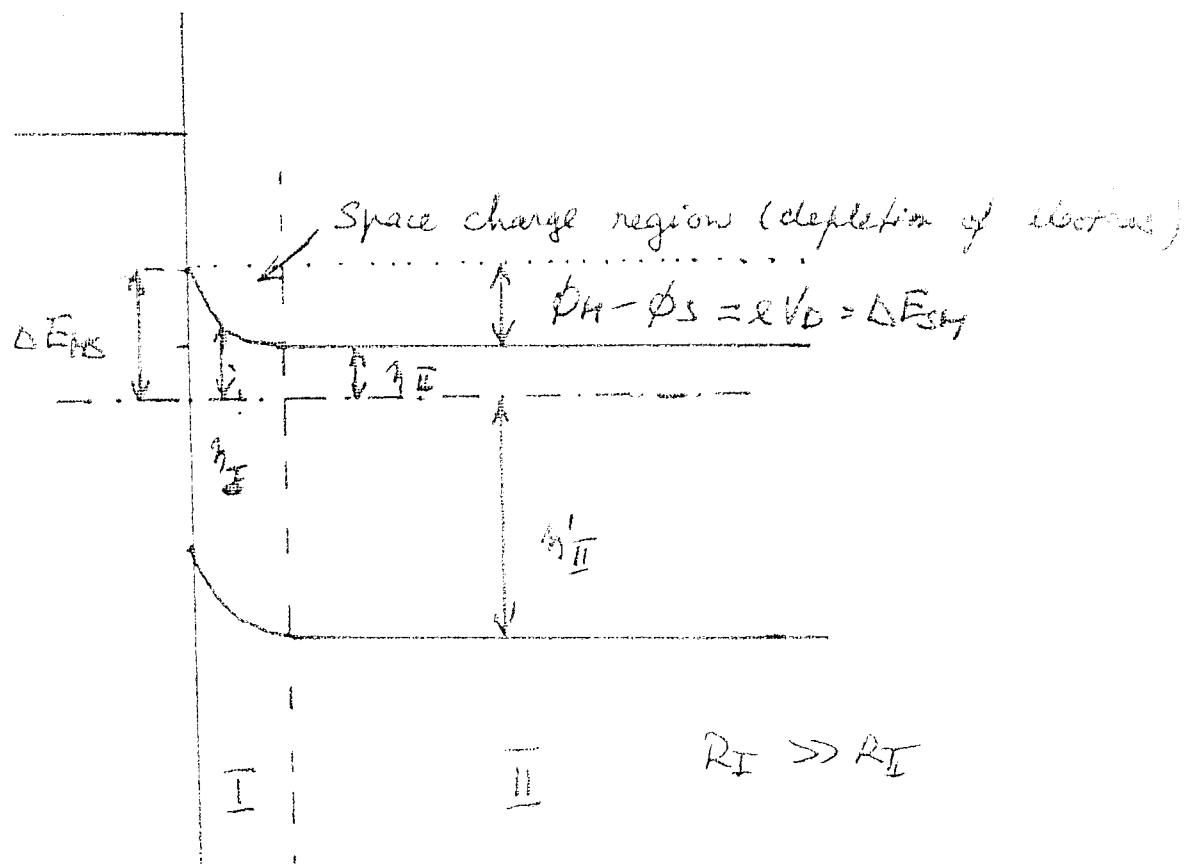
Due to the fact, that there is no or only very small energy barrier, N-type SC with a deposited metal ( $\phi_F < \phi_S$ ) has a linear or nearly linear I-V characteristics.

The metal / semiconductor interface behaves as an ohmic contact.

N-type semiconductor,  $\phi_H > \phi_S$



Band scheme before deposition of the metal



Band scheme after deposition of the metal.  
Space charge region of uncompensated ionized  
donors  $N_D^+$  is formed at the interface.

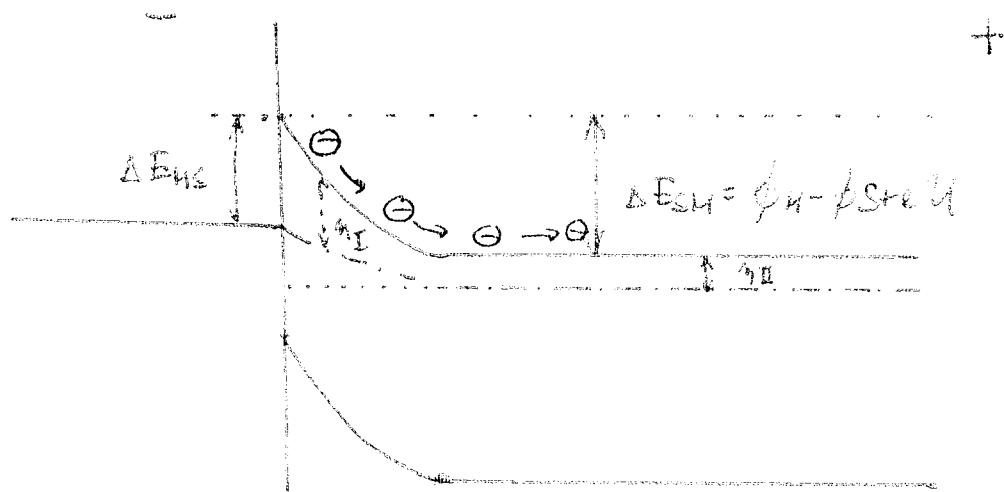
N-type SC,  $\phi_A > \phi_S$  under bias

The applied bias is almost completely concentrated on the space charge region ( $R_I \gg R_{II}$ )

$V = (R_I + R_{II})I \approx R_I I$ . The volume of the semiconductor is practically not influenced by the bias. Energy bands are nearly ~~most~~ tilted except of the SCR.

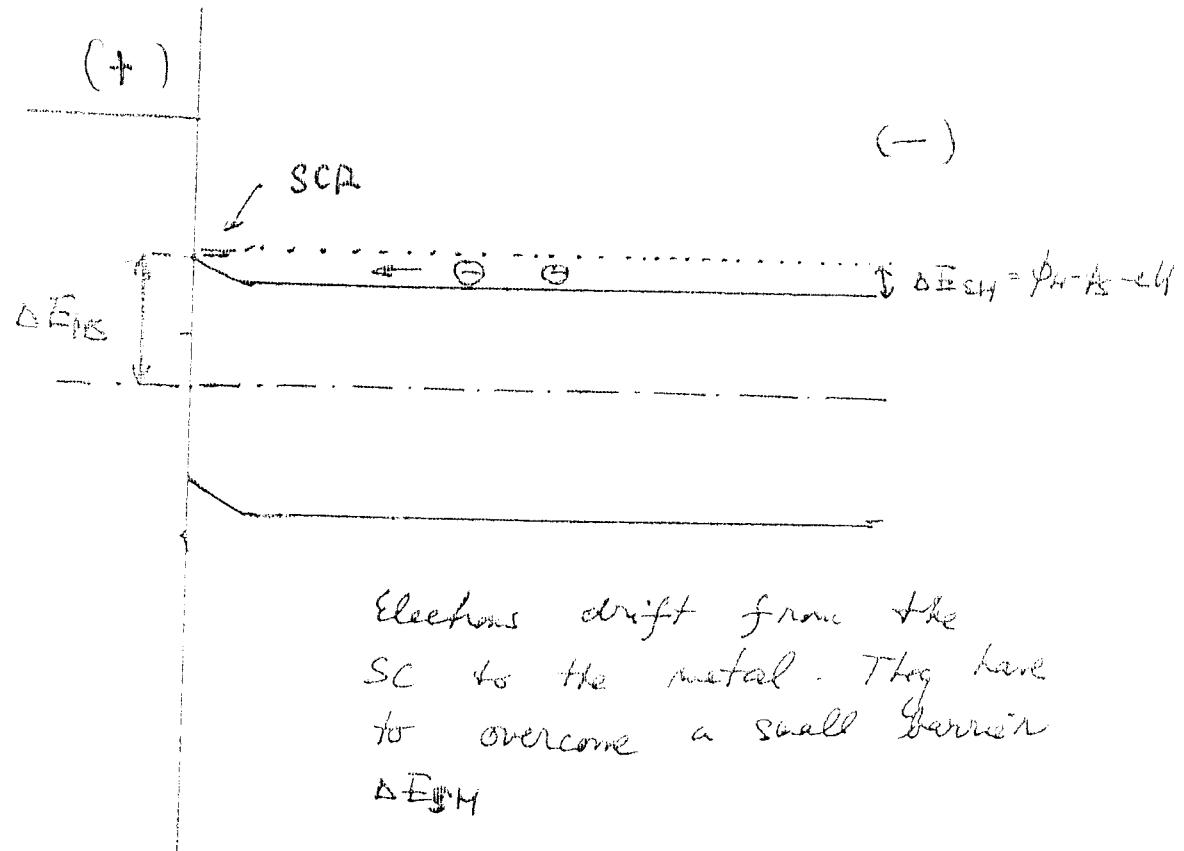
Application of (-) on H, (+) on S

Electrons are attracted to the (+), the width of the SCR increases. Electrons have to overcome the barrier  $\Delta E_{HS}$  before entering the SC.



The M-S contact is in the reverse direction

The width of the SCA decreases



The M-S contact is in the forward direction

The I-V characteristics is asymmetric, the M-S interface in this case behaves as a rectifying contact and is similar as in case of the P-N junction.

